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**AD2-I20-A049**

# **6mφ Radiometer Space Chamber**

## **Users' Manual**

**Advanced Engineering Services Co., Ltd.**

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## Table of Contents

1. Introduction .....	1
2. Brief Overview of this Facility .....	2
2.1. System Outline .....	2
2.2. Main Specifications .....	4
2.2.1. Monitor and Control System.....	5
2.2.2. Vacuum Vessel System .....	5
2.2.3. Vacuum Equipment System .....	10
2.2.4. Cryogenic System.....	10
2.2.5. Power supply System for IR Heaters .....	12
2.2.6. Vibration Isolation System.....	14
2.2.7. Data Acquisition System.....	20
2.2.8. Utility Equipment .....	21
2.2.9. Gadgets and Spares.....	23
3. User I/F.....	26
3.1. Configuration between Inside and Outside of Space Chamber .....	26
3.2. Measurement and Control Room.....	26
3.3. Device I/Fs.....	26
3.3.1. Vacuum Vessel .....	26
3.3.2. Cryogenic System.....	65
3.3.3. Power Supplies for Heat Sources.....	65
3.3.4. Control Mode.....	67
3.3.5. Limit Function .....	71
3.3.6. Vibration Control System .....	77
3.3.7. Data Acquisition System.....	78
3.3.8. Utility Facilities .....	84
3.4. Facility Belongings.....	88
3.5. Building I/F.....	89
4. Execution of Tests.....	101
4.1. Test-related Work Procedure.....	101
4.2. Test Procedure .....	102
4.2.1. General Description of Test .....	102
4.2.2. Standard Chamber Vacuum Curve, etc. ....	104
4.3. Power Failure Protective Measures .....	105
4.4. Other Remarks .....	108
4.5. Documents to be Submitted at K/O Meeting.....	114
Appendix A Correspondence Table of Channels between Terminal Boards inside Vessel and Data Loggers.....	A-0

## List of Figures

Figure 2-1 External View of 6 m $\phi$ Radiometer Space Chamber .....	2
Figure 2-2 System Diagram and Tree Diagram of 6m $\phi$ Radiometer Space Chamber Facility.....	3
Figure 2-3 Diagram of Monitor and Control System.....	5
Figure 2-4 External View of TS Installation Device.....	8
Figure 2-5 Supporting Bench with Cooling Panel .....	11
Figure 2-6 Supporting Bench.....	11
Figure 2-7 External View of Power Supplies for Heat Sources.....	13
Figure 2-8 System Diagram of Vibration Isolation System.....	15
Figure 2-9 Optical Bench.....	16
Figure 2-10 Seismic Slab.....	17
Figure 2-11 System Diagram of Vibration Analyzer .....	19
Figure 2-12 System Diagram of Data Acquisition System.....	20
Figure 2-13 Clean Booth .....	22
Figure 2-14 Calorimeter .....	24
Figure 2-15 WBD Example of Calorimeter to Power Supply for Heat Sources.....	25
Figure 3-1 System Diagram for Operation in Preparation Room .....	27
Figure 3-2 Configuration of Devices in Measurement and Control Room.....	28
Figure 3-3 Configuration of Feed-through Terminal Nozzles .....	29
Figure 3-4 WBD Diagram of Feed-through Terminal .....	34
Figure 3-5 WBD Diagram of Signal Lines for TS .....	35
Figure 3-6 WBD Diagram of EP Lines for TS .....	36
Figure 3-7 WBD Diagram of Thermocouples/Calorimeters for TS, and Thermocouple Spare Lines.....	37
Figure 3-8 WBD Diagram of Temperature Sensors for TS .....	38
Figure 3-9 WBD Diagram of SBG Temperature Measurement.....	39
Figure 3-10 WBD Diagram of 2 kW IR Power Supply Rack.....	40
Figure 3-11 WBD Diagram of 60W IR Power Supply Rack.....	41
Figure 3-12 Feed-through Terminal for Coaxial Cables of TS .....	42
Figure 3-13 Inner-vessel Permanent Terminal Boards – I, II, III.....	43
Figure 3-14 External Input Terminal Boards – I, II .....	44
Figure 3-15 Thermocouple Socket Contact (manufactured by Hitachi Power Semiconductor Device, Ltd.) .....	45
Figure 3-16 Configuration of Hard Ports.....	47
Figure 3-17 Load Capacity of Supporting Benches with and without Cooling Panel .....	48
Figure 3-18 Load Capacity of Body Shroud Hard Port .....	48
Figure 3-19 Schematic View of Hard Port for Optical Bench Maintenance.....	49
Figure 3-20 System Diagram of Ports for TS .....	53
Figure 3-21 Diagram of Grayloc Connector for LN <sub>2</sub> .....	54
Figure 3-22 Diagram of Supply Port Flange for GN <sub>2</sub> .....	55
Figure 3-23 Procedure of TS Installation .....	57
Figure 3-24 Diagram of Optical Window Mounting Flange.....	58

Figure 3-25 Optical Window .....	59
Figure 3-26 Mounting Positions of Optical Windows .....	60
Figure 3-27 Work Floors inside Vacuum Vessel .....	62
Figure 3-28 Movable Operation Bench .....	63
Figure 3-29 Working Platform.....	64
Figure 3-30 Diagram of SBG Support.....	65
Figure 3-31 Grayloc Connector for SBG-cooling He.....	65
Figure 3-32 Work Floor Rails (when mounting SBG).....	65
Figure 3-33 System Diagram of Holistic System .....	65
Figure 3-34 System Diagram of Power Supply Racks for IR Heaters.....	66
Figure 3-35 Connection of RTDs .....	80
Figure 3-36 Wire Breakage Detection Circuit .....	81
Figure 3-37 Outline Flow of Clean Booth Operation .....	85
Figure 3-38 Height inside Clean Booth .....	86
Figure 3-39 Configuration of Clean Booth Ducts.....	87
Figure 3-40 Mounting Bench (Large).....	91
Figure 3-41 Configuration of Distribution Boards/Plug Socket Boards .....	92
Figure 3-42 WBD Diagram of Distribution Boards .....	93
Figure 3-43 Specifications of Socket at Lower Part of Distribution Board and Plug Socket Board (A).....	94
Figure 3-44 Circuit Diagram of Branch Power Board for Users .....	97
Figure 3-45 Movable Range of Crane in Each Room.....	98
Figure 3-46 Diagram of Installation Sites for NVR Plates .....	99
Figure 4-1 Test-related Work Flow .....	101
Figure 4-2 Vacuum Curve in Standard Chamber, etc. ....	104
Figure 4-3 Standard Flow in Momentary Power Interruption and Power Failure .....	107
Figure 4-4 Inner-Chamber Pressure Transition during 20-minute Power Failure .....	108
Figure 4-5 Emergency Stop Switch inside Chamber.....	111
Figure 4-6 Locations of Emergency Stop Switches in Preparation Room and Measurement & Control Room ..	112
Figure 4-7 Location of Emergency Stop Switch on Emergency Stop Console Panel in Measurement & Control Room .....	112
Figure 4-8 Position of Emergency Stop Switch on Preparation Room Access Door Console Panel.....	113

### List of Tables

Table 2-1 Main Performance and Facility Specifications of 6 m $\phi$ Radiometer Space Chamber.....	4
Table 2-2 Basic Specifications of Moving Dolly.....	6
Table 2-3 Basic Specifications of TS Installation Dolly .....	7
Table 2-4 Basic Specifications of Supporting Bench with Cooling Panel.....	9
Table 2-5 Basic Specifications of Supporting Bench .....	9
Table 2-6 Basic Specifications of Power Supplies for Heat Sources.....	12
Table 2-7 Basic Specifications of Optical Bench .....	14
Table 2-8 Basic Specifications of Vibration Analyzer .....	18
Table 2-9 Basic Specifications of Data Acquisition System.....	20
Table 2-10 Basic Specifications of Clean Booth .....	21
Table 3-1 Table of Flanges (1/2).....	30
Table 3-1 Table of Flanges (2/2).....	31
Table 3-2 Table of Feed-through Terminals for Current/Thermocouples (1/2) (Simplified).....	33
Table 3-2 Table of Feed-through Terminals for Current/Thermocouples (2/2) (Detailed) .....	33
Table 3-3 Table of Hard Ports.....	46
Table 3-4 Load Capacities of Hard Ports.....	46
Table 3-5 Load Capacity of Body Shroud Hard Ports .....	48
Table 3-6 Load Capacity of Hard Ports on Optical Bench .....	49
Table 3-7 List of TS LN <sub>2</sub> Lines .....	50
Table 3-8 General Description of TS Cooling/Heating I/F.....	51
Table 3-9 Rough Levels of LN <sub>2</sub> Feed Rate and Valve Opening Percentage.....	51
Table 3-10 Basic Specifications of SBG I/F.....	65
Table 3-11 Composition of Primary Components in Power Supplies for Heat Sources.....	65
Table 3-12 Control System of Power Supply Rack .....	67
Table 3-13 Control Methods and Descriptions of PID Control (1/2).....	68
Table 3-13 Control Methods and Descriptions of PID Control (2/2).....	69
Table 3-14 Table of Limit Functions (1/3).....	72
Table 3-14 Table of Limit Functions (2/3).....	73
Table 3-14 Table of Limit Functions (3/3).....	74
Table 3-15 Contents of Alert for Each Detection Item (1/2).....	75
Table 3-15 Contents of Alert for Each Detection Item (2/2).....	76
Table 3-16 Correspondence between Acquisition Data and Channel Numbers.....	79
Table 3-17 Recommended Usage Instructions for Wire Breakage Detection Function (1/2).....	82
Table 3-17 Recommended Usage Instructions for Wire Breakage Detection Function (2/2).....	83
Table 3-18 List of Facility Belongings .....	88
Table 3-19 Basic Descriptions of Hand-pallet Truck.....	89
Table 3-20 List of Distribution Boards for Users .....	90
Table 3-21 Specification of Cranes.....	95
Table 3-22 Specification of UPS .....	96

Table 4-1 Test Methods Corresponding to Test Purposes .....	103
Table 4-2 Summary of Kinds of Tests and Environmental Conditions.....	103
Table 4-3 Requirements for Facility .....	115
Table 4-4 List of Nonmetallic Articles Brought into Space Chamber .....	116

## **Appendix A**

Table A-1 Correspondence Table of Channels between Terminal Boards inside Vessel and Data Loggers (1/5)	1
Table A-1 Correspondence Table of Channels between Terminal Boards inside Vessel and Data Loggers (2/5)	2
Table A-1 Correspondence Table of Channels between Terminal Boards inside Vessel and Data Loggers (3/5)	3
Table A-1 Correspondence Table of Channels between Terminal Boards inside Vessel and Data Loggers (4/5)	4
Table A-1 Correspondence Table of Channels between Terminal Boards inside Vessel and Data Loggers (5/5)	5

## 1. Introduction

This users' manual is to provide necessary information to the users of 6mφ Radiometer Space Chamber (referred to as “this facility” hereafter) located in the 6mφ Radiometer Space Chamber Building.

This facility is used for optic tests on different kinds of earth observation radiometers to be mounted on satellites, or thermal vacuum tests on mid/small-size satellites and satellite components, in simulated space environments on ground.

This facility can reduce the transmission of micro tremors from the ground or the vibration from vacuum pumps, etc. to a test specimen (■ abbreviated as TS hereafter) to the maximum degree, by adopting an isolated base, so that high-precision optical instruments, etc., can be the subject for a test. Furthermore, this facility achieves space with high cleanliness, with its design to satisfy the cleanliness requirements for optical instruments while dealing with both particulate and molecular contamination.

The major environments in outer space are high vacuum, cryogenic shade, etc. On the geostationary orbit which is about 36,000 km above the surface of the earth, those environments respectively reach the levels of about  $1.3 \times 10^{-11}$ Pa and 3K, the latter being an infinite heat absorber.

However, it is financially unfeasible to simulate such environments on ground as they are, and therefore this facility provides vacuum pressure of  $1.3 \times 10^{-4}$ Pa or less and shroud temperature of 100K or lower. In order to meet the request of temperature planes to be 100K or lower, meanwhile, this facility is equipped with hard ports to mount a space background panel, as well as a He refrigerator and a He supply flange which cool down the panel plane to 20K.

We can verify the reliability of satellite behaviors in space by extrapolating them from the accuracy assessment on thermal designs under the simulated environments mentioned above.



## 2. Brief Overview of this Facility

### 2.1. System Outline

The external view and system diagram of this facility are shown in Figures 2-1 and 2-2, respectively.

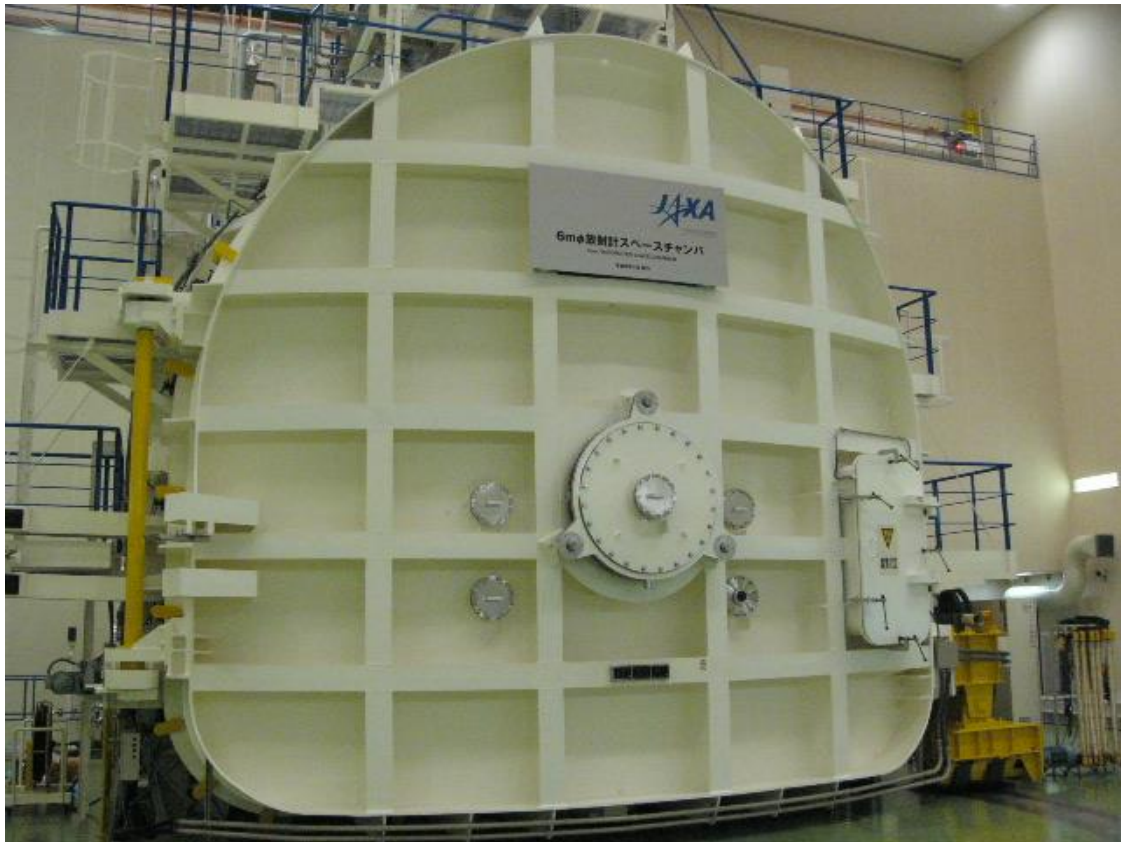


Figure 2-1 External View of 6 mφ Radiometer Space Chamber

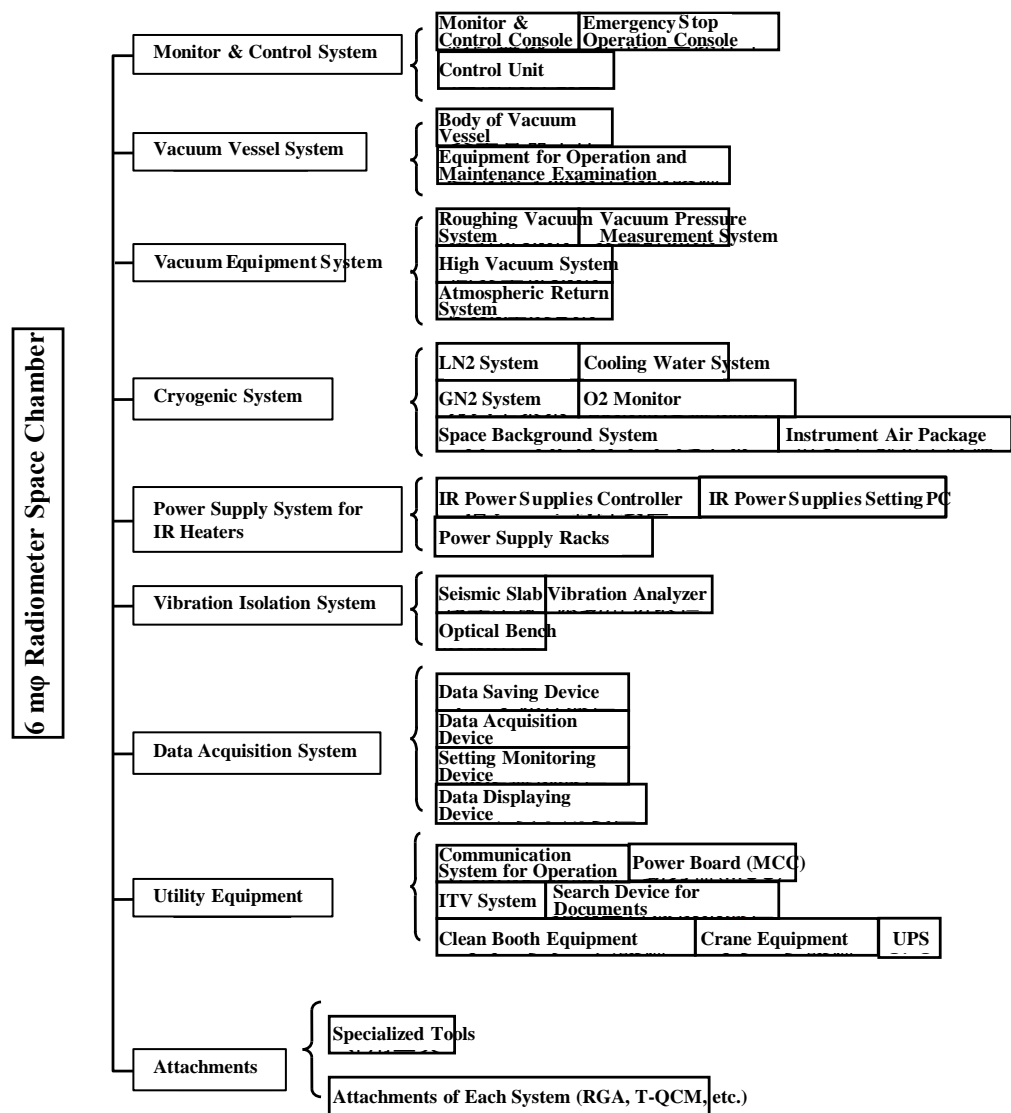
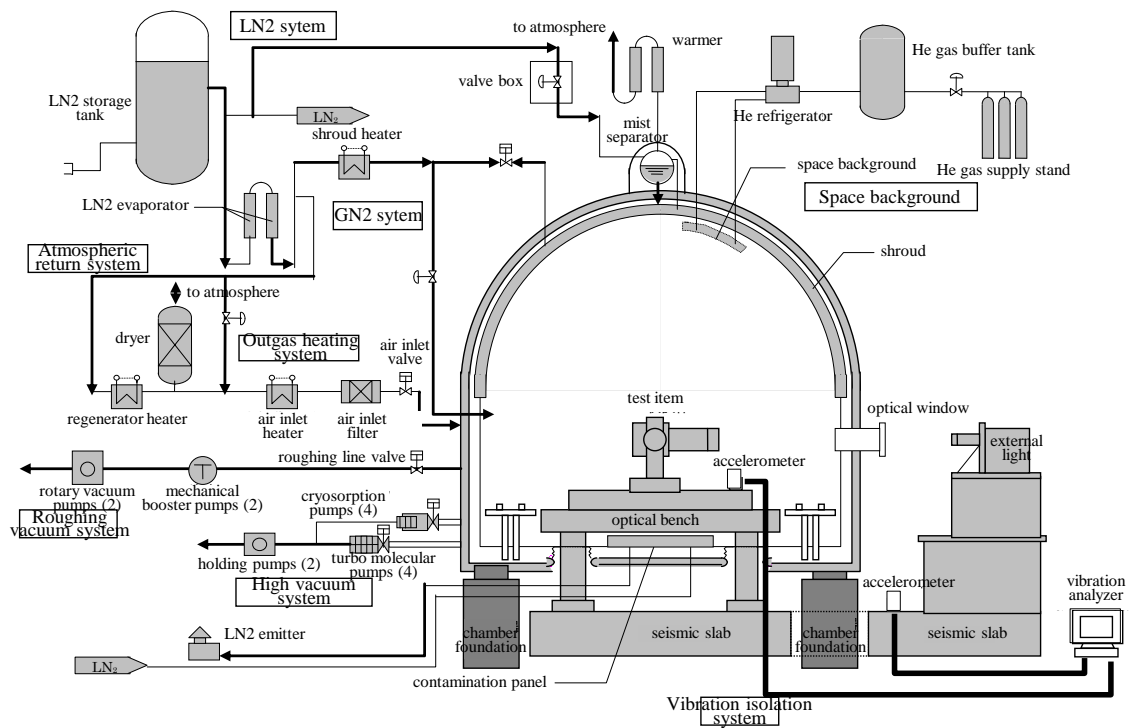


Figure 2-2 System Diagram and Tree Diagram of 6mφ Radiometer Space Chamber Facility

## 2.2. Main Specifications

The main specifications of the whole facility are shown in Table 2-1.

**Table 2-1 Main Performance and Facility Specifications of 6 mφ Radiometer Space Chamber**

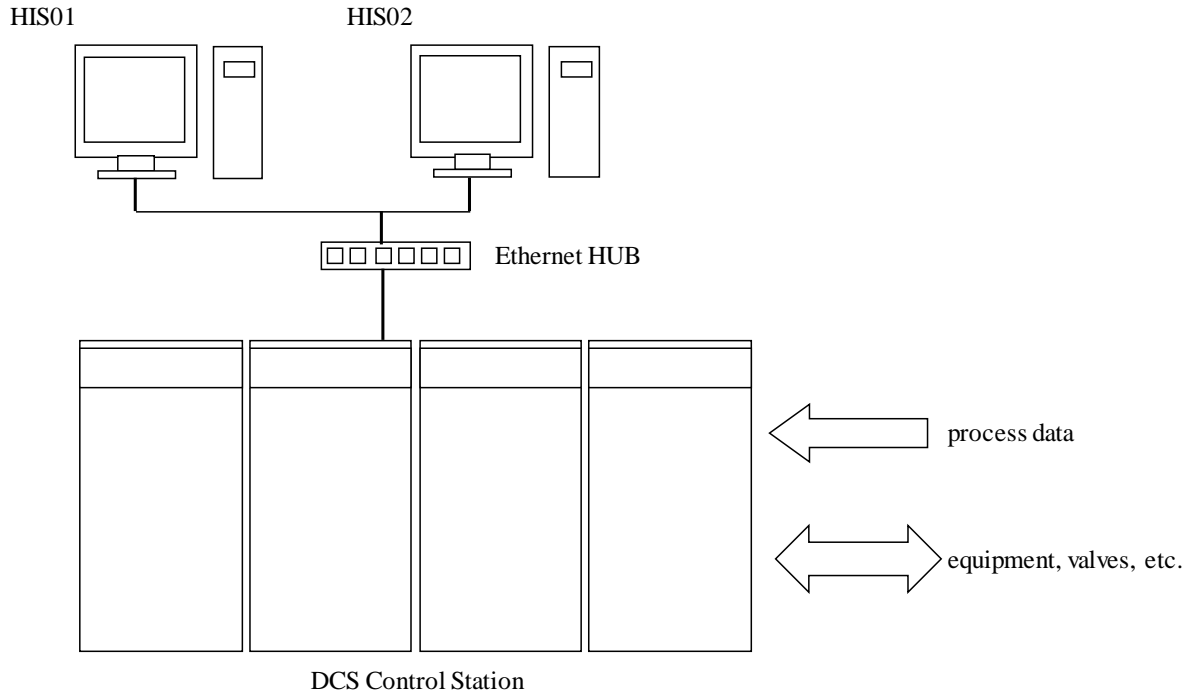
item	performance/specifications	notes
(1) space chamber	mailbox type	
(a) usable dimensions	6m (dia) × 8m (L)	dimensions inside shroud
(b) access door of chamber	6m (W) × 5.1m (H)	incl. dolly
(c) shroud temperature	100K or lower, or ambient temperature ~ 60°C	
(d) Max. weight carryable in chamber	4,000 kg	incl. jig
(e) vacuum pressure		
① operational vacuum pressure	1.33×10 <sup>-4</sup> Pa or less (1×10 <sup>-6</sup> Torr or less)	
② ultimate vacuum pressure	1.33×10 <sup>-5</sup> Pa or less (1×10 <sup>-7</sup> Torr or less)	*1
(f) pumpdown / repressurizing time	8 hours or less	
(g) Max. consecutive operation days	45 days	for 1-min. sampling cycle
(h) black space	95% or more	when using supporting bench with cooling panel
(i) space background temperature	20K or lower	
(2) power supply for IR heaters		
(a) power supplies for heat sources	4 racks	6mφ 60W power supply rack-1: 25 6mφ 2 kW power supply rack-1: 10 6mφ 2 kW power supply rack-2: 10 <sup>*2</sup> 6mφ 3 kW power supply rack-1: 10
(3) vibration isolation system		
(a) optical bench dimensions	4m × 6m × 0.5m (D)	permanently equipped in chamber
(b) optical bench eigenvalue	30Hz or higher	
(c) relative displacement vibration	1.0 μm 0-P or less	bet. bench in chamber and slab outside
(d) relative angle vibration	0.3 μrad P-P or less	bet. bench in chamber and slab outside

\*1 w/o TS, TS supporting bench, or IR radiation; shroud being cooled with LN<sub>2</sub>, within 8 hours after the start of pumpdown.

\*2 2 kW power supply rack-2 and power supplies-3, 4 are not available.

### 2.2.1. Monitor and Control System

This system enables intensive monitoring of the operational status in the space chamber via Human I/F Stations (HIS) based on the process data of the vacuum equipment system, cryogenic system, etc., collected in the DCS control station (Figure 2-3.)



**Figure 2-3 Diagram of Monitor and Control System**

### 2.2.2. Vacuum Vessel System

This system consists of a vacuum vessel and equipment for operation and maintenance. The brief explanation of the system is provided as follows.

#### (1) Vacuum vessel

This cylindrical stainless-steel vessel is shaped like a mailbox, and has a storage space of 6-meter diameter  $\times$  8-meter long (inside shroud.)

The mailbox-like shape of the vacuum vessel achieves a spacious working area and easy access to a TS.

The vacuum pressure inside the vessel is measured by the Pirani gauge and ionization gauge mounted on the vessel. Their measurement ranges cover successive measurement from the atmospheric pressure to the ultimate vacuum pressure range, and the data is displayed on the control and monitor console in the measurement and control room. They are also capable of continued measurement during power failure, with the help of an uninterruptible power supply system.

The vacuum vessel has optical windows to be used for radiometer optical confirmation tests on both sides of the vacuum vessel body part and the access door for a TS. There also are windows for alignment measurement on side and top of the body part, and on the access door.

The alignment measurement windows have mounting seats for the ITV facility (cf. section 2.2.8) to monitor the inside of the vacuum vessel.

## (2) TS installation device

The TS installation device is made up of a moving dolly, a TS installation dolly, and a supporting bench with a cooling panel (or a supporting bench w/o a cooling panel.) The moving dolly and the TS installation dolly can be moved with human power, owing to the air bearings attached to them which slightly lift them up. Each of the dollies is briefly explained below. As for how to operate the TS installation device, refer to 3.3.1.6. Its external view is shown in Figure 2-4.

## (a) Moving dolly

The moving dolly can freely move in the preparation room with the TS installation dolly, the TS supporting bench, and a TS mounted upon it. It also has a bridge board for moving the TS installation dolly onto the optical bench in the vacuum vessel. Its brief specifications are shown below.

**Table 2-2 Basic Specifications of Moving Dolly**

item	specification
dimensions	5m (width) × 7.25m (length) × 0.85m (height) (from floor surface)
load capacity	Max. 12,400 kg (incl. TS and jig = 4,000 kg)
own weight	7,700 kg
drive system	pushed by hands
movable range	unpacking room, preparation room
length of air-supplying hose	30m
movable load (Max. pulling force)	Max. 52 kg
air consumption	2.0 Nm <sup>3</sup> / min
air pressure	0.39 MPa or more

## (b) TS installation dolly

The TS installation dolly is used for mounting and dismounting the supporting bench with a cooling panel or the supporting bench without a cooling panel from/onto the moving dolly onto/from the optical bench in the vacuum vessel. The basic specifications of the TS installation dolly are shown below.

**Table 2-3 Basic Specifications of TS Installation Dolly**

item	specification
dimensions	3.19m (width) × 5.16m (length) × 0.145m (height) (to the upper end of the jack)
load capacity	6,800 kg (incl. TS and jig = 4,000 kg)
own weight	2,100 kg
drive system	pushed by hands
movable range	moving dolly ~ on the optical bench inside the vacuum vessel
length of air-supplying hose	10m
air consumption	2.0 Nm <sup>3</sup> / min
air pressure	0.39 MPa or more

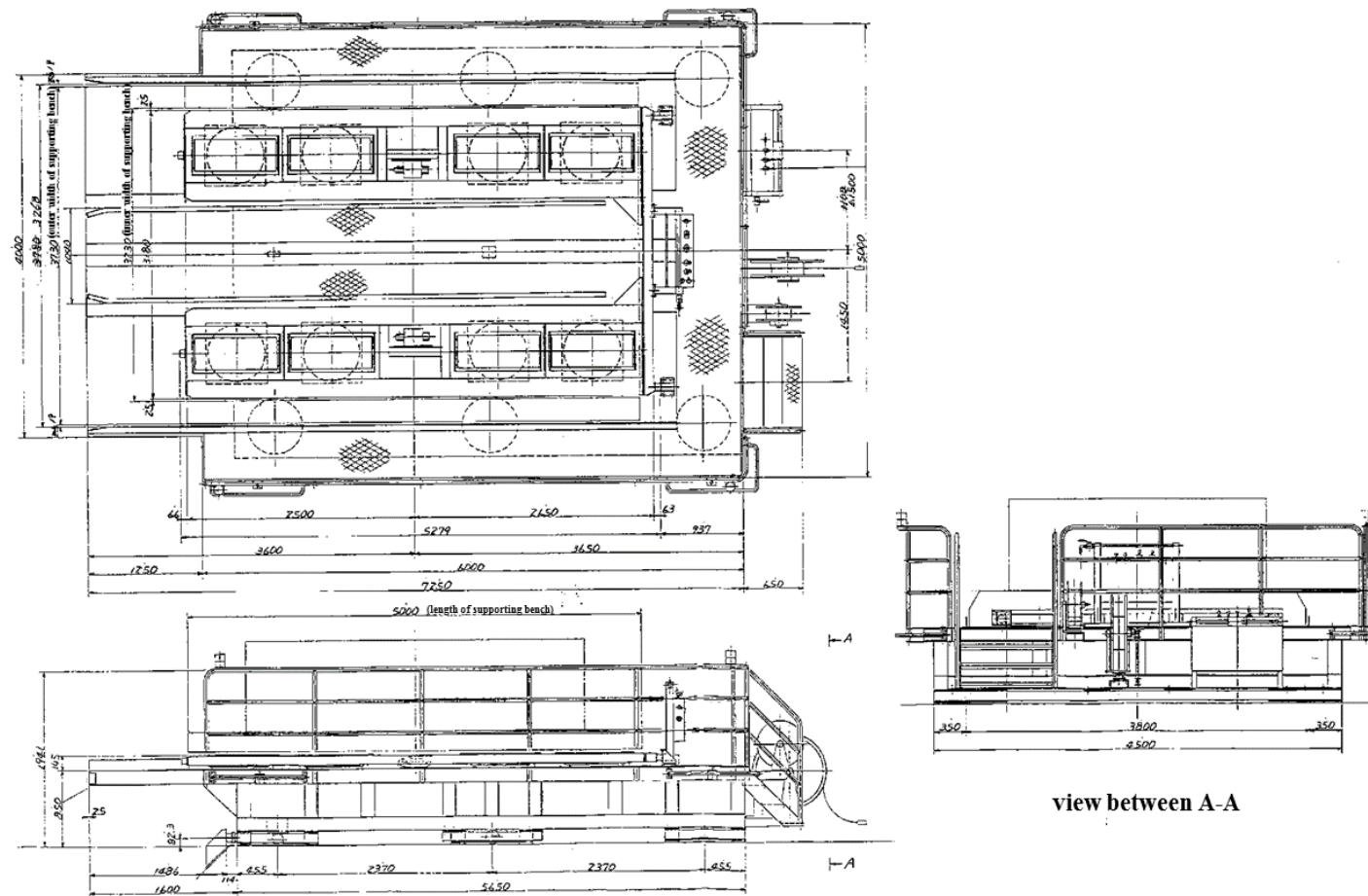


Figure 2-4 External View of TS Installation Device

## (c) TS supporting bench

Those supporting benches are used to mount a TS to place it inside the vacuum vessel. That is, a TS is carried into the vessel by a TS installation device to be placed on the optical bench, while mounted on a supporting bench all the way through. TS supporting benches can be mainly classified into two kinds; one is a supporting bench with a cooling panel used for thermal vacuum tests, and the other is a supporting bench (for optic tests) used for optical performance confirmation tests. The basic specifications of the former are shown in Table 2-4 and Figure 2-5, while those of the latter are shown in Table 2-5 and Figure 2-6. As can be seen from Tables 2-4 and 2-5, their load capacities withstand a TS (including a jig) weighing up to 4.0t. Information on the I/F, e. g., the diameters of the screw holes of hard ports, etc., is provided in section 3.3.1.3.

**Table 2-4 Basic Specifications of Supporting Bench with Cooling Panel**

item	specification
dimension	5m (width) × 3.5m (depth)
Max. load mass	4,000 kg
mass of body	about 2,800 kg
material	aluminum alloy
surface temperature	100K or lower  (two out of the LN <sub>2</sub> lines for cooling parts of a TS are used)

**Table 2-5 Basic Specifications of Supporting Bench**

item	specification
dimension	5m (width) × 3.5m (depth)
Max. load mass	4,000 kg
mass of body	about 2,200 kg
material	alluminum alloy



### **2.2.3. Vacuum Equipment System**

This system consists of low and high vacuum systems which vacuum the vacuum vessel from the atmospheric pressure to the high vacuum, and an atmospheric return system which raises the pressure inside the vacuum vessel from the vacuum state to the atmospheric pressure condition with GN<sub>2</sub> and dry air.

The standard vacuum curve (without a TS) during a thermal vacuum test is shown in Figure 4-2.

### **2.2.4. Cryogenic System**

This system consists of an aluminum-alloyed fin-tube type shroud that is cooled down to 100K or lower by means of LN<sub>2</sub> to establish cryogenic environment, and SBG (space background) cooling lines in the vacuum vessel that are cooled down to 20K or lower by He gas to simulate deep space for radiation cooling. The SBG itself is to be prepared by users. Refer to section 3.3.2.1 for the I/F to the facility. The SBG cooling lines are currently in a dormant state, being not ready for use. Users are to contact the Environmental Test Technology Unit if they want to use SBG cooling lines.

Note) It takes 12 months or longer to get them ready for use.

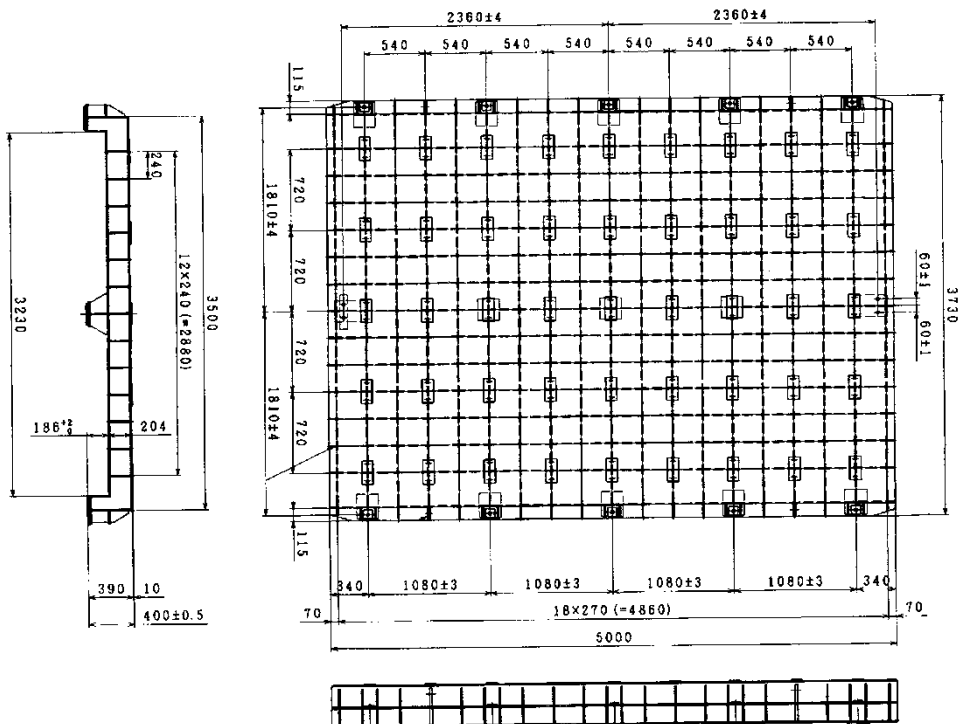
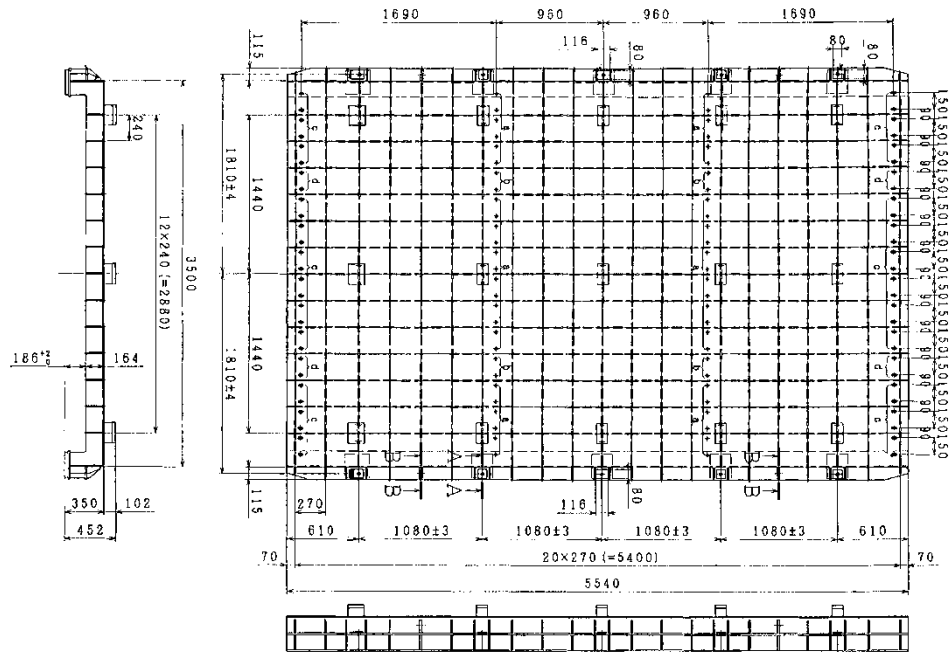


Figure 2-5 Supporting Bench with Cooling Panel

Figure 2-6 Supporting Bench

### 2.2.5. Power supply System for IR Heaters

These devices are used for IR radiation thermal balance/thermal vacuum tests performed in 6m $\phi$  radiometer space chamber, to supply specified EP to IR lamps as the IR light source or heaters which provide external thermal input to a satellite, or to simulation heaters for the heat from the equipment mounted on a satellite.

The test data collected by those devices are transmitted to the data acquisition system in 6m $\phi$  radiometer space chamber and recorded thereat.

**Table 2-6 Basic Specifications of Power Supplies for Heat Sources**

item	specification			
name	6m $\phi$ 60W power supply rack -1	6m $\phi$ 2 kW power supply rack -1	6m $\phi$ 2 kW power supply rack -2	6m $\phi$ 3 kW power supply rack -1
qty	25	10	10	10
output voltage	DC60V	DC100V	DC100V	DC100V
output current	1A	20A	20A	30A
output EP	60W	2 kW	2 kW	3 kW
control method	remote control (temperature / constant power / manual voltage output control) / local control			
notes	2 kW power supply rack -2 and power supplies No. 3, 4 are not available.			

6mφ 3 kW power  
supply rack -1

6mφ 2 kW power  
supply rack -1

6mφ 2 kW power  
supply rack -2

6mφ 60W power  
supply rack -1



**Figure 2-7 External View of Power Supplies for Heat Sources**

### 2.2.6. Vibration Isolation System

This system, which is made up of an optical bench, a seismic slab, and a vibration analyzer, is established to avoid the bad influence of vibration that is propagated from outside during a radiometer optical confirmation test performed in the space chamber. The schematic view and basic specifications of this system are shown in Figure 2-8 and below, respectively.

#### (1) Optical bench (Figure 2-9)

This bench is permanently equipped in the vacuum vessel, and used with a TS supporting bench, on which a TS is mounted, fixed onto the bench. Its main posts are directly connected to the seismic slab via bellows, penetrating through the vacuum vessel, which perfectly insulates vibration from the vacuum vessel system.

**Table 2-7 Basic Specifications of Optical Bench**

item	specification
dimensions	6m (length) × 4m (width) × 0.5m (height)
mass	about 6,500 kg
material	aluminum alloy (A5083P-O)
structure	integrated with a weld box
main post	6 stainless steel pipes
bellows	stainless steel
surface roughness	25 μm or less
flatness	600 μm or less
eigen frequency	optical bench alone: 30Hz or higher in all the directions w/ supporting bench: about 27Hz in Y direction

#### (2) Seismic slab (Figure 2-10)

The seismic slab is a large slab made of reinforced concrete which is separated from the building foundation, the chamber foundation, and the machine foundation of the vacuum pumps, etc., to isolate vibration from them.

When performing an optical confirmation test on radiometers, etc., relative vibration can be controlled by placing the external light source on this seismic slab, that is, placing the light source and a TS on the same foundation.

- Eigen frequency: 20Hz or higher (for up/down and bending modes, according to analysis)

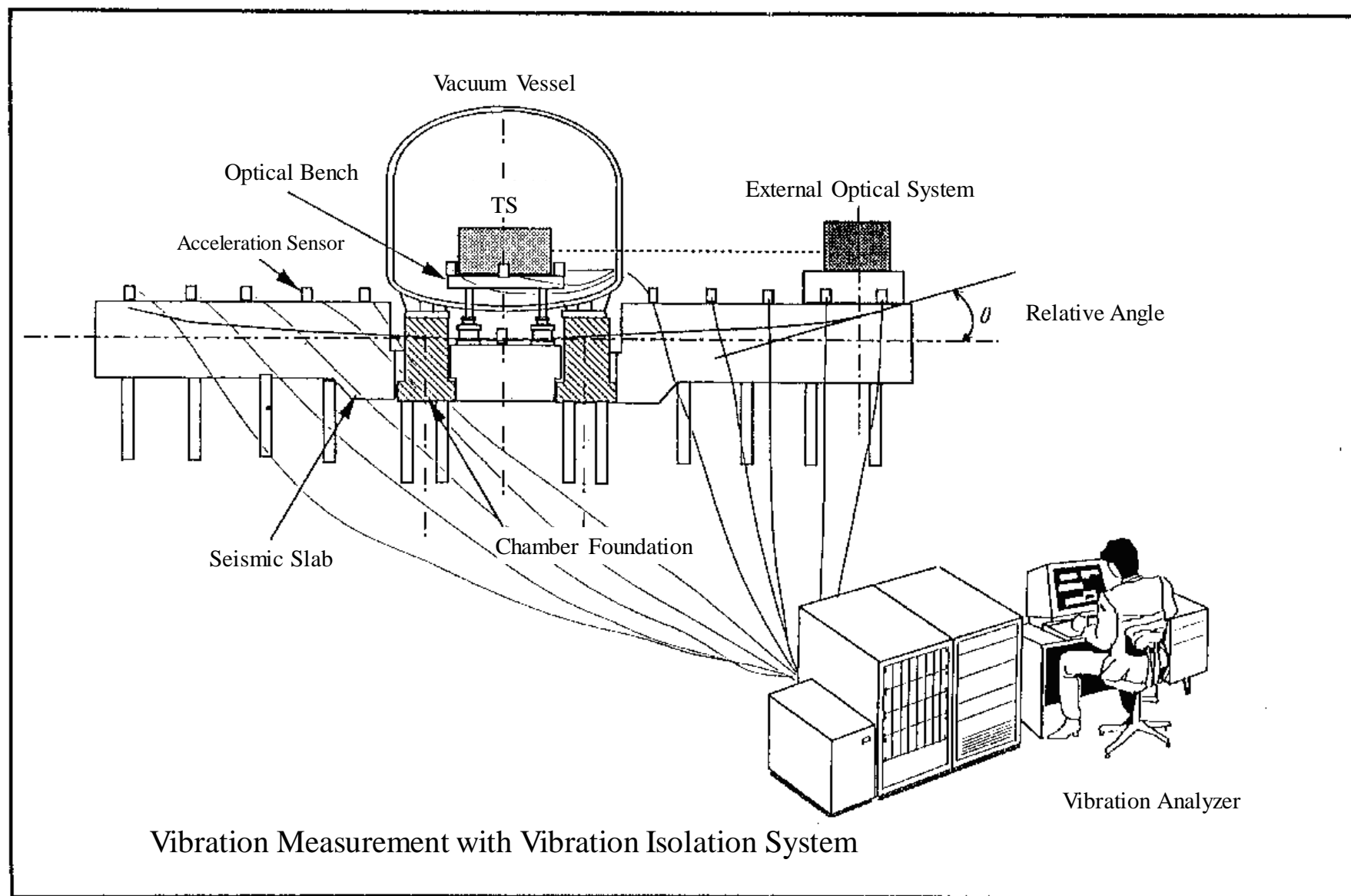
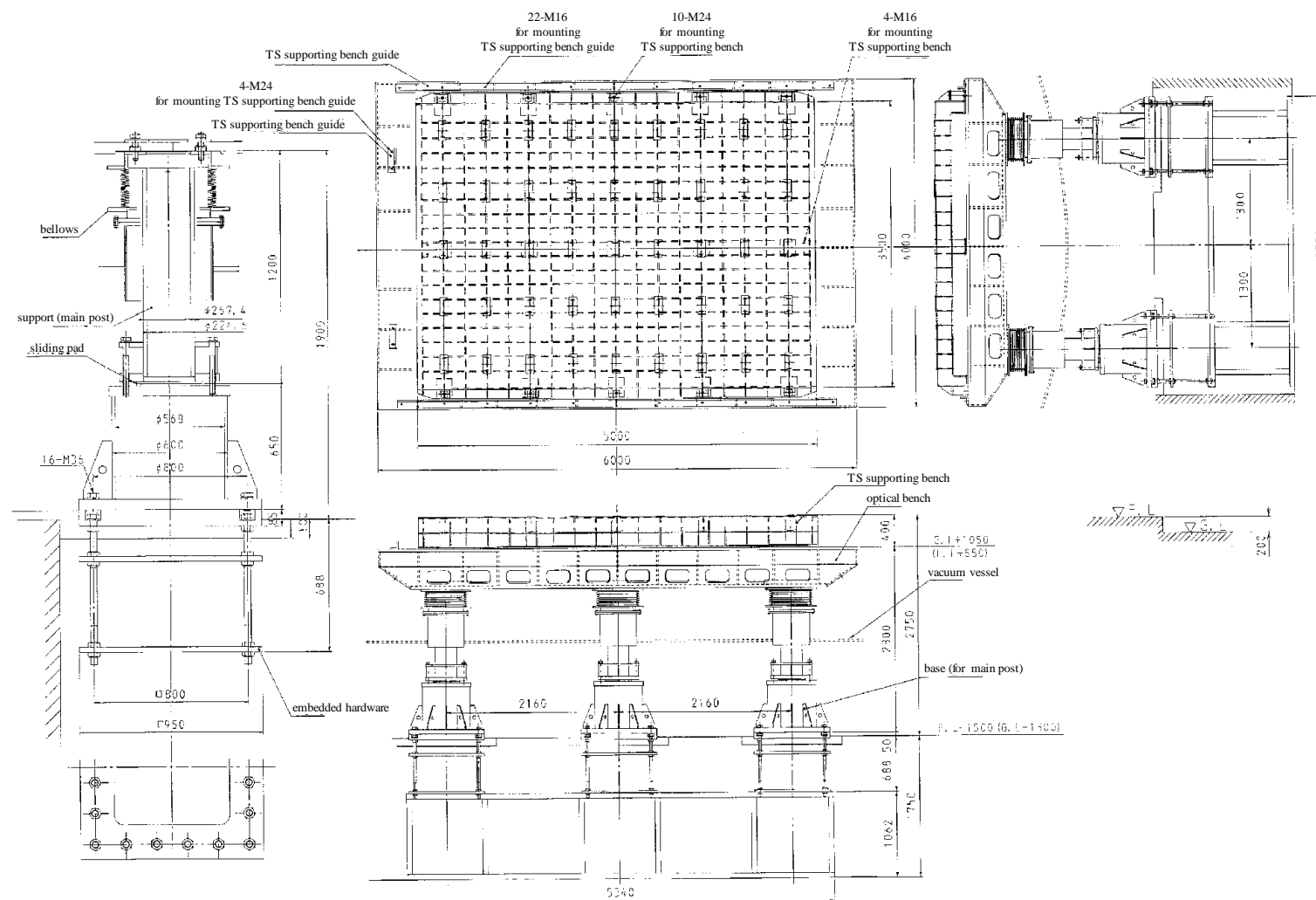


Figure 2-8 System Diagram of Vibration Isolation System



### Figure 2-9 Optical Bench

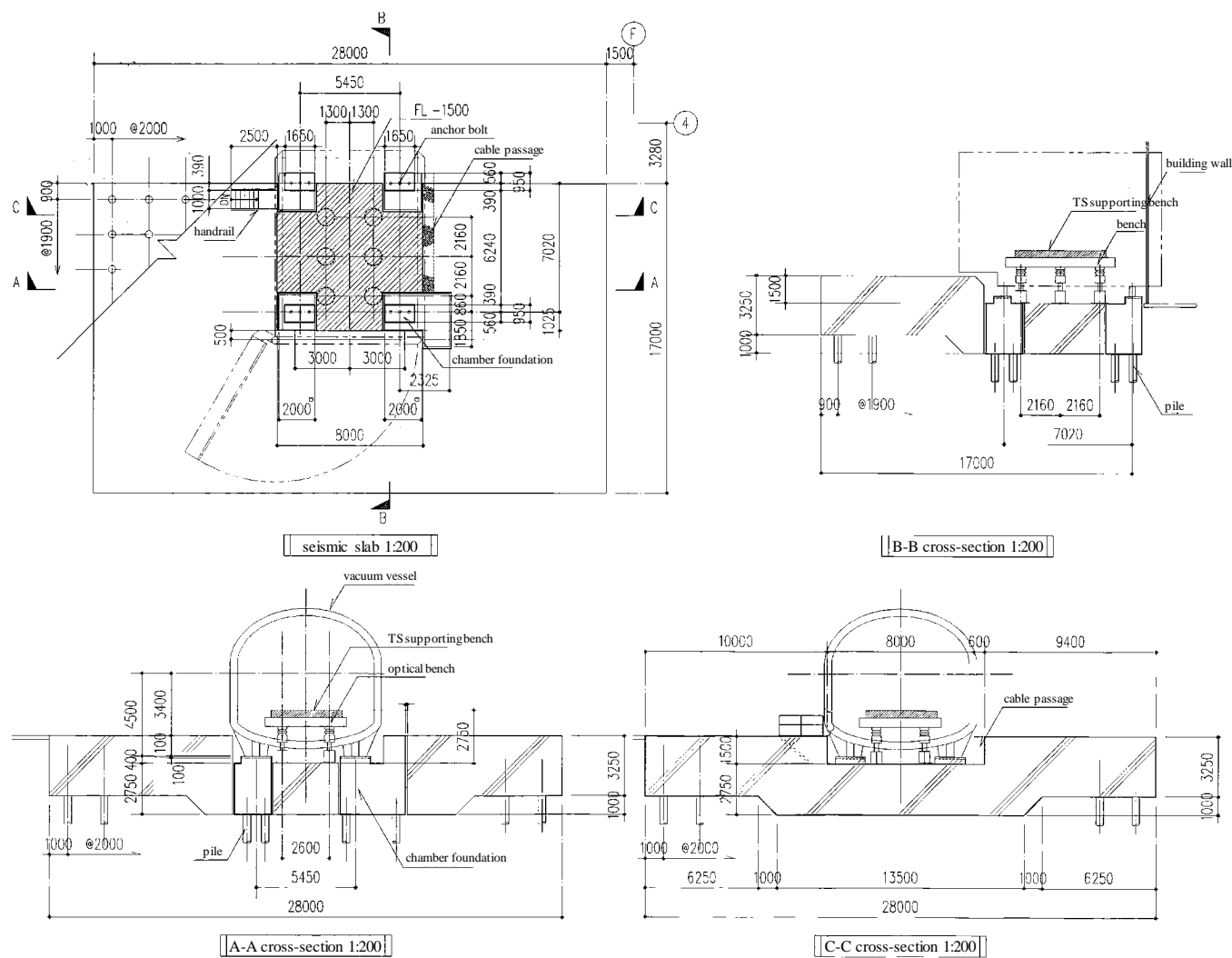


Figure 2-10 Seismic Slab



## (3) Vibration analyzer

The purpose of this vibration analyzer is to assess and verify the feasibility of an optical property verification test on a TS especially in micro vibration environments amid the constraints of the vibration turbulence specific to this facility. It is made up of measuring devices, e. g., accelerometers, drivers, etc., and a work station for analyzing data. The basic specifications and system diagram of the vibration analyzer are shown in Table 2-8 and Figure 2-11, respectively.

If it is planned to be used, contact us 6 months in advance, because it requires a prior-to-use checking by the facility-side personnel.

**Table 2-8 Basic Specifications of Vibration Analyzer**

item	specification
data to be dealt with	acceleration, relative displacement, relative angle
measurement spots	inside vacuum vessel: optical bench, shroud, vacuum vessel outside vacuum vessel: seismic slab, optical window
input	digital signals via accelerometers
output	output to monitor, or in digital (binary/text)/analogue data
frequency range	1Hz ~ 1,000Hz
number of measurement channels	31 channels (incl.) for accelerometers: 30 chs (inside vacuum vessel: 15 chs, outside vacuum vessel: 15 chs) for laser doppler displacement gauge: 1ch
contents of data analysis	• PSD analysis • transfer function analysis • waveform analysis • FFT analysis
accelerometer specification*	measurement range ( $\pm G$ ): 2.5
cryogenic accelerometer (393M33)	sensitivity (gal/V): 1,000
8 sets	resolution ( $\mu G$ ): 100
	working temperature range ( $^{\circ}C$ ): $-196 \sim +121$
	measurement range ( $\pm G$ ): 0.5
high sensitivity accelerometer (393B12)	sensitivity (gal/V): 100
3 sets	resolution ( $\mu G$ ): 8
	working temperature range ( $^{\circ}C$ ): $-46 \sim +82$
	measurement range ( $\pm G$ ): 0.5
high sensitivity accelerometer (393B31)	sensitivity (gal/V): 100
12 sets	resolution ( $\mu G$ ): 1
	working temperature range ( $^{\circ}C$ ): $-18 \sim +65$
calibration equipment	LV-2100 manufactured by Ono Sokki Co., Ltd. (laser doppler displacement gauge)

\* Accelerometers are fixed with heliserts. Pay enough attention to the screw parts, because they can easily be jammed.

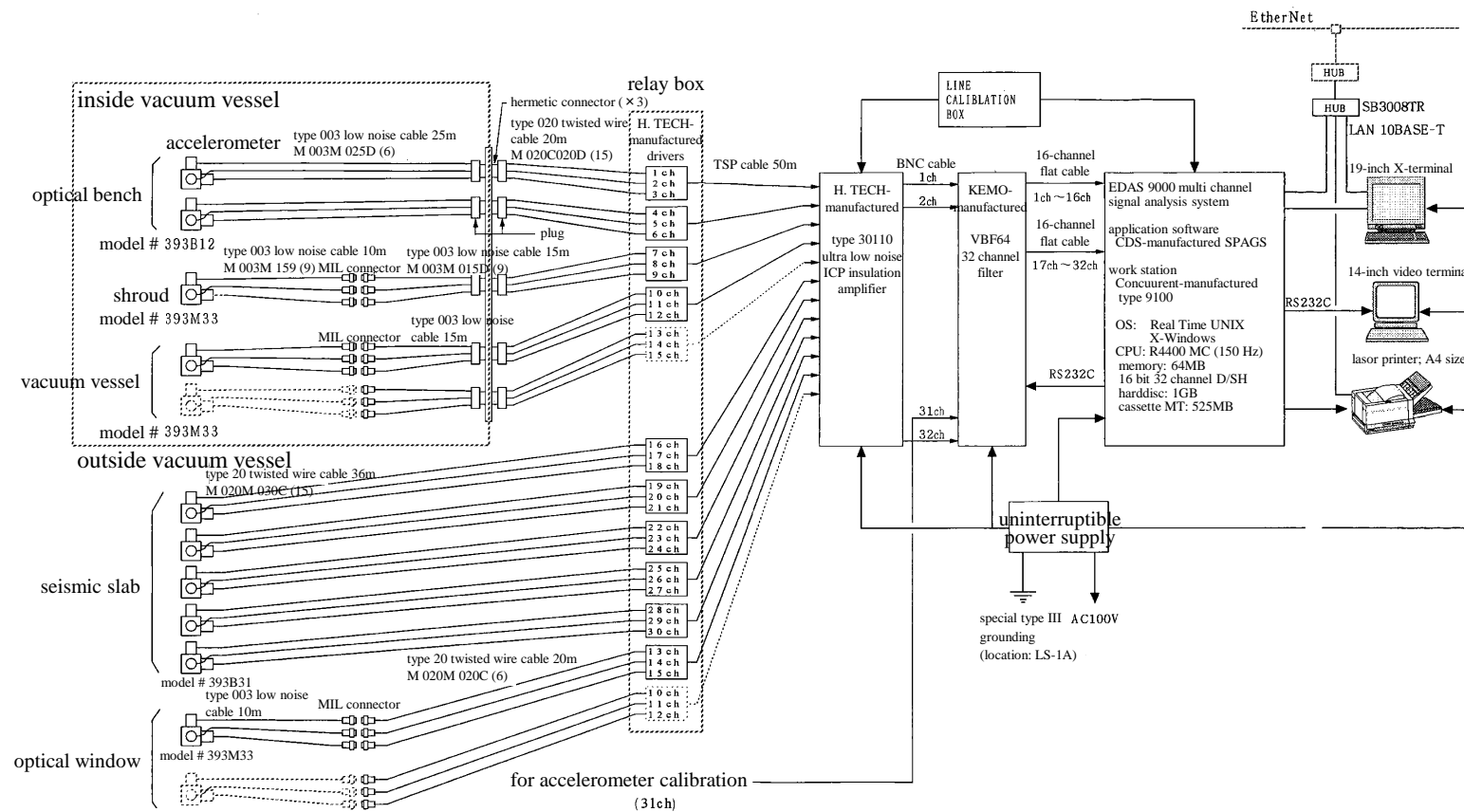


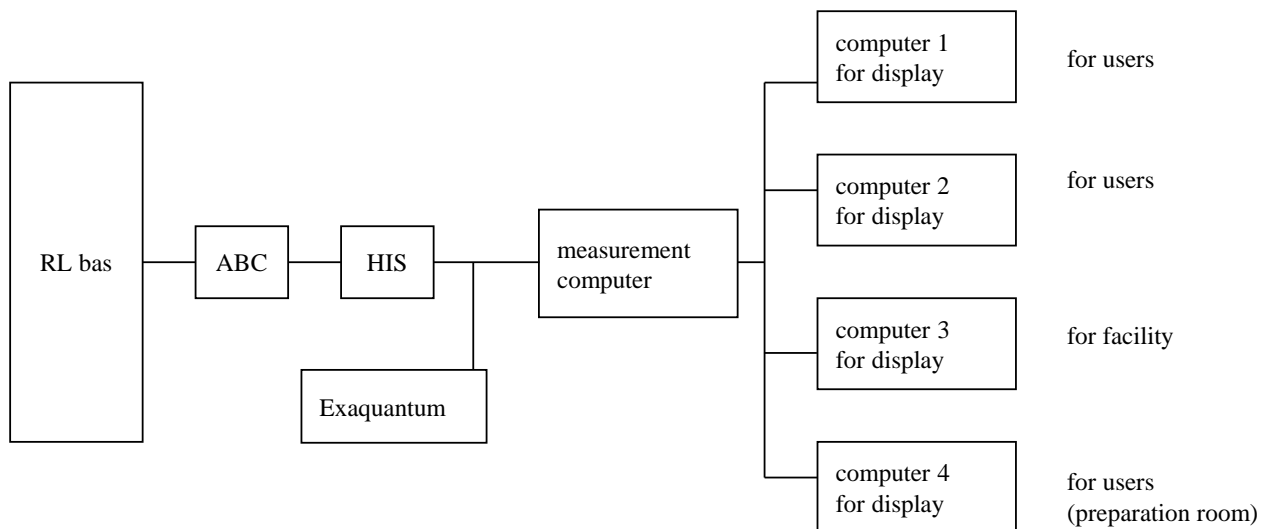
Figure 2-11 System Diagram of Vibration Analyzer

### 2.2.7. Data Acquisition System

This system possesses a function to acquire, process, and save TS data and facility data during a test on a satellite, etc., performed in this facility, while displaying the data in real time to the operator (viz. monitoring function.) Its basic specifications are shown below. The system diagram of the acquisition system and a correspondence table of thermocouple channels are shown in Figure 2-12 and Appendix A, respectively.

**Table 2-9 Basic Specifications of Data Acquisition System**

item	specification
Max. consecutive test days	45 days (for sampling cycle = 1 minute)
number of measurement points	thermocouple: 550 chs TQCM: 4 chs
measurement accuracy	(1) temperature: $\pm 1.0^{\circ}\text{C}$ uncertainty (incl. thermocouple sensors): $0.9^{\circ}\text{C}$ ( $k = 2$ ) : $1.4^{\circ}\text{C}$ ( $k = 3$ ) (2) voltage: measurement range $\pm 0.1\%$
sampling rate	1 time/min OR 1 time/2 mins Min. interval for thermocouple temperature measurement section = 1 sec
compatible thermocouple	T-type



**Figure 2-12 System Diagram of Data Acquisition System**

### 2.2.8. Utility Equipment

#### (1) ITV facility

The ITV facility is a TV system to monitor the ongoing state of equipment and work in this facility from the measurement and control room. There are two cameras with a turning and zooming function installed in the preparation room. There also exist two portable cameras (installed on the alignment windows of the vacuum vessel from outside) to monitor the state inside the vacuum vessel. One of them is a highly-sensitive type and the other is a normal type. There is no ITV camera installed inside the vacuum vessel. The entire images taken by the cameras can be recorded up to 30 days in time-division time lapse videos, allowing the required images to be copied on normal videos.

The jacks of the image/EP cables for the portable cameras are to be plugged in/out after making sure that the power is turned off.

#### (2) Communication system for operation

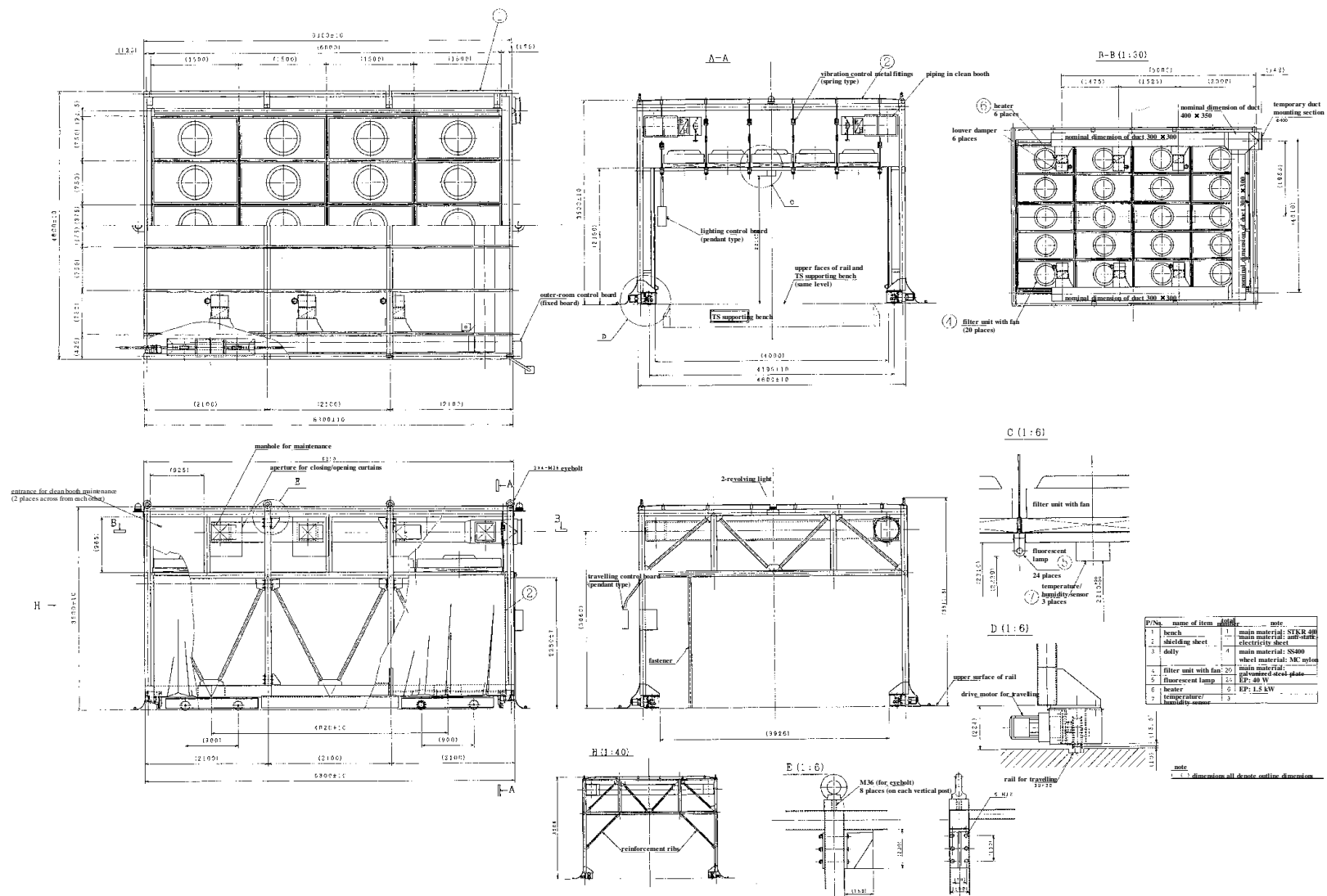
This system is made up of wired and wireless paging devices (multi-function telephones and cellular phones (digital)) which enable mutual communication among test-concerned personnel and announcement of instructions during the operation of the facility or preparation for testing on a TS.

#### (3) Clean booth

A clean booth is designed to achieve and maintain a highly clean environment for the preparation and execution of tests. Its basic specifications and external view are shown below and in Figure 2-13, respectively.

**Table 2-10 Basic Specifications of Clean Booth**

item	specification
performance, structure	cleanliness: ISO class 5 (equivalent of FED-STD-209 class 100) temperature: set temperature (20 ~ 23°C) $\pm 1^{\circ}\text{C}$ humidity: $50 \pm 10\%$ dimensions: 6m (width) $\times$ 4.6m (depth) $\times$ 3.5m (height) mass: 3,000 kg
location	inside the preparation room or vacuum vessel
installation environment	
(inside vacuum vessel, preparation room)	cleanliness: ISO class 7 (equivalent of FED-STD-209 class 10,000) temperature: $23 \pm 3^{\circ}\text{C}$ humidity: $50 \pm 10\%$



### Figure 2-13 Clean Booth

### 2.2.9. Gadgets and Spares

- (1) Mass-filter-type mass spectrometer (QMG220M3): 1 set

This device measures and analyzes the remnant gas components inside the vacuum vessel with its quadrupole analyzer.

Mass measurement range:  $M/e = 1 \sim 300$

- (2) Calorimeter (cf. Figures 2-14, 15): 30 sets

A calorimeter measures the radiant energy irradiated on a satellite from external heat sources, e. g., an IR lamp, for the purposes of setting, monitoring, and controlling test conditions for each test on a satellite, etc.

Measurement range:  $0.1 \text{ kW/m}^2 \sim 2.0 \text{ kW/m}^2$

Compatible thermocouple: copper-constantan

- (3) TQCM (Thermoelectric Quartz Crystal Microbalance): 4 sets

- (a) TQCM

Application purpose: for monitoring contamination

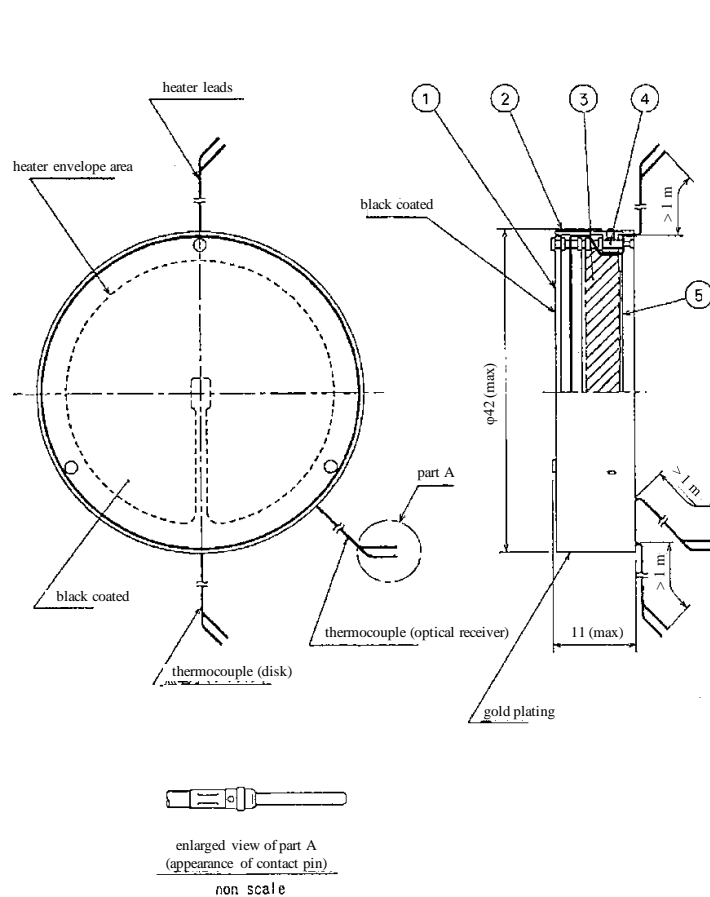
Model #: MK10 sensor, MODEL 1900 processor, MODEL 1800 temperature controller,  
manufactured by QCM Research Corp.

- (b) TQCM mounting table

Mounting part: hard points on the TS supporting bench

Note) Cautions for mounting TQCM sensors

- The temperature of a TQCM sensor may not go down if it is surrounded by heat sources, e. g., IR panels, due to the thermal input from them. In that case, measures are to be taken by mounting the sensor after its heat sink surface is cooled down, for example.
- When using TQCM with its HEAT PUMP (Peltier device) turned on, use it at  $-110^\circ\text{C}$  or higher.



manufactured by 0603-34-2039 (C u)  
Japan Deutsches co. 105372 (C o)

specification	
measurement range:	0.1~2.0 kW/m <sup>2</sup>
view angle:	hemisphere
reproducibility:	within $\pm 0.5\%$ (note 1)
accuracy:	within $\pm 0.3\%$ (note 1)
response time:	within 10 sec (note 2)
output level:	-5 ~ +7 mV
weight:	10 g or less (note 4)
applied thermocouple:	copper-constantan
solar absorptivity:	$0.96 \pm 0.0.2$ (note 6)
hemisphere IR emissivity:	$0.88 \pm 0.04$ (note 6)

note

1. It denotes the tolerance to the full scale in measurement range.
2. It denotes the time to take for temperature on the optical receiver to change by 10 °C when 1 solar is radiated on it with the initial temperature of -180°C~100°C.
3. Size tolerance shown below is to be followed when not specified.

classification	by nominal size	tolerance
over 6	~ 6	$\pm 0.6$
over 6	~ 18	$\pm 1$
over 18	~ 50	$\pm 1.3$
over 50	~ 120	$\pm 2$
over 120	~ 250	$\pm 2.5$
over 250	~ 500	$\pm 3.2$
over 500	~ 1000	$\pm 5$
over 1000	~ 2000	$\pm 8$
over 2000	~ 3150	$\pm 10$

4. Heater leads, thermocouple wires, contact pins, and standard supports are excluded.
5. Heater leads and thermocouple wires are to have a 0.1-mm-φ central line and 1-m length or more.
6. The measurement values are based on the sample coating.

	name	material	quantity
①	optical receiver	alumina	1
②	case	Al	1
③	insulation	Al Mylar	1
④	support	polyimide resin	3
⑤	disc	Al	1

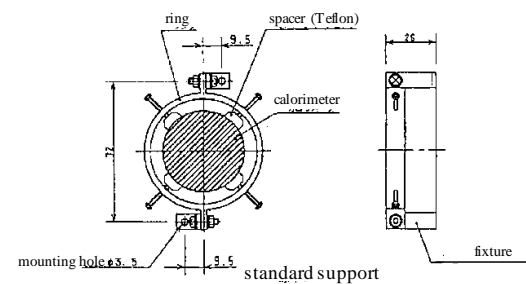


Figure 2-14 Calorimeter

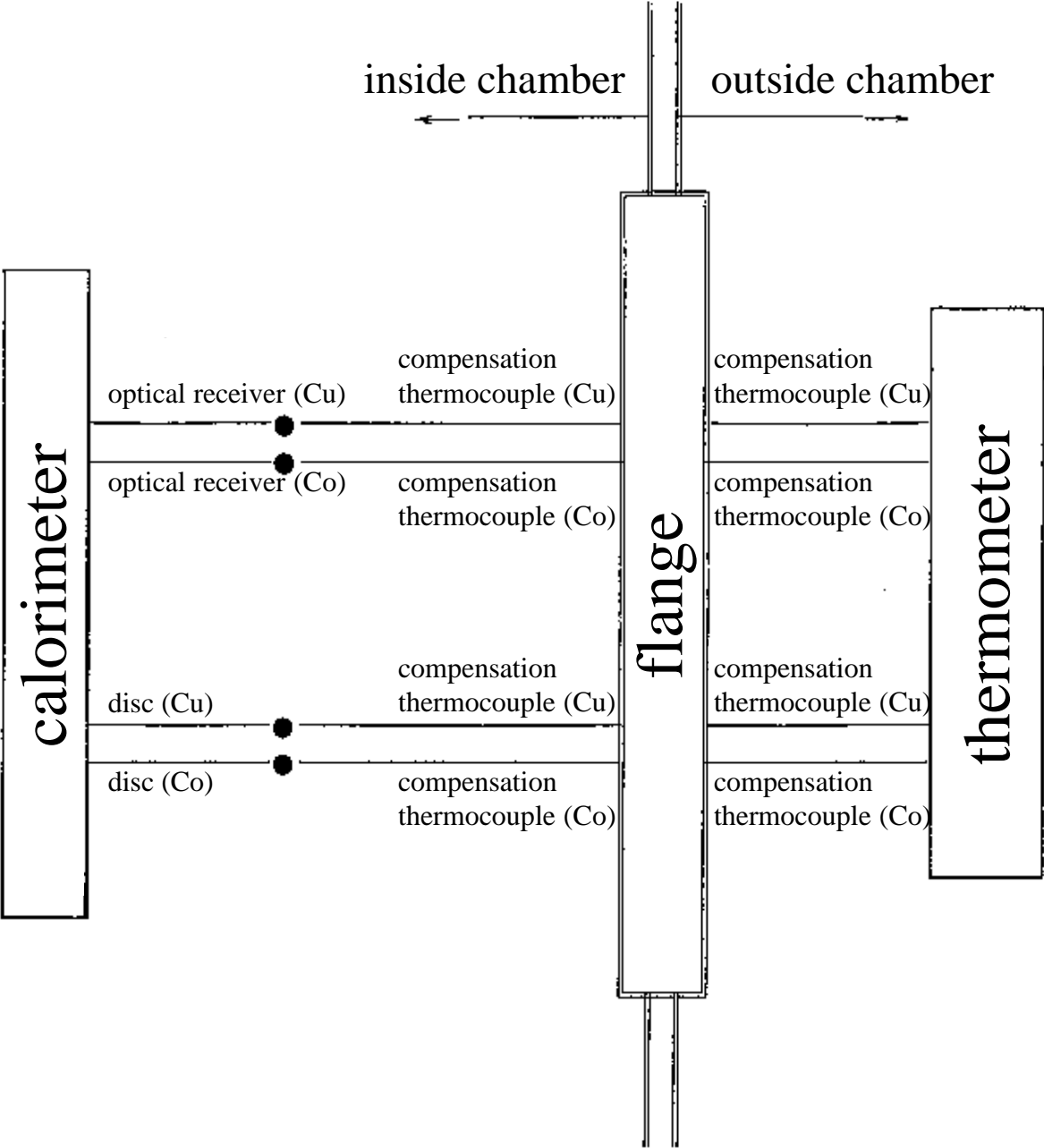


Figure 2-15 WBD Example of Calorimeter to Power Supply for Heat Sources



### **3. User I/F**

#### **3.1. Configuration between Inside and Outside of Space Chamber**

A system diagram of the post-TS-installation state of this facility is shown in Figure 3-1.

#### **3.2. Measurement and Control Room**

The measurement and control room (1F) possesses controllers and monitors for each of the control and monitor system and the data acquisition system.

The measured TS temperature, etc., can be checked in the data acquisition system, and the operation of the setting monitoring computer, T-QCM console, vibration analyzer, clean booth operation console, and the power supplies for heat sources is to be executed by users. If a TS is to be partially cooled or heated (cf. section 3.3.1.5), inform the company in charge of the facility of the automatic valve aperture percentage.

Figure 3-2 shows the configuration of the devices in the measurement and control room.

#### **3.3. Device I/Fs**

##### **3.3.1. Vacuum Vessel**

##### **3.3.1.1. Nozzle Configuration in Vacuum Vessel**

There are nozzles with flanges all over the vacuum vessel as the I/Fs to connect the inside and outside of the vessel (cf. Figure 3-3.) The nozzles not being used by the facility are available to users.

Especially, the main chamber body (to the measurement and control room side) has flanges for a TS with specific purposes as signals, EP, thermocouples, waveguides, etc.

In case feed-through terminals other than the ones prepared by the facility are necessary, users are to prepare the flanges with feed-through terminals to satisfy their designated purposes. A table of flanges is shown in Table 3-1.

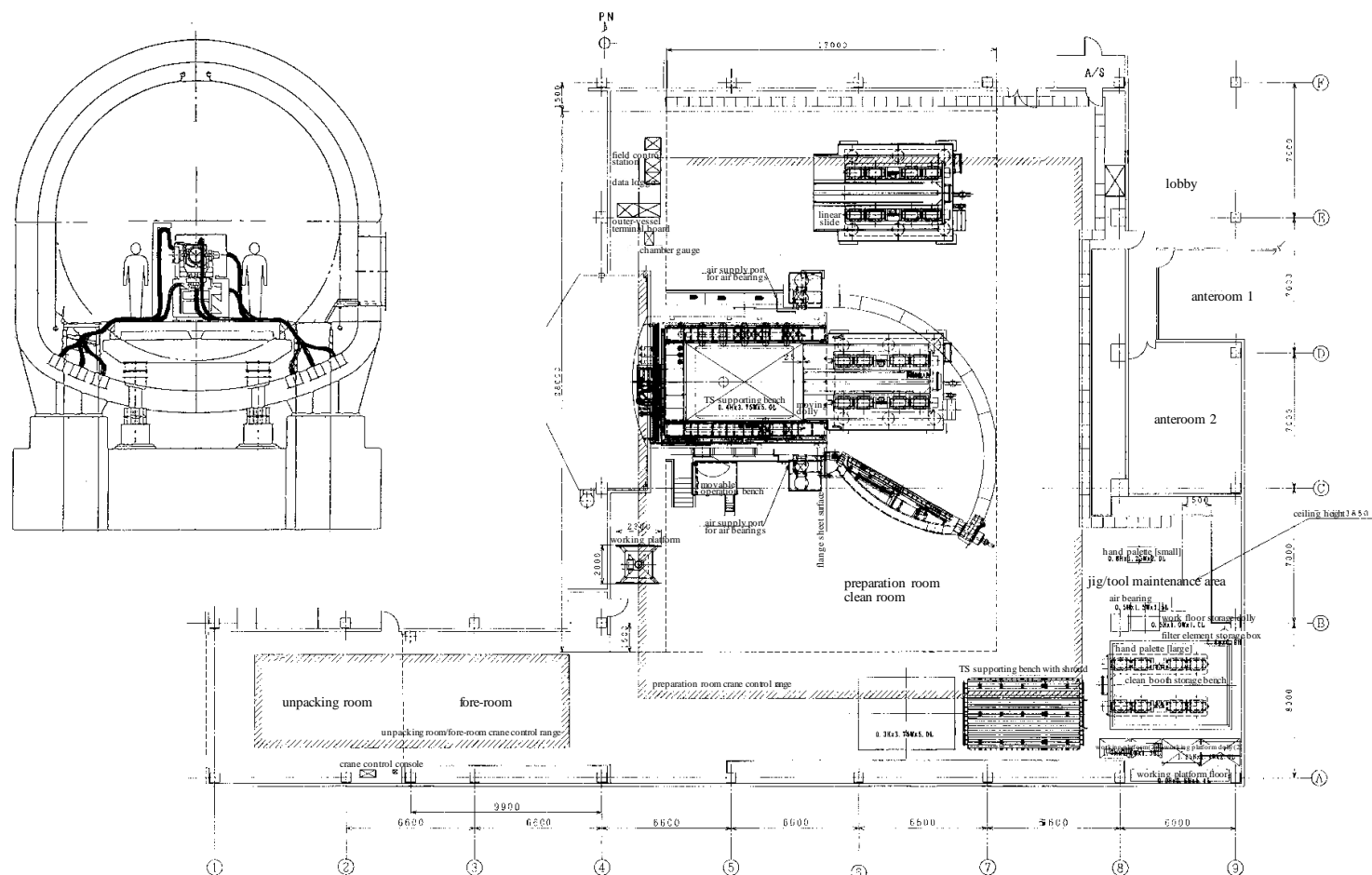


Figure 3-1 System Diagram for Operation in Preparation Room

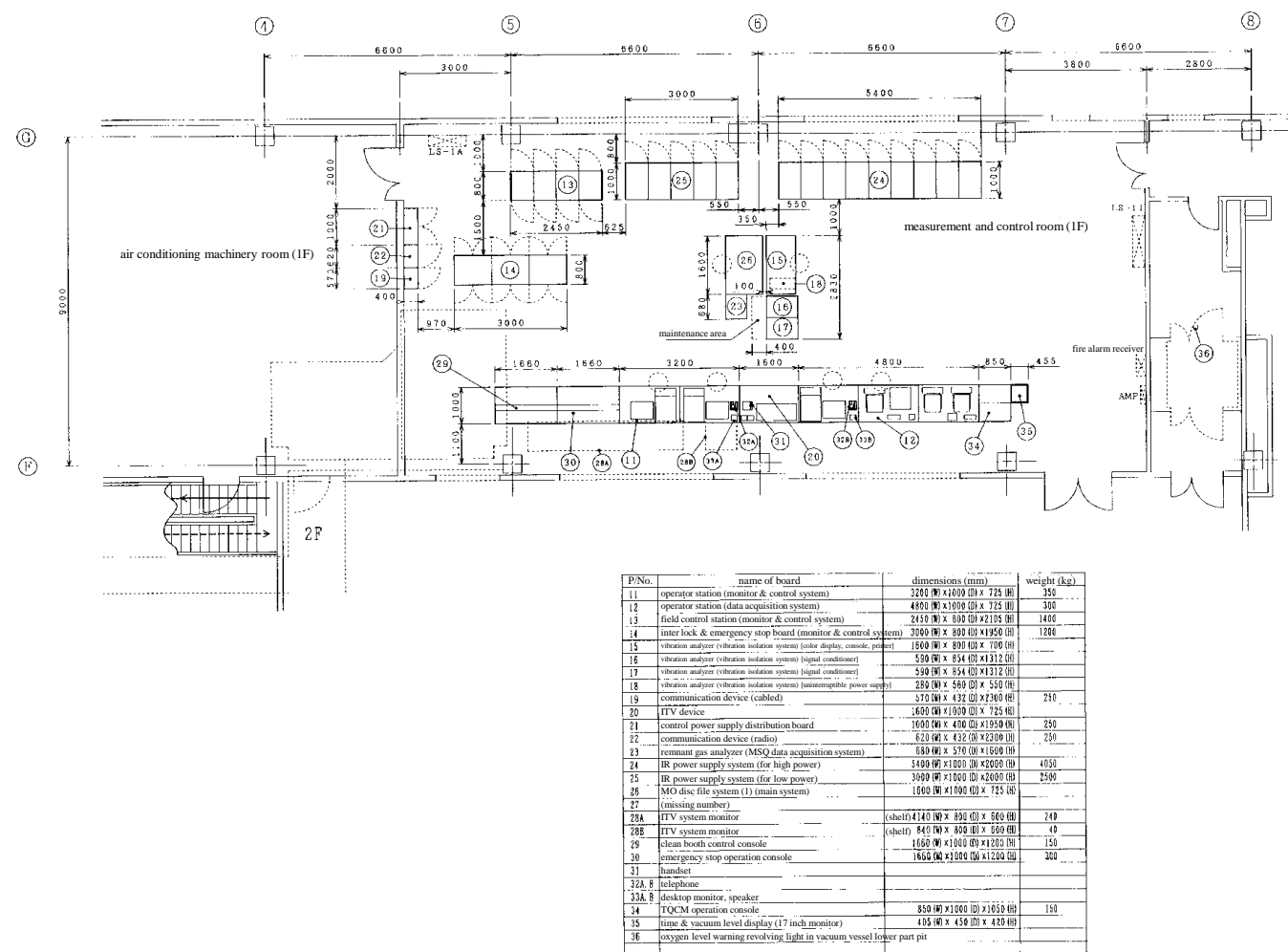


Figure 3-2 Configuration of Devices in Measurement and Control Room

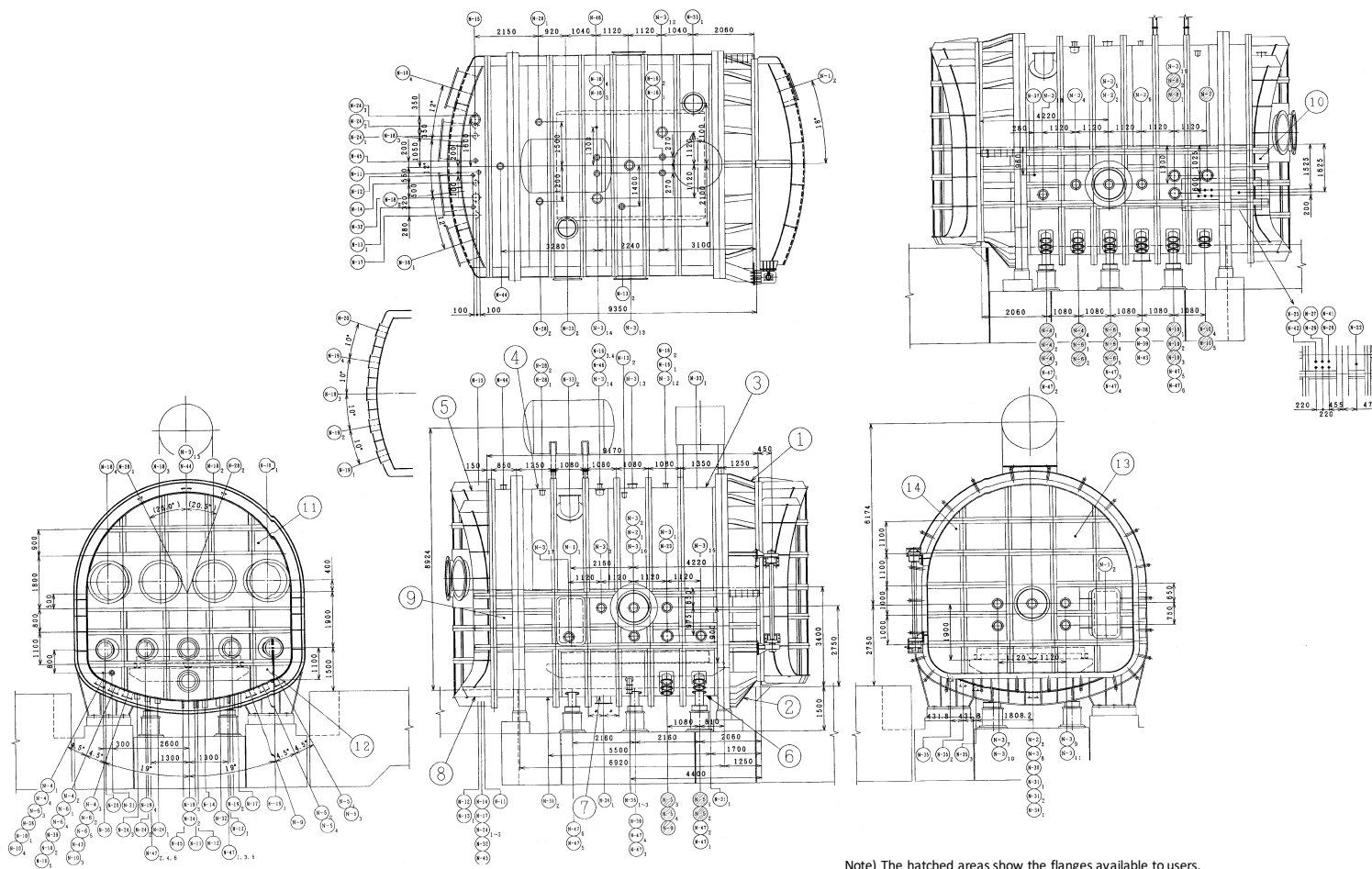


Figure 3-3 Configuration of Feed-through Terminal Nozzles

**Table 3-1 Table of Flanges (1/2)**

sign	nominal $\phi$	qty	model #	name	note
N-1	1500 $\times$ 800	2	SPECIAL	man door	straight cylindrical body 1, access door 1
N-2	1000 $\phi$	3	SPECIAL	optical window	straight cylindrical body 2, access door 1
N-3	250A	19	JIS VG	alignment window	straight cylindrical body 11, upper part 3, access door 5
N-4	300A	4	JIS VG	for CC thermocouples (incl. calorimeters, spares)	for TS thermocouples
N-5	300A	4	JIS VG	current inlet terminal	for IR power supplies (N-5 <sub>4</sub> is for spare)
N-6	300A	5	JIS VG	current inlet terminal (100V, 5A)	for TS signals
N-7	300A	1	JIS VG	high frequency output signal (coaxial)	
N-8	300A	2	JIS VG	for waveguides	only nozzles; N-8 <sub>1</sub> can also be used for the alignment window.
N-9	300A	1	JIS VG	current inlet terminal (200V, 10A)	for TS EP
N-10	300A	5	JIS VG	spare nozzle	
N-11	150A	1	stub end	LN <sub>2</sub> piping	IR gauge
N-12	125A	1	stub end	LN <sub>2</sub> piping	
N-13	150A	2	stub end	LN <sub>2</sub> piping	
N-14	200A	1	stub end	LN <sub>2</sub> piping	
N-15	250A	1	stub end	LN <sub>2</sub> piping	
N-16	150A	4	stub end	LN <sub>2</sub> piping	
N-17	250A	1	stub end	He piping	
N-18	1250A	4	SPECIAL	cryosorption pump	
N-19	500A	4	JIS VG	turbo molecular pump	
N-20	500A	1	JIS VG	low vacuum system, vacuuming port	
N-21	100A	1	JIS VG	dry air inlet port	
N-22	32A	1	ICF 70	residual gas analyzer pipe port	
N-23	300A	1	JIS VG	current inlet terminal	for vibration analysis
N-24	150A	3	JIS VG	GN <sub>2</sub> entrance	
N-25	20A	1	JIS VG	Bourdon tube pressure gauge	
N-26	32A	1	ICF 70	Pirani gauge	
N-27	32A	1	ICF 70	BA gauge	
N-28	100A	2	JIS VG	ionization gauge (nude gauge)	
N-29	32A	1	ICF 70	ionization gauge (wide range A)	
N-30	250A	1	JIS VG	GN <sub>2</sub> exit	

**Table 3-1 Table of Flanges (2/2)**

N-31	50A	2	JIS VG	for scavenger cryopanel drains	
N-32	300A	1	stub end	for partial cooling of TS	IR gauge
N-33	600A	2	JIS VG	for permanently equipped lighting	
N-34	500A	2	JIS VG	manhole (for operation)	on the chamber head 1, on the bottom of the body: 1
N-35	150A	3	JIS VG	GN <sub>2</sub> exit	
N-36	15A	1	—	GN <sub>2</sub> entrance	
N-37	32A	1	ICF 70	for safety switches	
N-38	300A	1	JIS VG	for facility, shroud temperature measurement	
N-39	300A	1	JIS VG	for facility, SBG temperature (incl. T-QCM)	
N-40	150A	1	JIS VG	safety device	attached to the vacuuming port piping of low vacuum system
N-41	32A	1	ICF 70	ionization gauge (wide range B)	
N-42	20A	1	JIS VG	diaphragm pressure gauge	
N-43	300A	1	JIS VG	current inlet terminal	for resistor temperature measurement
N-44	200A	1	stub end	LN <sub>2</sub> piping	
N-45	150A	1	stub end	LN <sub>2</sub> piping	
N-46	20A	1	JIS VG	oximeter	
N-47	450A	6	JIS VG	nozzle for optical bench post	

Note) The shaded lines denote the flanges available to users.

### 3.3.1.2. WBD for EP, Signals, etc.

Refer to the following Figures and Tables for the cabling or the connector WBD between a TS and its check-out devices, etc., inside and outside the chamber, and choose the appropriate items according to the purposes.

- |   |               |
|---|---------------|
| (1) Table of Feed-through Terminals for Current/Thermocouples (for users)   | (Table 3-2)   |
| (2) WBD Diagram of Feed-through Terminal  | (Figure 3-4)  |
| (3) WBD Diagram of Signal Lines (5A) for TS [plug signs A1 ~ 100]   | (Figure 3-5)  |
| (4) WBD Diagram EP Lines (10A) for TS [plug signs B1 ~ 11]  | (Figure 3-6)  |
| (5) WBD Diagram of Thermocouples/Calorimeters for TS, and Thermocouple Spare Lines [plug signs C1 ~ 42, D1 ~ 5, N1 ~ 2] | (Figure 3-7)  |
| (6) WBD Diagram Temperature Sensors (thermistor platinum sensors) for TS [plug signs E1 ~ 13]                           | (Figure 3-8)  |
| (7) WBD Diagram of SBG Temperature Measurement [plug signs G1 ~ 3]  | (Figure 3-9)  |
| (8) WBD Diagram of 2 kW IR Power Supply Rack (100V, 30A) [plug signs H1 ~ 15]   | (Figure 3-10) |
| (9) WBD Diagram of 60W IR Power Supply Rack (100V, 3A) [plug signs J1 ~ 6]  | (Figure 3-11) |
| (10) Feed-through Terminal for Coaxial Cables of TS   | (Figure 3-12) |
| (11) Inner-vessel Permanent Terminal Boards – I, II, III  | (Figure 3-13) |
| (12) External Input Terminal Boards – I, II   | (Figure 3-14) |

Note) For grounding, the same type of plug as shown in (8) is to be used, which is connected to Q1 on the inner-vessel permanent terminal board (3); the pins A and B on Q1 respectively correspond to E3 and SE3 for grounding.

#### [Notes for Wiring Thermocouples]

The thermocouple terminal receptacles on the inner-vessel permanent terminal boards (Figure 3-13) are manufactured by Japan Deutsches co. while those on the external input terminal boards (Figure 3-14) are manufactured by Hitachi Power Semiconductor Device, Ltd. The two companies' receptacles have different numbers of conductors and pin configurations, which requires attention to the following matters.

- (1) The terminal pair on the Japan Deutsches' connector that corresponds to the J-Q pair on the Hitachi Power Semiconductor Device's connector is J-Ć, due to the lack of terminal Q.
- (2) The terminals a and b on the Japan Deutsches' connector are to be left unused.
- (3) Since the K-R and J-Ć pin pairs on the Japan Deutsches' connector are located away from each other, the order of WBD is to be determined with that fact taken into account.
- (4) The thermocouple plugs do not include socket contacts, which are therefore to be procured based on the specifications shown below.
  - Manufactured by Japan Deutsches co.
 

Socket contact (Cu)	: model # 0603-34-2039
Socket contact (constantan)	: model # 105372
  - Manufactured by Hitachi Power Semiconductor Device, Ltd.
 

Socket contact (Cu)	: Figure 3-15 NM-104-845-article # 1
Socket contact (constantan)	: Figure 3-15 NM-104-845-article # 2

sign	application purpose	specification	connector #	usable size	situation	figure
A	signal line	100V/5A	A1~A100	49	A21: not available wired from inside chamber ~ external input terminal board	3-5
B	EP	100V/10A	B1~B11	44	wired from inside chamber ~ external input terminal board	3-6
C	thermocouple	CC	C1~C42	479	C3: ch. 2~12 not available C14: ch. 12 not available C28: ch. 12 not available C42: all 12chs not available	3-7
D	calorimeter	CC	D1~D5	60	ch. 12 not available	
N	thermocouple sensor	CC	N2	11	ch. 12 not available	
F	thermometric resistor	—	F1~F13	30	via converter board LP910	3-8
H	thermistor, platinum sensor	—	—	—	via data acquisition system (Daqtec)	
H	EP	100V/30A	H1~H15	30	H1~H5: connected to 3kW power supply rack-1 H6~H10: connected to 3kW power supply rack H11~H15: 2kW power supply rack-2 (power supplies No. 3, 4 are not available) H12: for facility support bench heater	3-10
J	EP	100V/3A	J1~J6	30	J1~J5: connected to 60W power supply J6: wired from inside chamber ~ external input terminal board	3-11

to be prepared by users

item #	application purpose	specification	rev. of connector	Min. size of conductor	rev. of flange	hozzle allocation size	notes	inner-vessel permanent terminal board										vacuum vessel feed-through terminal										preparation room external input terminal board										note
								dust cap	plug	receptacle	junction shell	cable clamp	cable clamp	plug	plug	cable clamp	cable clamp	junction shell	receptacle	plug	plug	cable clamp	cable clamp	junction shell	receptacle	plug	plug	cable clamp	cable clamp	junction shell	receptacle	plug	plug	terminal				
1	TS signals (5A)	5A DC 100V	500	1000 (1000)	10. x 20 conductors	300AX	N-6 1~5	#16X10 conductors	MS25043-18D	MS3106B18-1S	MS3102A18-1P	CA2120-9	MS3057-10A	MS3057-10A	MS3106B18-1S	MS3106B18-1S	MS3057-10A	MS3057-10A	CA2120-9	MS3102A18-1P	MS3106B18-1S	MS3106B18-1S	MS3057-10A	MS3057-10A	CA2120-9	MS3102A18-1P	MS3106B18-1S	MS3106B18-1S	MS3057-10A	MS3057-10A	CA2120-9	MS3102A18-1P	MS3106B18-1S	MS3106B18-1S	A1~A100			
connector maker									Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited				
2	TS EP (10A)	10A DC 100V	40	80 (80)	8 x 11 conductors	300AX	N-9	#12x8 conductors	MS25043-22D	MS3106B22-23S	MS3102A22-23P	CA2120-11	MS3057-12A	MS3057-12A	MS3106B22-23S	MS3106B22-23S	MS3057-12A	MS3057-12A	CA2120-11	MS3102A22-23P	MS3106B22-23S	MS3106B22-23S	MS3057-12A	MS3057-12A	CA2120-11	MS3102A22-23P	MS3106B22-23S	MS3106B22-23S	MS3057-12A	MS3057-12A	CA2120-11	MS3102A22-23P	MS3106B22-23S	MS3106B22-23S	B1~B11			
connector maker									Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited					
3	TS thermocouple	C. C.	500	1000 24 x 14 (1000)	24 x 14 conductors	300AX	N-4 1~3	#16 X 24 conductors	660-00W1656-34	MS3106B16-1S	MS3102A16-1P	CA2120-9	MS3057-15A	MS3057-15A	MS3106B24-28SC	MS3106B24-28SC	MS3057-16A	MS3057-16A	CA2120-12	MS3102A24-28P	MS3106B24-28SC	MS3106B24-28SC	MS3057-16A	MS3057-16A	CA2120-12	MS3102A24-28P	MS3106B24-28SC	MS3106B24-28SC	MS3057-16A	MS3057-16A	CA2120-12	MS3102A24-28P	MS3106B24-28SC	MS3106B24-28SC	C1~C42			
connector maker									Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.				
4	calorimeter (60 ch) spare thermocouple (20 ch)	C. C.	60	120 24 x 5 (120)	24 x 5 conductors	300AX	N-4 1~3	#16 X 24 conductors	660-00W1656-34	MS3106B16-1S	MS3102A16-1P	CA2120-9	MS3057-15A	MS3057-15A	MS3106B24-28SC	MS3106B24-28SC	MS3057-16A	MS3057-16A	CA2120-12	MS3102A24-28P	MS3106B24-28SC	MS3106B24-28SC	MS3057-16A	MS3057-16A	CA2120-12	MS3102A24-28P	MS3106B24-28SC	MS3106B24-28SC	MS3057-16A	MS3057-16A	CA2120-12	MS3102A24-28P	MS3106B24-28SC	MS3106B24-28SC	D1~D5 N1, N2			
connector maker									Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.	Japan Deutchesches co. Ltd.				
5	TS temperature measurement (thermistor, platinum sensor)	1A DC 100V	301	120 10 x 13 (110)	10 x 13 conductors	300AX	N-43	#16 X 10 conductors	MS25043-18D	MS3106B18-1S	MS3102A18-1P	CA2120-9	MS3057-10A	MS3057-10A	MS3106B18-1S	MS3106B18-1S	MS3057-10A	MS3057-10A	CA2120-9	MS3102A18-1P	MS3106B18-1S	MS3106B18-1S	MS3057-10A	MS3057-10A	CA2120-9	MS3102A18-1P	MS3106B18-1S	MS3106B18-1S	MS3057-10A	MS3057-10A	CA2120-9	MS3102A18-1P	MS3106B18-1S	MS3106B18-1S	E1~E13			
connector maker									Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited					
6	shroud temperature measurement	C. C.	301	60 24 x 31 (12)	24 x 31 conductors	300AX	N-38	#16 X 24 conductors	MS25043-18D	MS3106B18-1S	MS3102A18-1P	CA2120-9	MS3057-15A	MS3057-15A	MS3106B24-28SC	MS3106B24-28SC	MS3057-16A	MS3057-16A	CA2120-12	MS3102A24-28P	MS3106B24-28SC	MS3106B24-28SC	MS3057-16A	MS3057-16A	CA2120-12	MS3102A24-28P	MS3106B24-28SC	MS3106B24-28SC	MS3057-16A	MS3057-16A	CA2120-12	MS3102A24-28P	MS3106B24-28SC	MS3106B24-28SC	F1~F13			
connector maker									Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited	Japan Aviation Electronics Industry Limited														

Table 3-2 Table of Feed-through Terminals for Current/Thermocouples (1/2) (Simplified)

Table 3-2 Table of Feed-through Terminals for Current/Thermocouples (2/2) (Detailed)



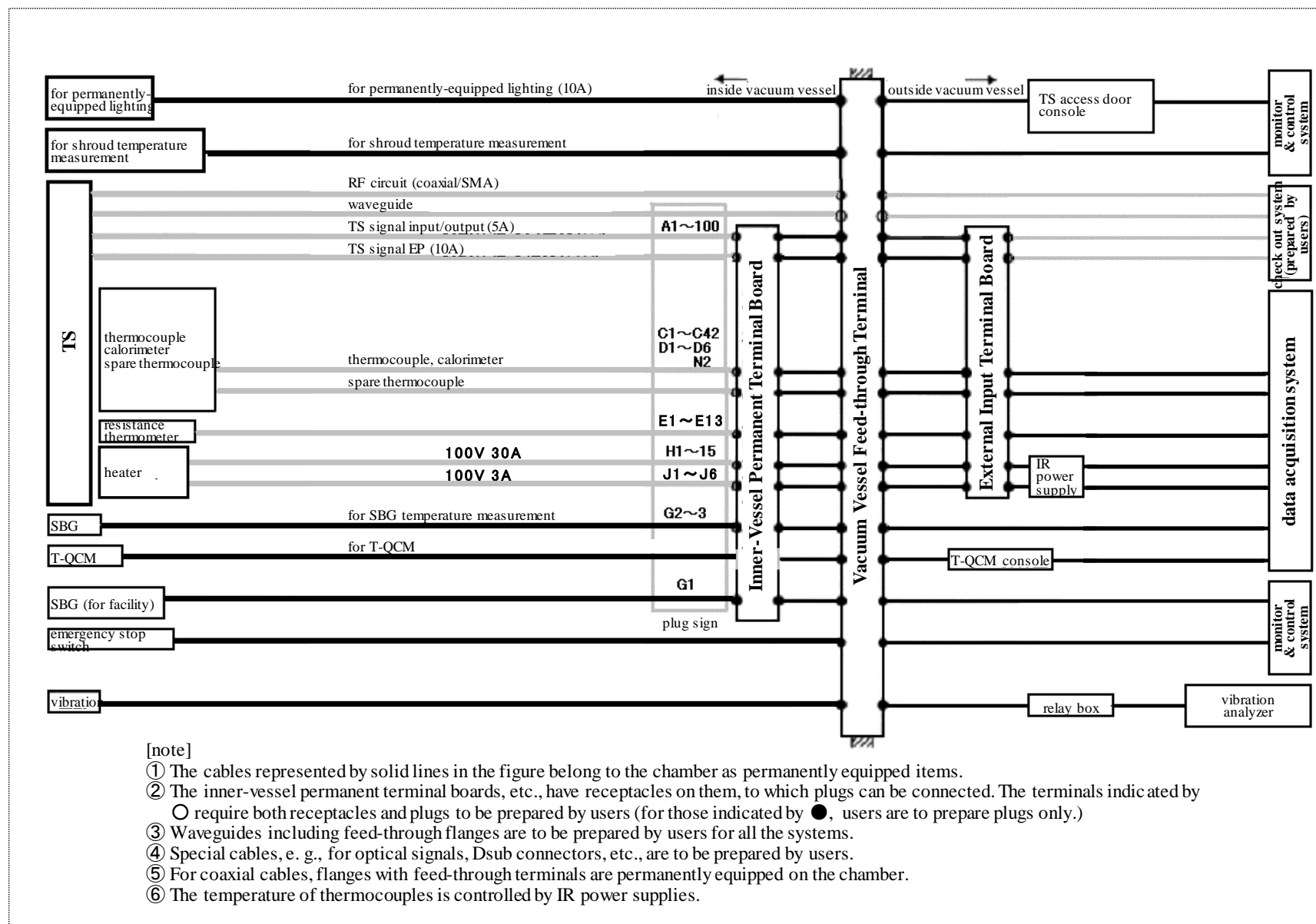


Figure 3-4 WBD Diagram of Feed-through Terminal

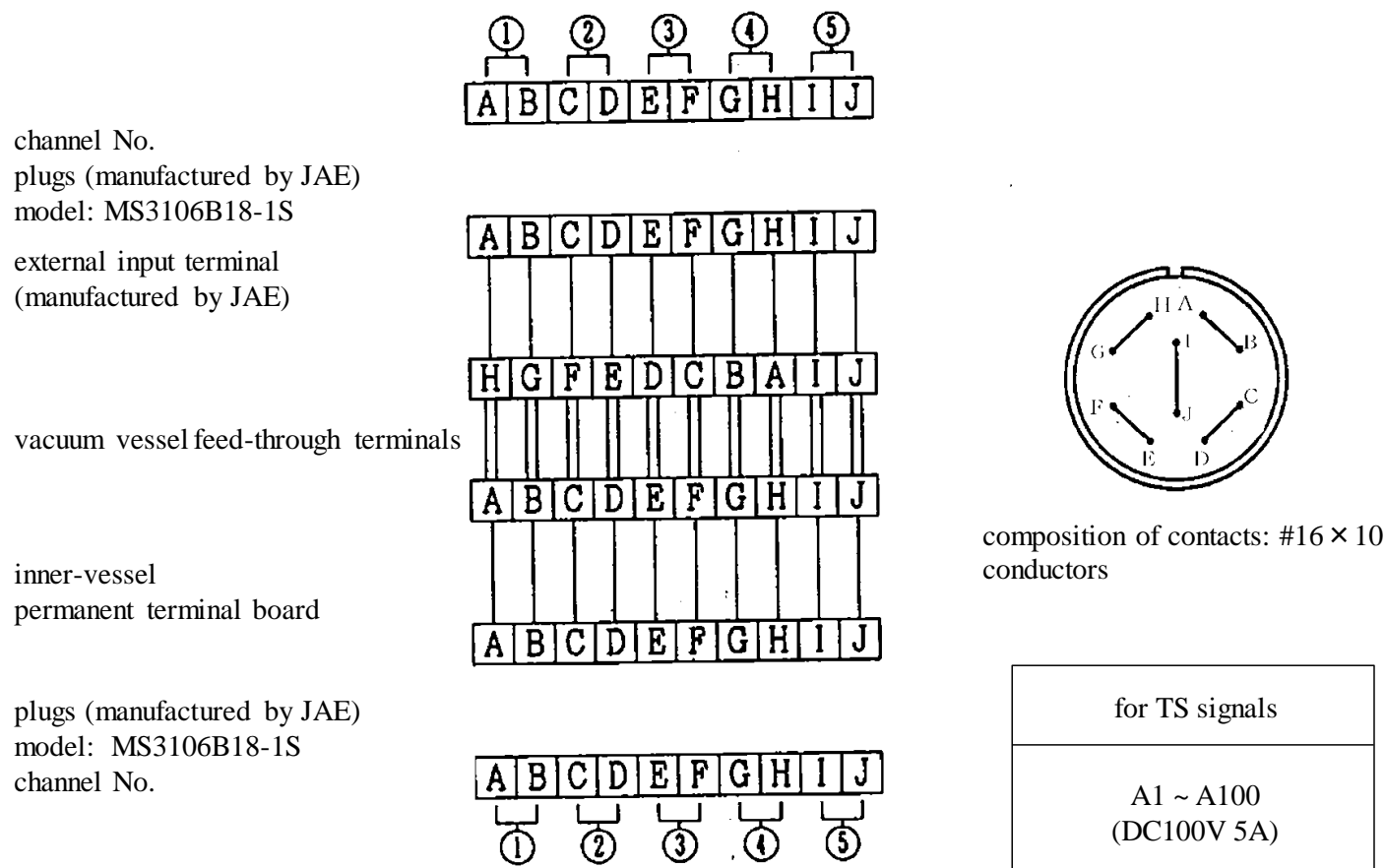


Figure 3-5 WBD Diagram of Signal Lines for TS

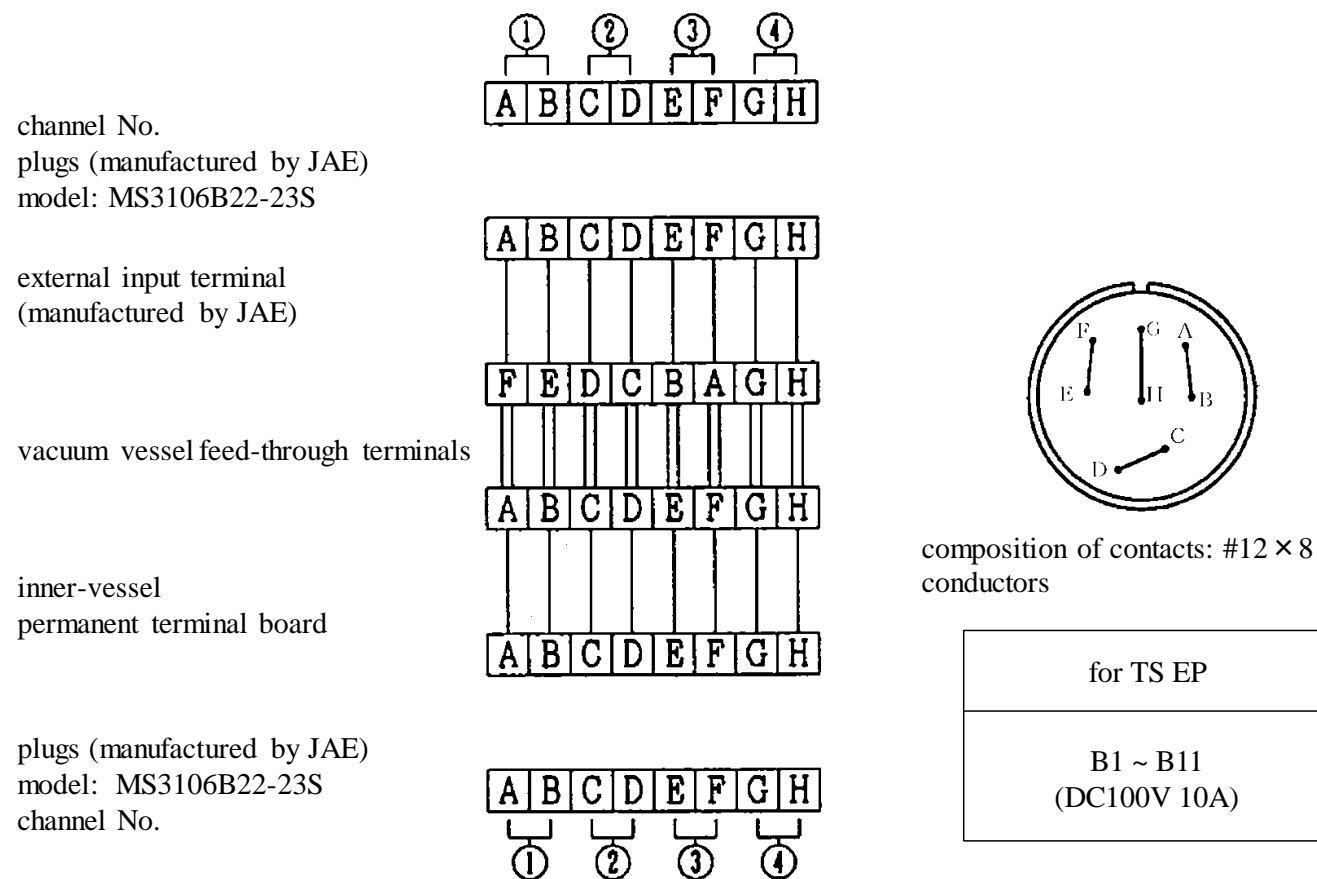
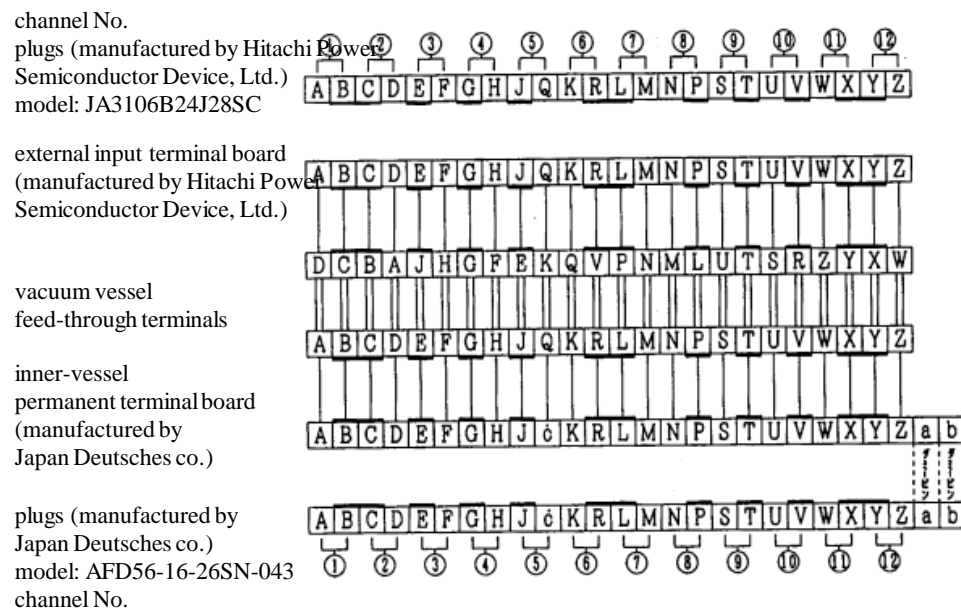


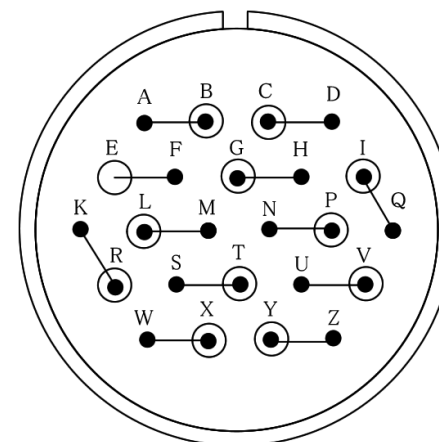
Figure 3-6 WBD Diagram of EP Lines for TS



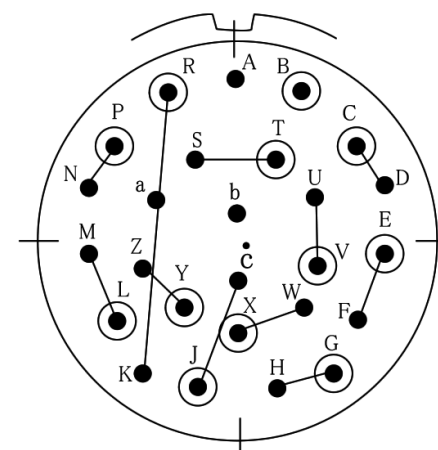
C1 ~ C42 for thermocouples  
 D1 ~ D5 for calorimeters  
 ..N<sub>2</sub> spares

● Cu pin

⊙ Constantan pin



composition of contacts: #16 × 24  
 conductors



composition of contacts: #20 × 26  
 conductors

**Figure 3-7 WBD Diagram of Thermocouples/Calorimeters for TS, and Thermocouple Spare Lines**

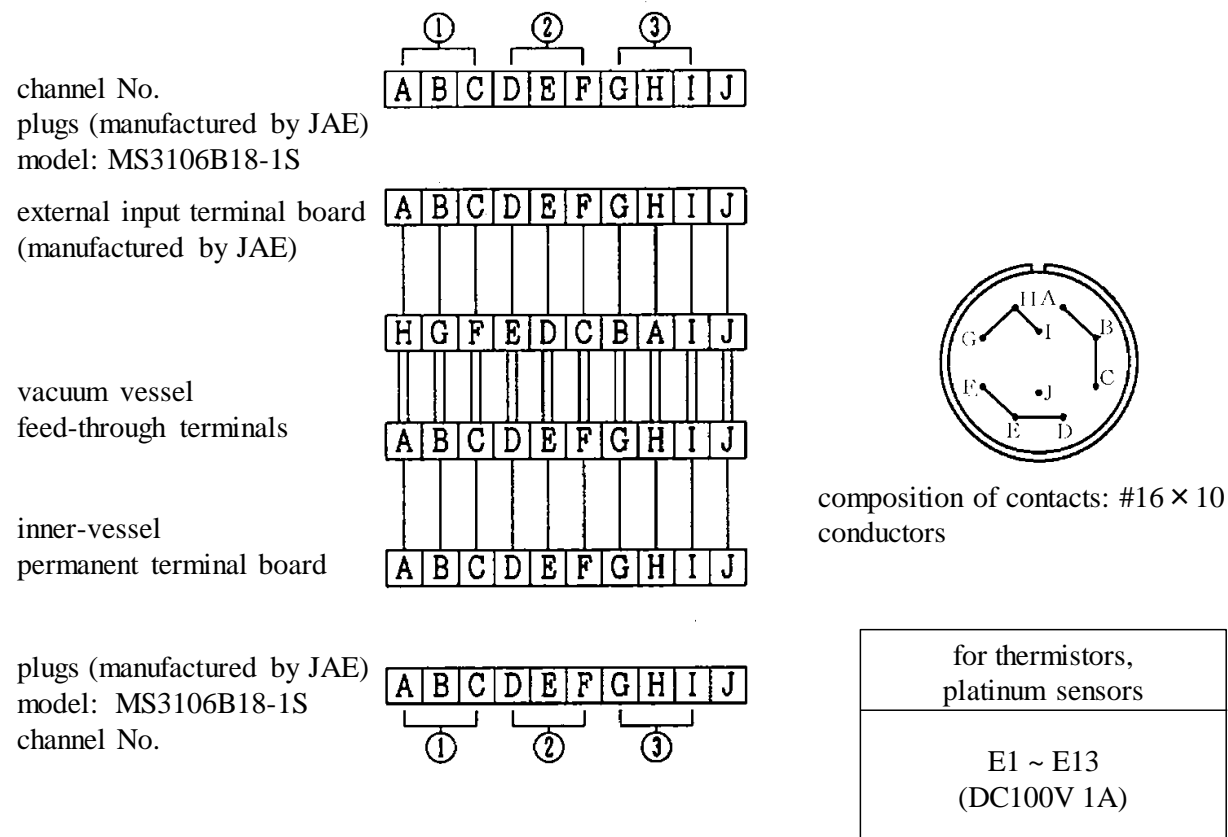
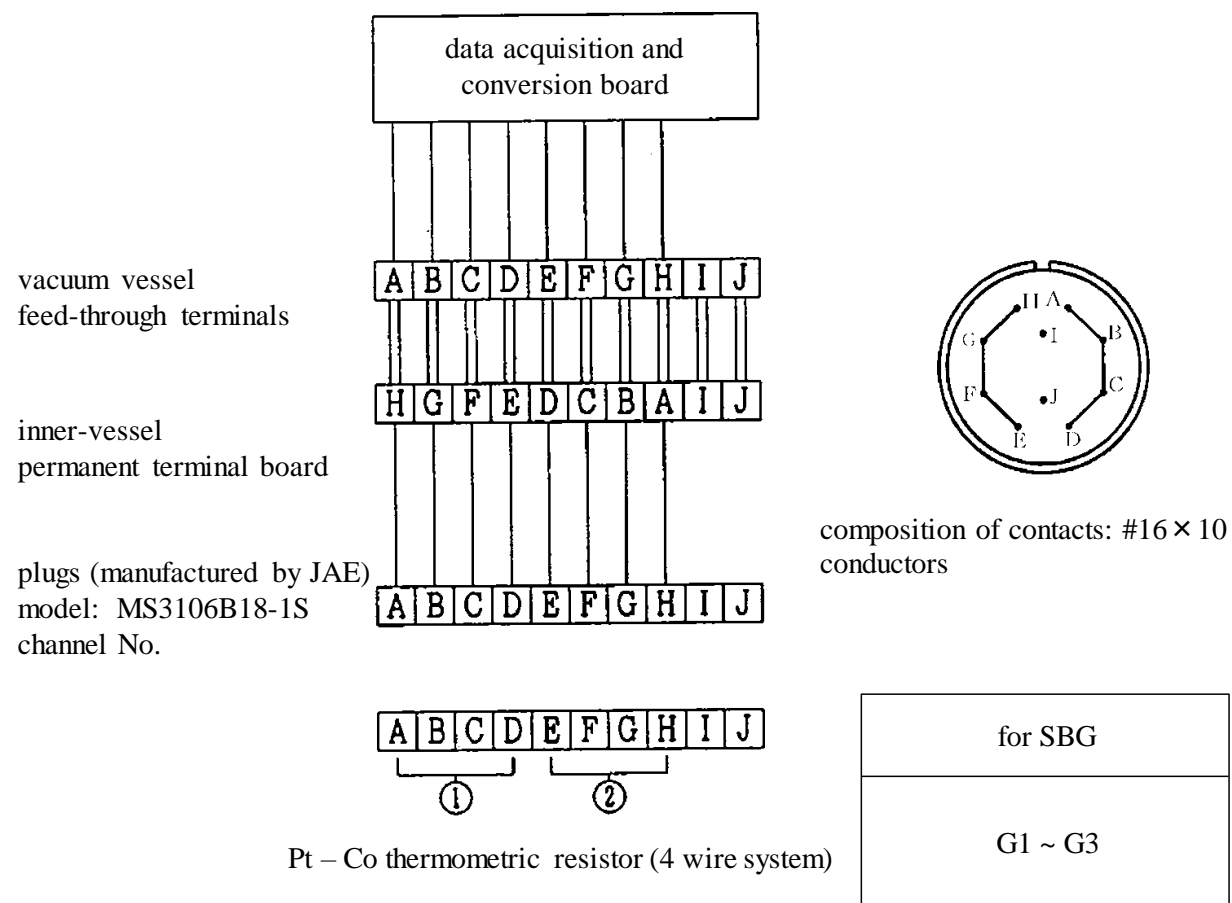


Figure 3-8 WBD Diagram of Temperature Sensors for TS



**Figure 3-9 WBD Diagram of SBG Temperature Measurement**

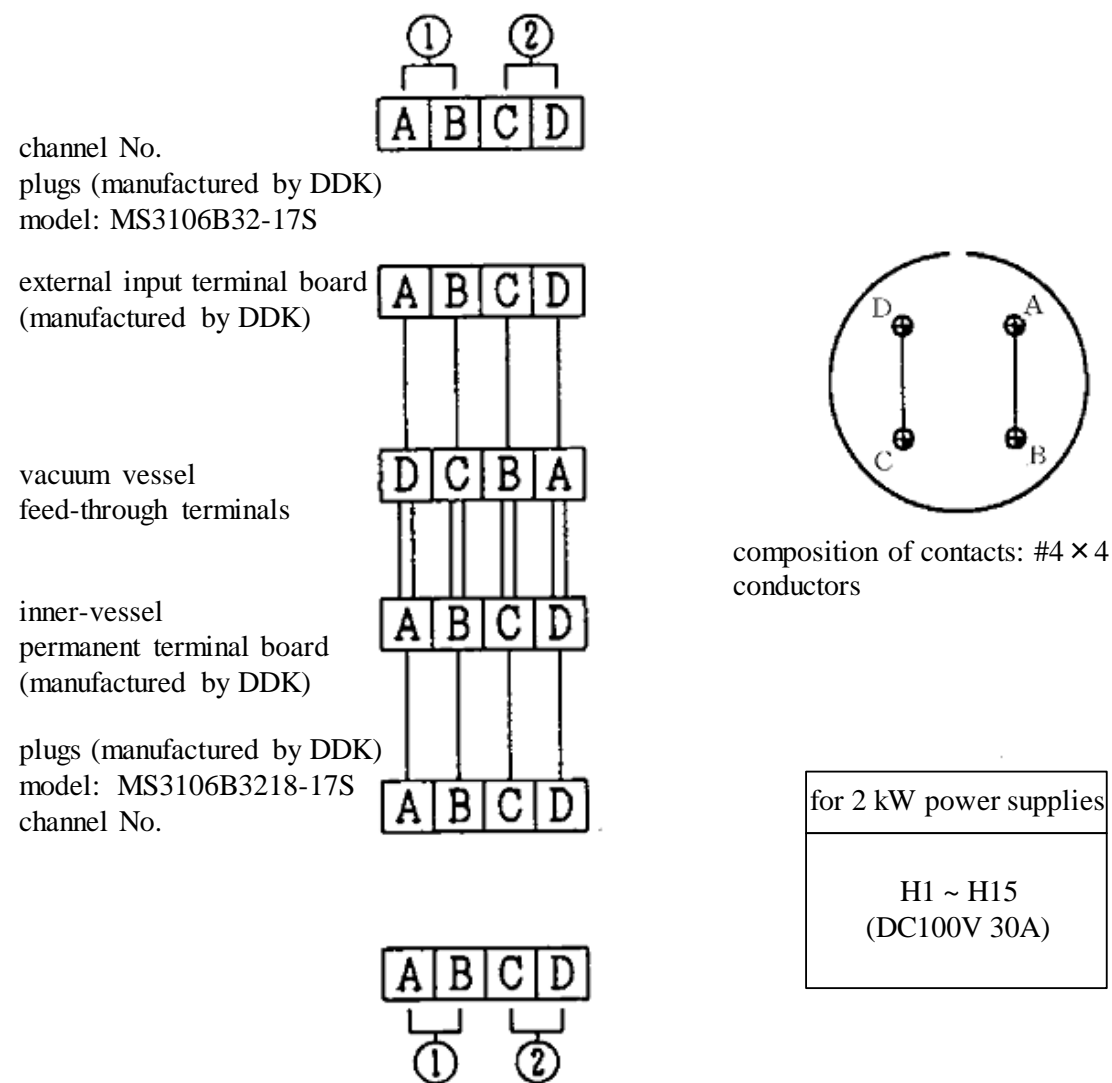


Figure 3-10 WBD Diagram of 2 kW IR Power Supply Rack

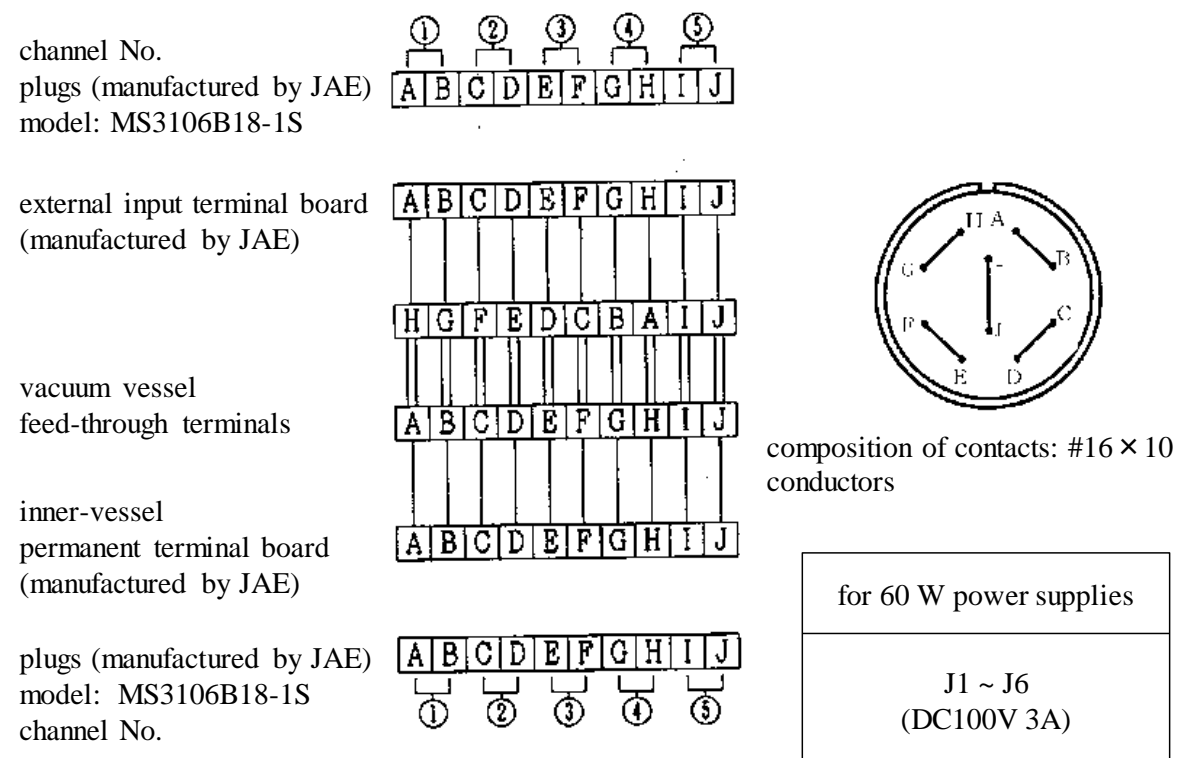


Figure 3-11 WBD Diagram of 60W IR Power Supply Rack



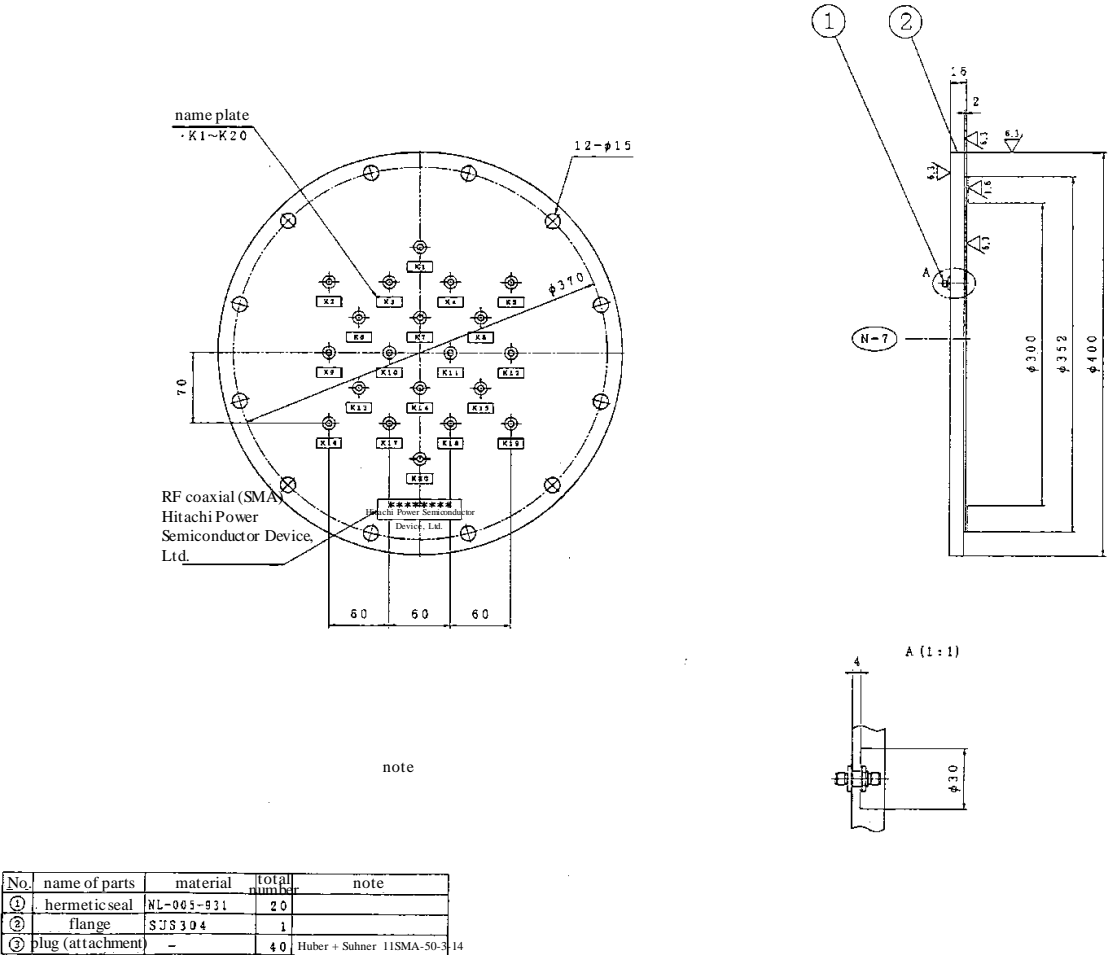
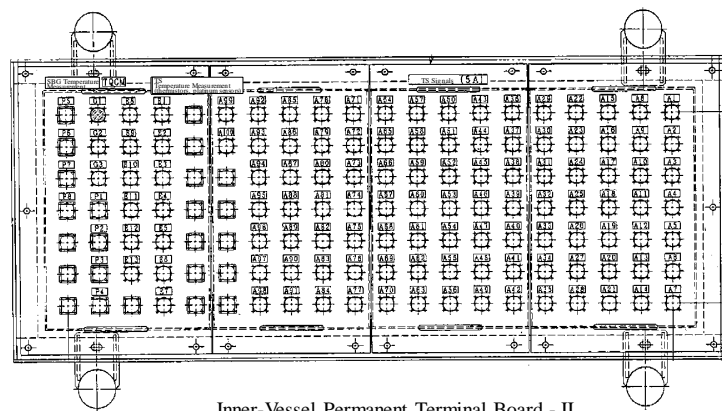
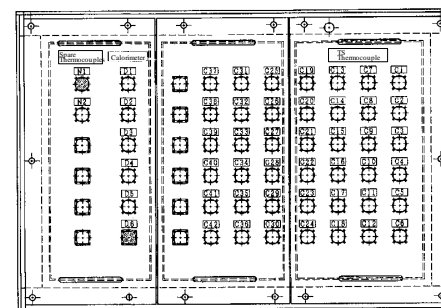


Figure 3-12 Feed-through Terminal for Coaxial Cables of TS

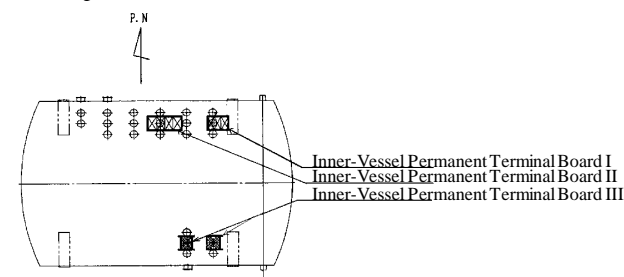


Inner-Vessel Permanent Terminal Board - II



Inner-Vessel Permanent Terminal Board - I

Mounting Positions of Permanent Terminal Boards



Note1) The hatched parts are used by the facility.

Note2) The connection positions for shield earth are shown below.

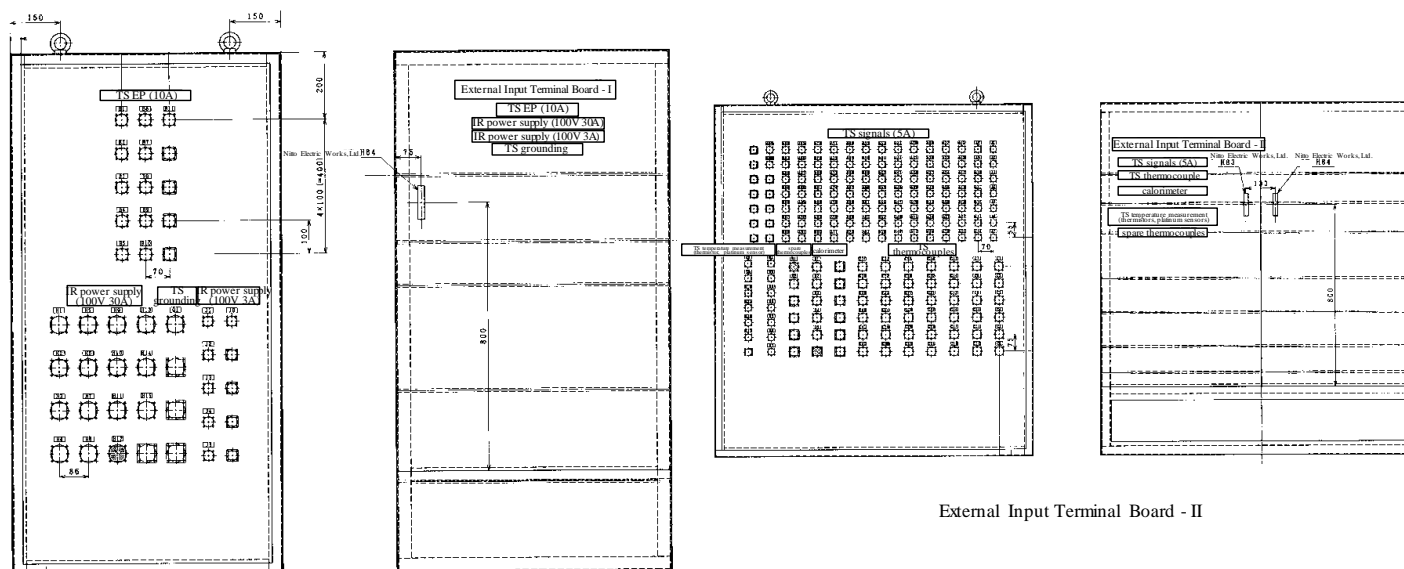
TS signal lines: J pins at E13 and G3

TS thermocouple lines: Z pins at C14, C28, C42

calorimeters and thermocouple spare lines: Z pin at N2

Inner-Vessel Permanent Terminal Board - III

**Figure 3-13 Inner-vessel Permanent Terminal Boards – I, II, III**



External Input Terminal Board - I

Note) The hatched parts are used by the facility.

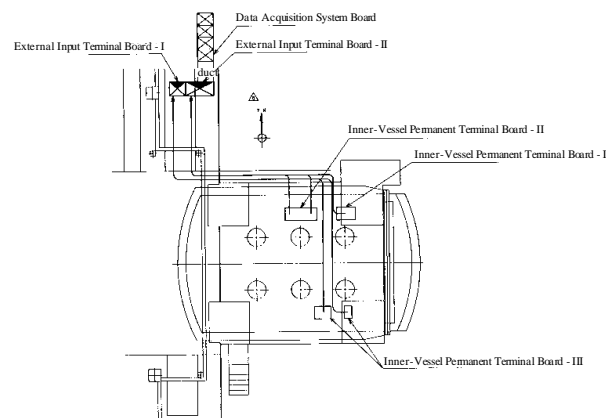


Figure 3-14 External Input Terminal Boards – I, II

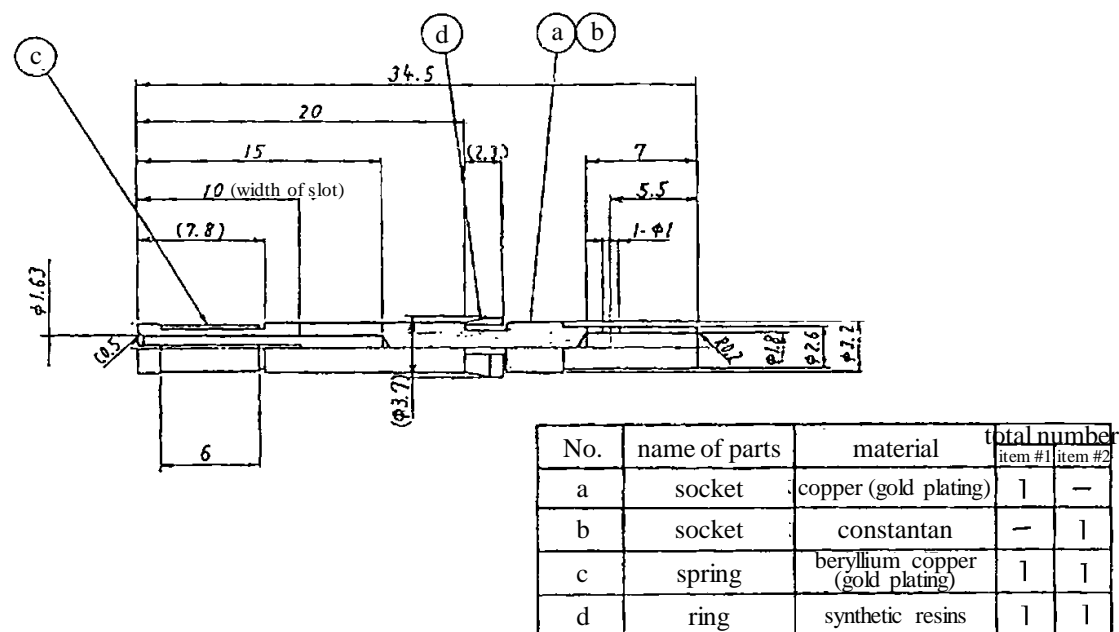


Figure 3-15 Thermocouple Socket Contact (manufactured by Hitachi Power Semiconductor Device, Ltd.)

### 3.3.1.3. Details of Hard Ports

There are hard ports as shown in Table 3-3 inside the vacuum vessel. Refer to Figure 3-16 for the hard ports (1) ~ (3) in the Table.

**Table 3-3 Table of Hard Ports**

No.	location	qty	bolt size <sup>*1</sup>	usage, etc.
(1)	TS supporting bench	45	M20	helisert insert attached
(2)	supporting bench with cooling panel	15	M20	helisert insert attached
(3)	body shroud	64	M12	
(4)	upper part of vacuum vessel	2		support for SBG
(5)	upper part of vacuum vessel			for optical bench maintenance <sup>*2</sup>
(6)	on optical bench	11	M16	guide for carrying in supporting bench <sup>*3</sup>
(7)	on work floor			<sup>*4</sup>

\*1 Bolts are to be prepared by users.

\*2 Even though “optical bench maintenance” is shown here as the nominal usage, the usage is not restricted and is at users’ choice.

\*3 While these screw holes are used for mounting the guide for carrying in a TS supporting bench, they can be used as hard ports otherwise.

\*4 By arranging attachment jigs, the rails on the work floor can be used.

The load capacities of the hard ports are shown below.

(1) TS supporting benches with and without cooling panel

Refer to Table 3-4 and Figure 3-17.

**Table 3-4 Load Capacities of Hard Ports**

No.	sign	name	load capacity <sup>*2</sup>
(1)	Fc	compressive load	37262.80 N (for vertical load)
(2)	Ft	tensile load	43146.4 kg (for vertical load)
(3)	Fx	X-direction load in horizontal plane	23534.4 N <sup>*1</sup>
(4)	Fy	Y-direction load in horizontal plane	23534.4 N <sup>*1</sup>
(5)	Mx	X-direction moment	1618 N·m
(6)	My	Y-direction moment	98.06 N·m

\*1 It denotes the load capacity for shearing, but does not guarantee the prevention of lateral slippage.

\*2 It denotes the load capacity for the TS supporting benches with and without a cooling panel, obtained based on safety factor  $f = 3$ .

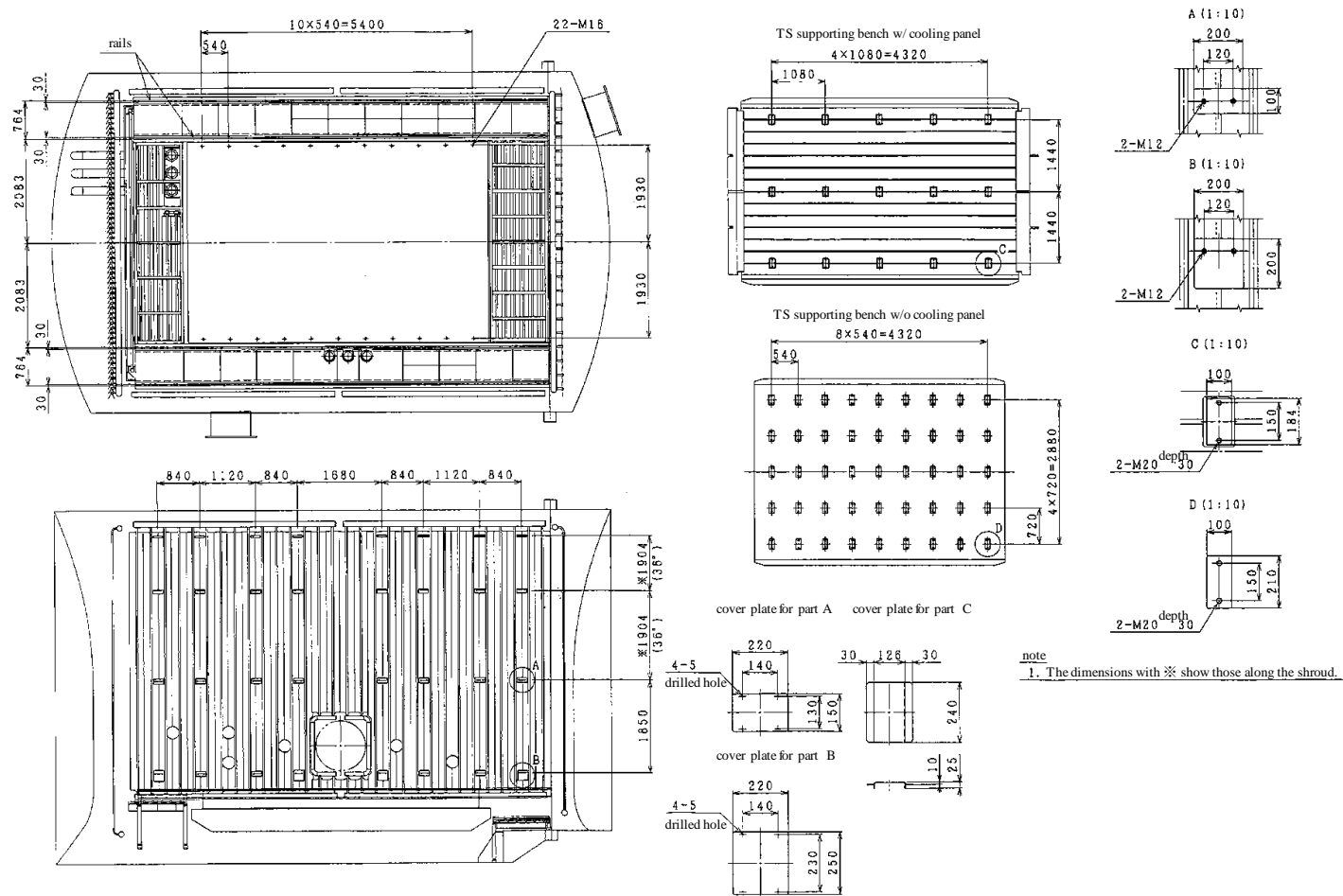
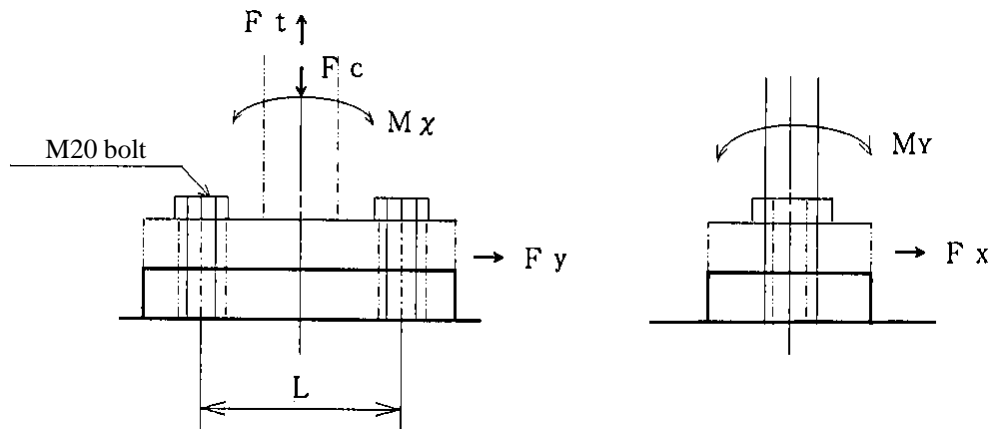


Figure 3-16 Configuration of Hard Ports



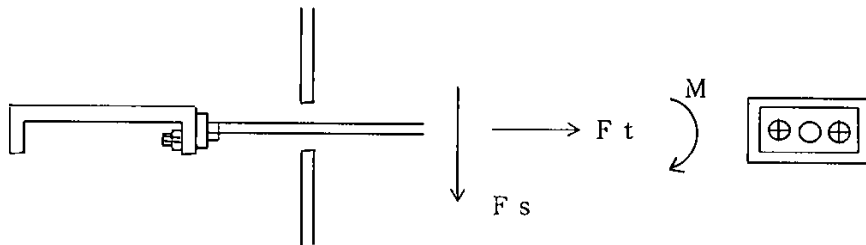
**Figure 3-17 Load Capacity of Supporting Benches with and without Cooling Panel**

(2) Body shroud

Refer to Table 3-5 and Figure 3-18.

**Table 3-5 Load Capacity of Body Shroud Hard Ports**

No.	sign	name	load capacity
(1)	Ft	tensile load	588.36N (for vertical load; the total weight per one shroud is to be under 600 kg.)
(2)	Fs	shearing load	294.18N (in the perpendicular direction to the axis; the total weight per one shroud is to be under 600 kg.)
(3)	M	moment	7.85 N · m (no more than 8 hard points are to be used per one shroud.)



**Figure 3-18 Load Capacity of Body Shroud Hard Port**

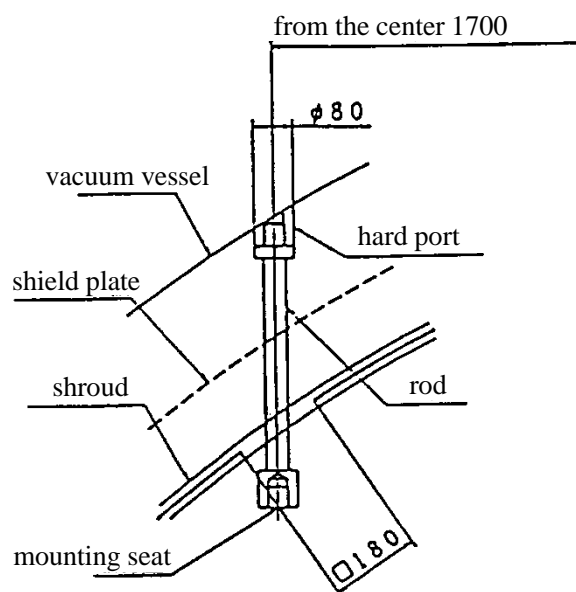
(3) Upper part of vacuum vessel (support for SBG) ··· Refer to Figure 3-30 and section 3.3.2.1.

200 kg/ hard port (for vertical load)

(4) Upper part of vacuum vessel (for optical bench maintenance)

Even though these hard ports are for “optical bench maintenance”, the usage is not restricted and is at users’ choice as long as the method below is followed.

These hard ports are attached to the upper side of the vacuum vessel and cannot be used as they are. As shown in Figure 3-19, they require a rod to be inserted whose user-side mounting section is extended into the shroud, and users are to place a necessary mounting seat at the end of it.



**Figure 3-19 Schematic View of Hard Port for Optical Bench Maintenance**

Pay attention to the following matters when inserting a rod.

- (a) Load capacity of hard port: 4,500 kg (for vertical load)
- (b) Opening dimensions of the shroud:  $180 \times 180$

That is, the maximum dimensions of the rod are to be manufactured the way they do not exceed the limit of enabling it to go through the feed-through hole. Furthermore, there may be manufacture errors between the vacuum vessel and the shroud, and therefore a rod is to be manufactured with its shroud-feed-through part in as minimized dimensions as possible.

- (c) Rod configuration: Be sure to place a mounting seat at the end of a rod to prevent seizure at the thread part when bending load acts on the rod; that way, the thread part can be protected from the direct impact of bending load.
  - (d) Prevention of seizure: The hard ports being SUS 304 products, a rod made of stainless steel requires caution not to cause seizure at the thread parts. When using a seizure-preventing agent, make sure to choose one that does not have bad influence on a TS or the vacuum vessel with its outgas, etc.
- (5) On optical bench
- Refer to Table 3-6.

**Table 3-6 Load Capacity of Hard Ports on Optical Bench**

No.	sign	name	load capacity
(1)	Ft	tensile load	13728.4N (vertical direction)
(2)	M	moment	23.53 N · m



## (6) Notes

As mentioned in section 2.2.6, the chamber foundations are isolated from the seismic slab which has an optical bench mounted upon it. When performing an optical property confirmation test that takes account of micro vibration, make sure to prevent the vibration from the vacuum vessel not to be transmitted via hard ports. (ex. by tying the tie-wrap that fixes a TS to the body shroud.)

**3.3.1.4. Thermal I/F on TS Supporting Bench**

## (1) Supporting bench without cooling panel

The TS supporting bench without a cooling panel cannot be cooled because it is not equipped with an LN<sub>2</sub> circulating structure. Meanwhile, the bench has heaters attached to it, which heat the bench during a test. In other words, it is the balance between cooling by radiation cooling and heating with the heaters that determines the temperature of the bench. Keep that point in mind when using the TS supporting bench without a cooling panel.

## (2) Supporting bench with cooling panel

The TS supporting bench with a cooling panel can be deliberately cooled with its attached panel through which LN<sub>2</sub> circulates. The hard ports where a TS or a jig is mounted are thermally insulated from the parts where LN<sub>2</sub> runs through. That is, the hard ports are cooled only by radiation cooling. Meanwhile, the bench is heated by a heater as with the supporting bench without a cooling panel. Therefore, enough level of heat insulation is necessary when mounting a TS or a jig.

**3.3.1.5. TS Cooling/Heating I/F**

## (1) General description

When a jig is manufactured for controlling temperature from the TS side, there are flanges available in the vacuum vessel that supply LN<sub>2</sub> and GN<sub>2</sub> for partially cooling and heating a TS, respectively. Refer to Figure 3-20 regarding to ports for TSs. Some of those flanges are for cooling the work floor and others are dedicated for a supporting bench with a cooling panel (cf. Table 3-7.)

**Table 3-7 List of TS LN<sub>2</sub> Lines**

No.	line No.	location	application purpose
(1)	LN-3145-20-3HV	body	cooling work floor / TS
(2)	LN-3146-20-3HV	head	cooling work floor
(3)	LN-3147-20-3HV	head	cooling TS
(4)	LN-3148-20-3HV	body	cooling TS
(5)	LN-3149-20-3HV	body	cooling TS

**Table 3-8 General Description of TS Cooling/Heating I/F**

LN <sub>2</sub> line for partial cooling of TS	GN <sub>2</sub> line for partial heating of TS
<ul style="list-style-type: none"> <li>• 20A × 5 lines</li> <li>• N-32 nozzle (cf. Figure 3-20)</li> </ul> <p>CASE.1 shroud on supporting bench lower plane being not used (4 lines are available for the TS side)</p> <p>head (2 lines): for work floor – 1 line for TS – 1 line</p> <p>body (3 lines): for TS – 3 lines</p> <p>CASE.2 shroud on supporting bench lower plane being cooled (3 lines are available for test item side)</p> <p>head (2 lines): for work floor / shroud on lower plane of supporting bench – 1 line for TS – 1 line</p> <p>body (3 lines): for work floor / shroud on lower plane of supporting bench – 1 line for TS – 2 lines</p>	<ul style="list-style-type: none"> <li>• 150A × 3 lines</li> <li>• N-24 nozzle (Figure 3-20)</li> </ul> <p>supply temperature: normal temperature ~ 60°C</p> <p>supply pressure: 0.098 ~ 0.148 MPa</p>

(2) Feed rate of LN<sub>2</sub> and GN<sub>2</sub>(a) The supply conditions of the LN<sub>2</sub> supply line are shown in Table 3-9 below.**Table 3-9 Rough Levels of LN<sub>2</sub> Feed Rate and Valve Opening Percentage**

feed rate (Nm <sup>3</sup> /h)	50	60	70
valve opening percentage (%)	24	27	31

The gasification rate is 35%, and the supply pressure is about 0.098 ~ 0.148 MPa.

(b) As for the GN<sub>2</sub> supply line, the feed rate is 30 Nm<sup>3</sup>/h and the supply pressure is about 0.098 ~ 0.158 MPa for the valve opening percentage of 46%.

(3) LN<sub>2</sub> supply ports

The LN<sub>2</sub> supply ports are connected via Grayloc Connectors (cf. Figure 3-21, tightening torque 260 kg·cm.) Users are to pay attention to the following matters when laying pipes via the Grayloc Connectors by themselves. (The same cautions are required when laying SBG systems explained in section 3.3.2.1.)

(a) The hubs and seal rings shown in Figure 3-21 are to be prepared by users.

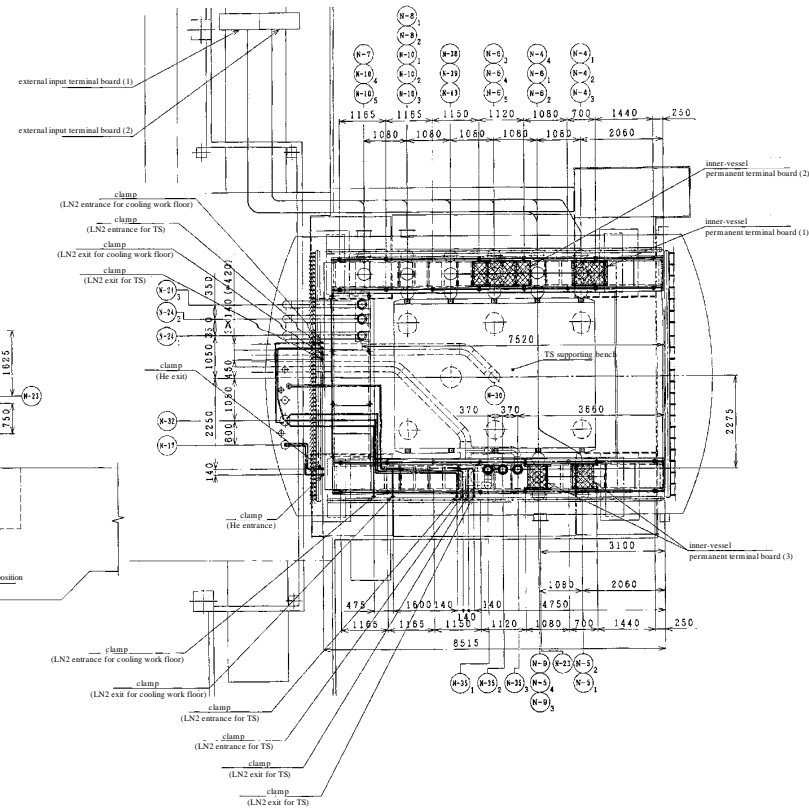
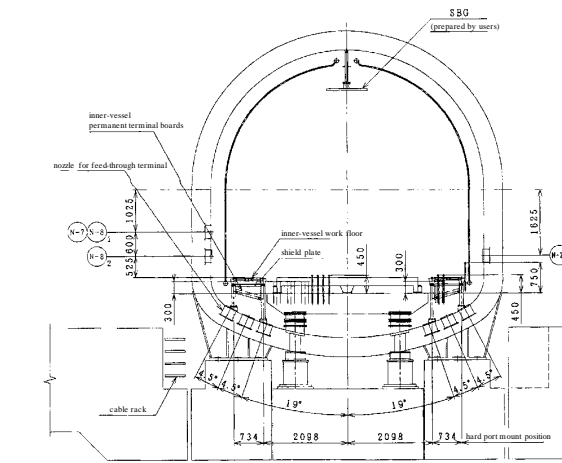
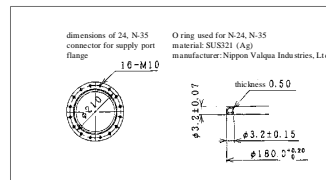
(b) Since it normally takes 3 months to have the hubs of Grayloc Connectors procured (seal rings also take long for procurement), users are to confirm with the manufacturer (NIKKISO CO., LTD.) for the procurement lead time when they plan the manufacturing process for laying pipes.

(4) GN<sub>2</sub> supply ports for heating TS

There are three GN<sub>2</sub> supply ports for heating a TS in this facility with their inlets at the chamber head and outlets on the body (cf. Figure 3-20.) The ports have a 150A special VG flange that adopts a metal tubal O ring. Therefore, users are to pay attention to the following matters when laying pipes by themselves.

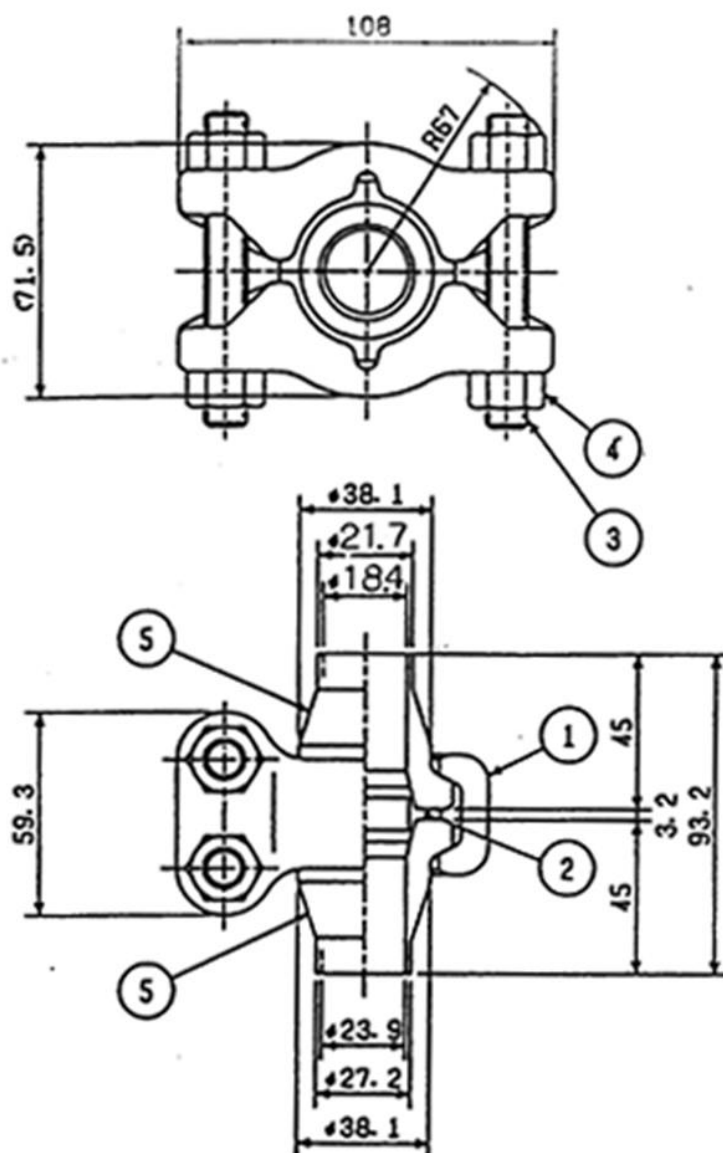
- (a) The metal tubal O rings (cf. Figure 3-20) and connection pipes are to be prepared by users.
- (b) Since it normally takes one month to have metal tubal O rings delivered, it is recommended that they be ready beforehand. Also, refer to Figure 3-22 which depicts how the flanges of GN<sub>2</sub> nozzles are manufactured, when planning for laying pipes.

N-24 TS heating GN2 entrance
N-35 TS heating GN2 exit



name	nominal quantity	format	name	note
N-39	300A	1	J1S Vg	for facility, SBG temperature (incl. TQCM)
N-38	300A	1	J1S Vg	for facility & shroud temperature measurement
N-35	150A	3	J1S SVG	GN2 exit
N-32	20A	5	clamp	for partial cooling of TS (IR gauge)
N-32	20A	5	clamp	for partial cooling of TS (IR gauge)
N-30	250A	1	J1S Vg	GN2 exit
N-24	150A	3	J1S SVG	GN2 entrance
N-23	300A	1	J1S Vg	current inlet terminal
N-17	20A	1	clamp	He piping
N-17	20A	1	clamp	He piping
N-10	300A	5	J1S Vg	vane nozzles
N-9	300A	1	J1S Vg	current inlet terminal (200V/10A)
N-8	300A	2	J1S Vg	for waveguides
N-7	300A	1	J1S Vg	high frequency output signals (coaxial)
N-6	300A	5	J1S Vg	current inlet terminal (100V/5A)
N-5	300A	4	J1S Vg	current inlet terminal
N-4	300A	4	J1S Vg	for CC thermocouples (incl. calorimeters, spurs)
sign	nominal quantity	format	name	note

### Figure 3-20 System Diagram of Ports for TS



6				
5	welded hub	SUSF304	18 sets	1GR8 (GL-32-4815)
4	nut	SA194-Gr8	36 sets	M12x1.75
3	bolt	SA193-88	18 sets	M12x1.75xL89
2	seal ring	17-4PH PT-24	18	NO.8
1	clamp	SA182-F304	18 sets	1GR8
item	name	material	quant	description

Figure 3-21 Diagram of Grayloc Connector for LN<sub>2</sub>

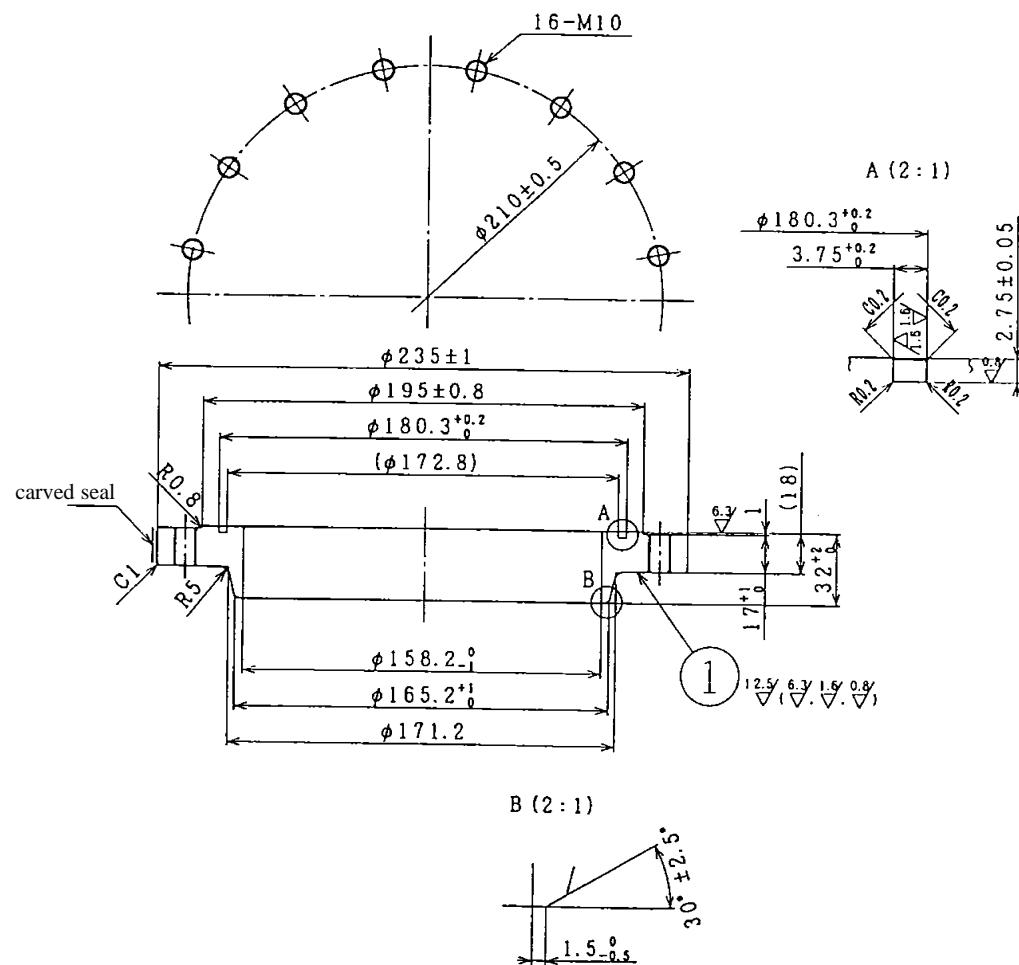


Figure 3-22 Diagram of Supply Port Flange for GN<sub>2</sub>

### 3.3.1.6. I/F on TS Installation Device

A typical procedure of carrying in a TS into the vacuum vessel is shown in Figure 3-23. The operation of the installation device is basically executed by the facility side.

The assemble work for a TS is performed on the TS installation dolly.

The maximum load capacities on the moving dolly and the TS installation dolly are presented in section 2.2.2. Their load capacities vary when the CG of a loaded item deviates from their centers. Therefore, the CG of a loaded item is to be aligned as close as possible to the center of the TS installation dolly. In case the total weight of a TS and a jig exceeds 2,000 kg while their CGs deviate from the center of the TS installation dolly, contact the facility operation company in advance.

### 3.3.1.7. Optical Window and Alignment Window

There are three sets of optical window mounting flanges and nineteen sets of alignment windows installed in the vacuum vessel. For their mounting I/F positions, refer to Figure 3-3.

#### (1) Optical window flange

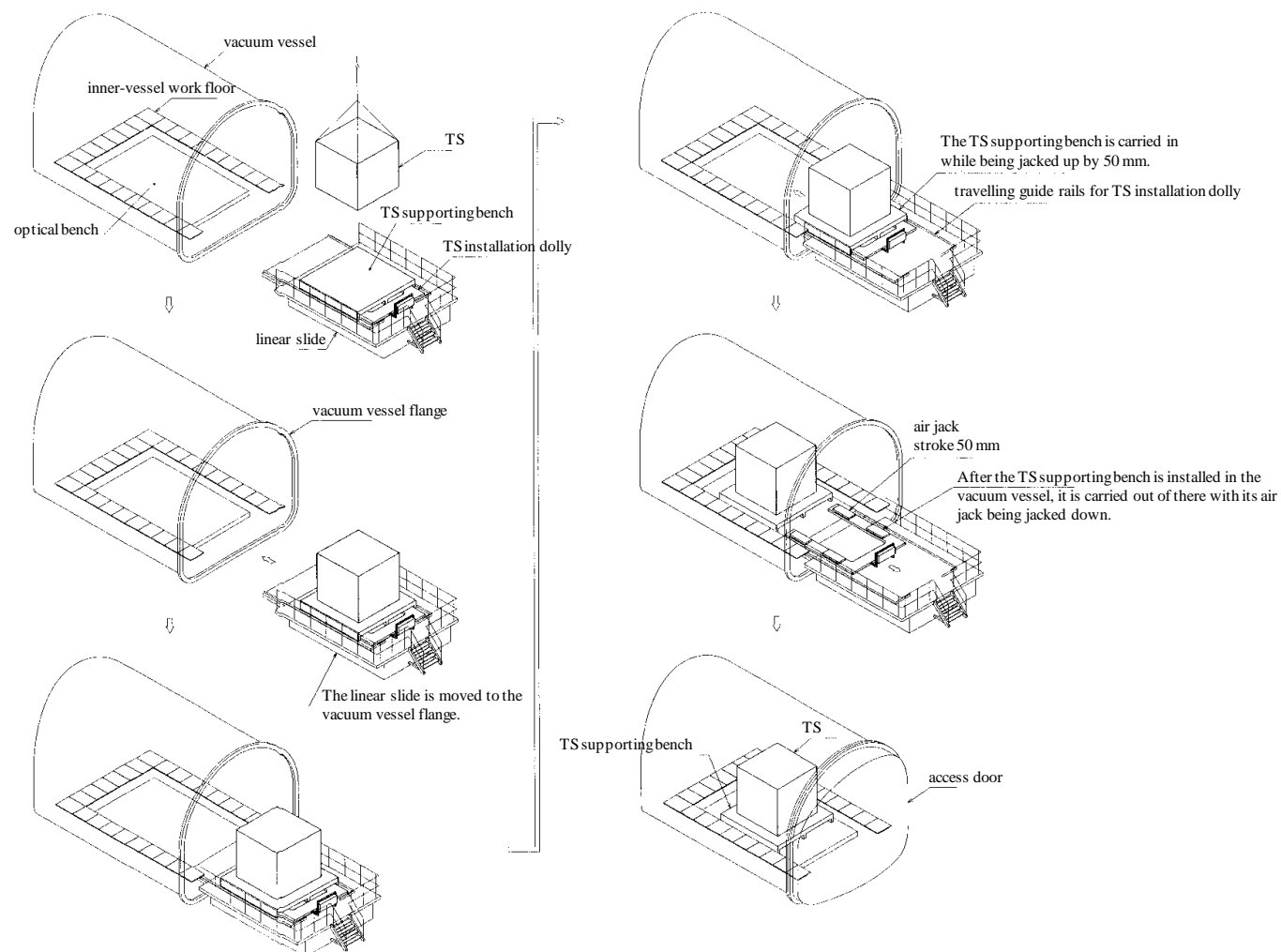
The structure of an optical window flange is shown in Figure 3-24. Users are to prepare optical glass and flanges referring to this Figure when using the optical window. The surface roughness on the contact face to the facility-side flange is to be 50  $\mu\text{m}$  or less. An optical window flange has an adjustment mechanism which allows the controlling of the slant that can be up to  $5.067 \times 10^{-4}$  rad after vacuuming in the vacuum vessel down to 1 minute ( $2.9 \times 10^{-4}$  rad.) The facility possesses an optical window and mounting flanges that used to be applied in the old radiometer space chamber. Their specifications and drawings are shown in Figure 3-25.

#### (2) Alignment window

There are alignment windows for the purpose of alignment measurement on a TS. Besides the permanently-equipped alignment window glass which is made of tempered glass, there are eight (4 concentric-type and another 4 eccentric-type) alignment windows ( $\phi 96$ ) made of glass (BK7) with a highly-accurate transmission wave front, which can replace the permanently-equipped alignment window prior to the execution of a test to satisfy test requirements. Moreover, a theodolite and an ITV device (portable) shown in section 2.2.8 can be set on the alignment window.

When removing the tempered glass from the alignment window, lay air packing, etc., by way of caution to prevent damage on the tempered glass in case it is dropped.

The heights from the TS supporting bench to the optical window and to the center of the alignment window are shown in Figure 3-26.



**Figure 3-23 Procedure of TS Installation**



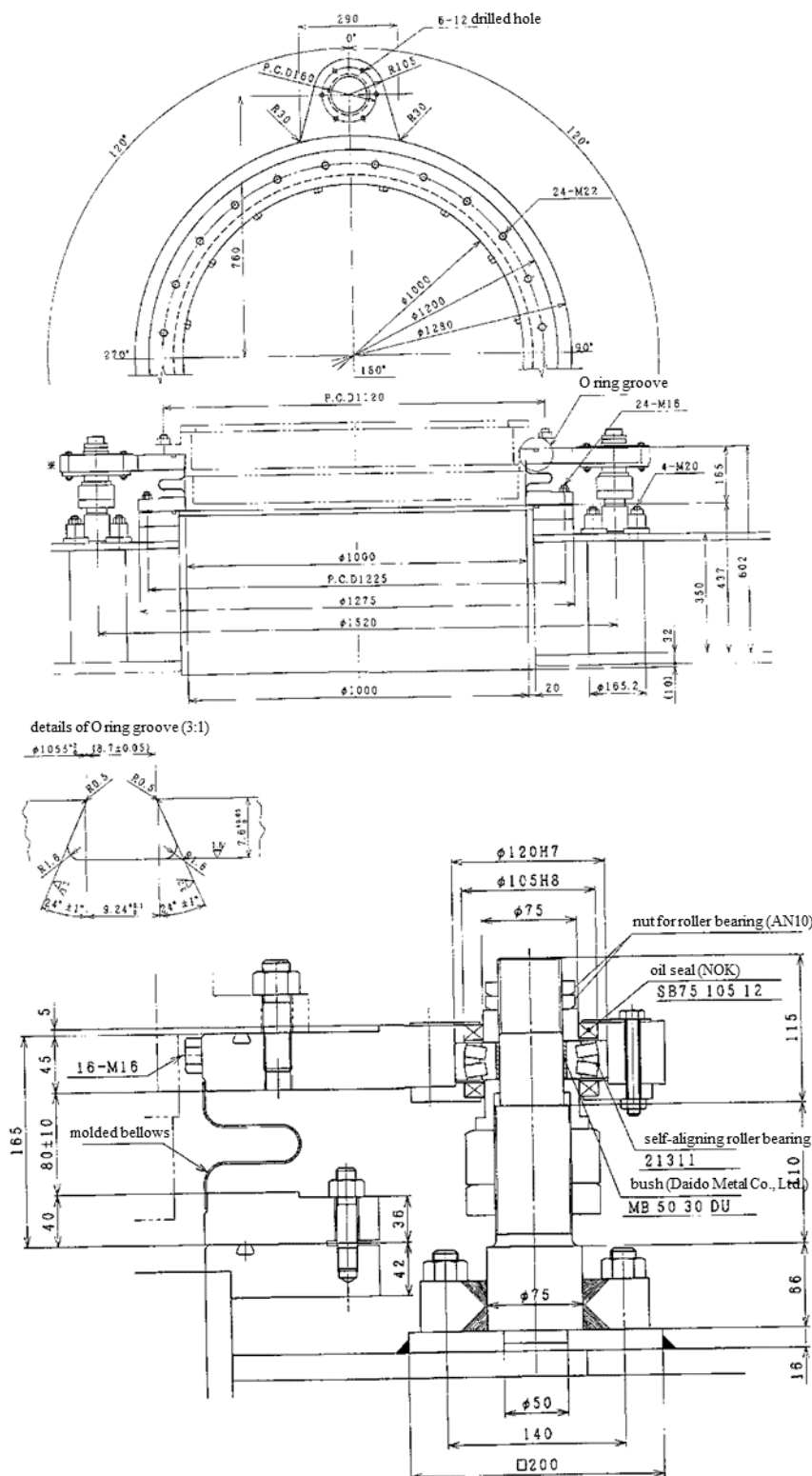


Figure 3-24 Diagram of Optical Window Mounting Flange

- note) 1. The accuracy of the transmission wave front on the  $\phi 50$  in the effective diameter  $\phi 96$  is within  $0.1 \mu\text{m}$ .  
 2. The uniformity of material is  $\Delta n = 5 \times 10^{-6}$  or less.

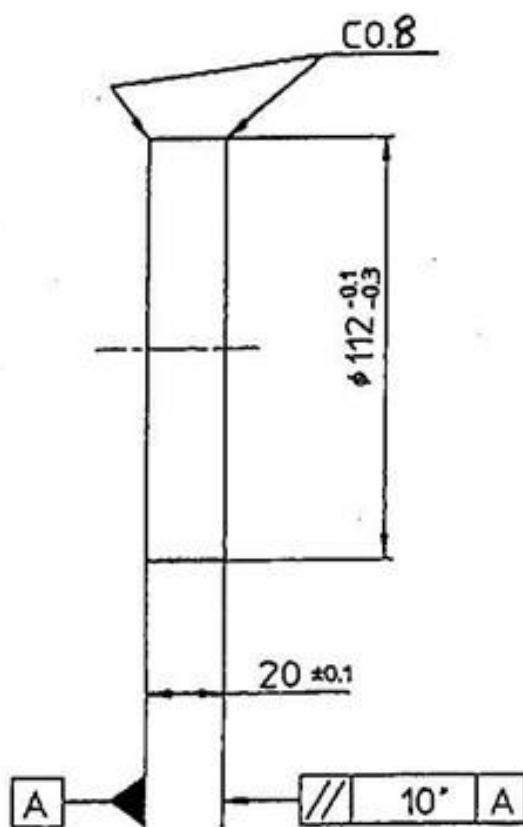
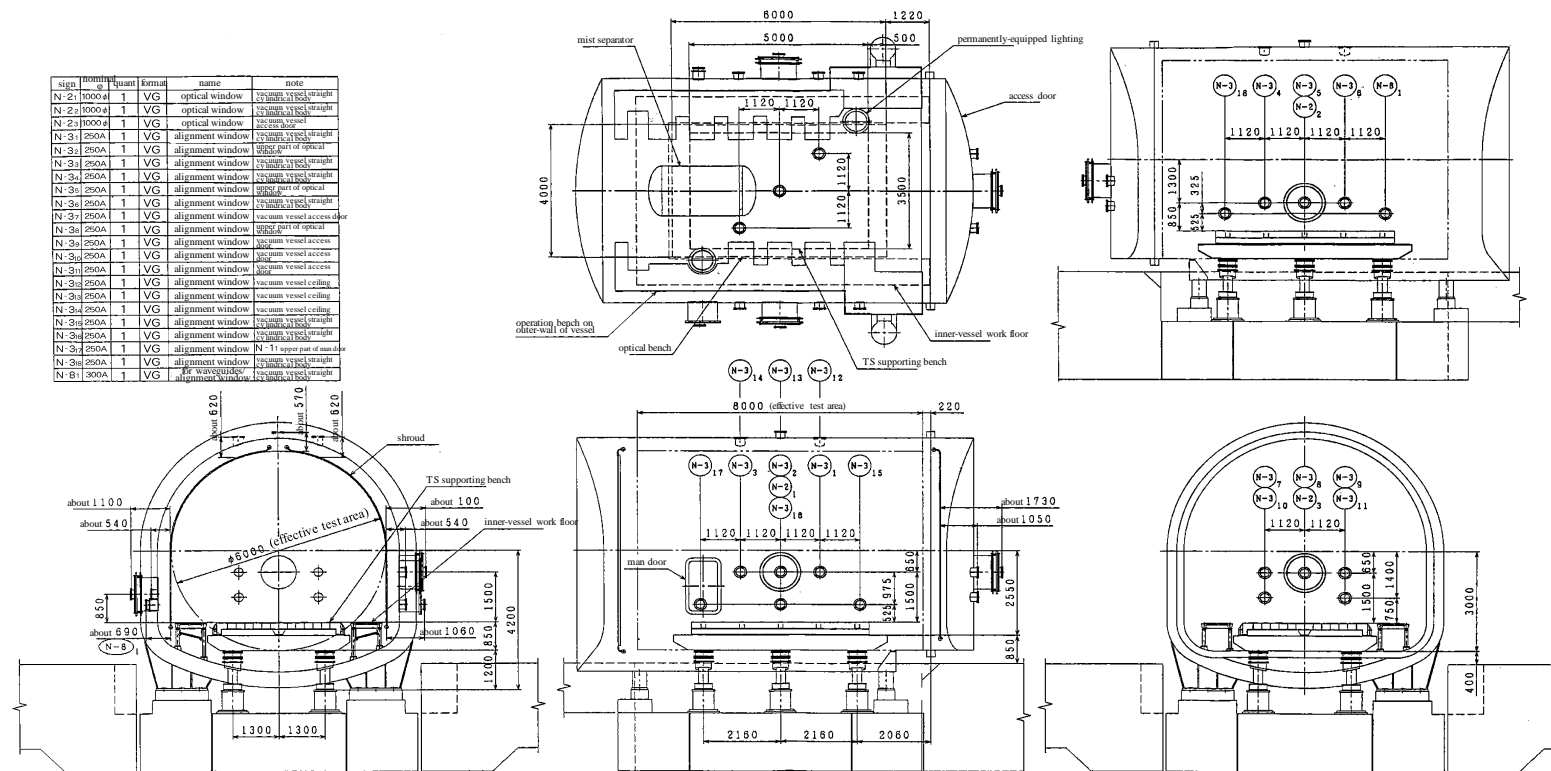


Figure 3-25 Optical Window



**Figure 3-26 Mounting Positions of Optical Windows**

### 3.3.1.8. Others (Inner-Vessel Work Floor, Movable Operation Bench, Working Platform)

(1) Work floors inside vacuum vessel (cf. Figure 3-27)

The work floors inside the vessel are used for the work to be performed on them after carrying in a TS into the vacuum vessel. The load capacity of the work floor is 150 kg / piece.

(2) Movable operation bench (cf. Figure 3-28)

There is a movable operation bench for accessing the man door and the optical window. It is available to users when necessary.

(3) Working platform (cf. Figure 3-29)

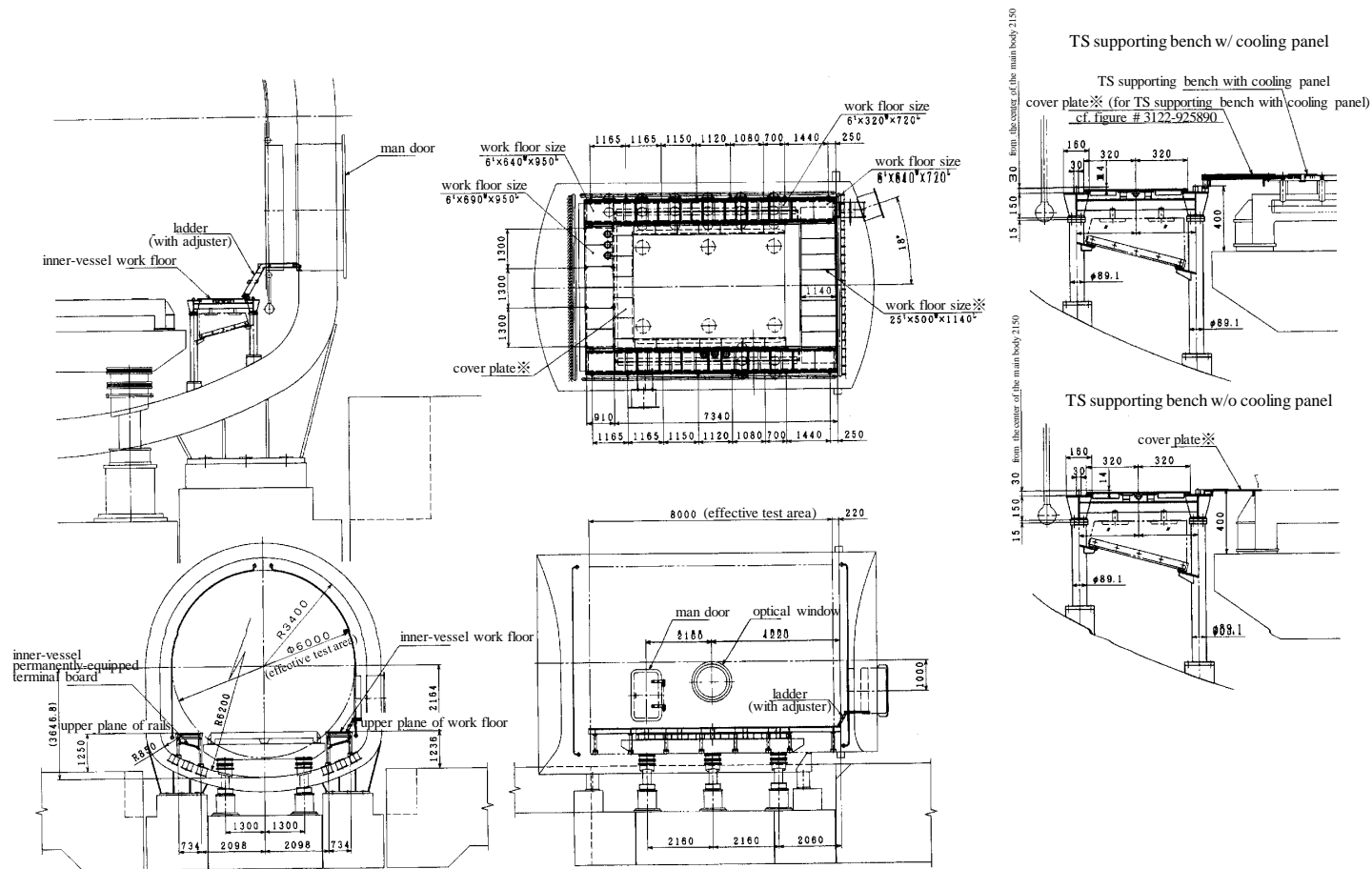
There is a working platform for mounting an SBG or accessing the upper part of a TS in the vacuum vessel. The maximum load mass and usable dimensions are shown below. The assembly and operation of the platform are to be executed by users.

(a) Max. load mass

① Working platform floor	150 kg
② Working platform flip-up floor	100 kg
③ Working platform ladder	100 kg

(b) Usable dimensions

① Max. usable height	3,505 mm
② Storage height	1,705 mm



**Figure 3-27 Work Floors inside Vacuum Vessel**

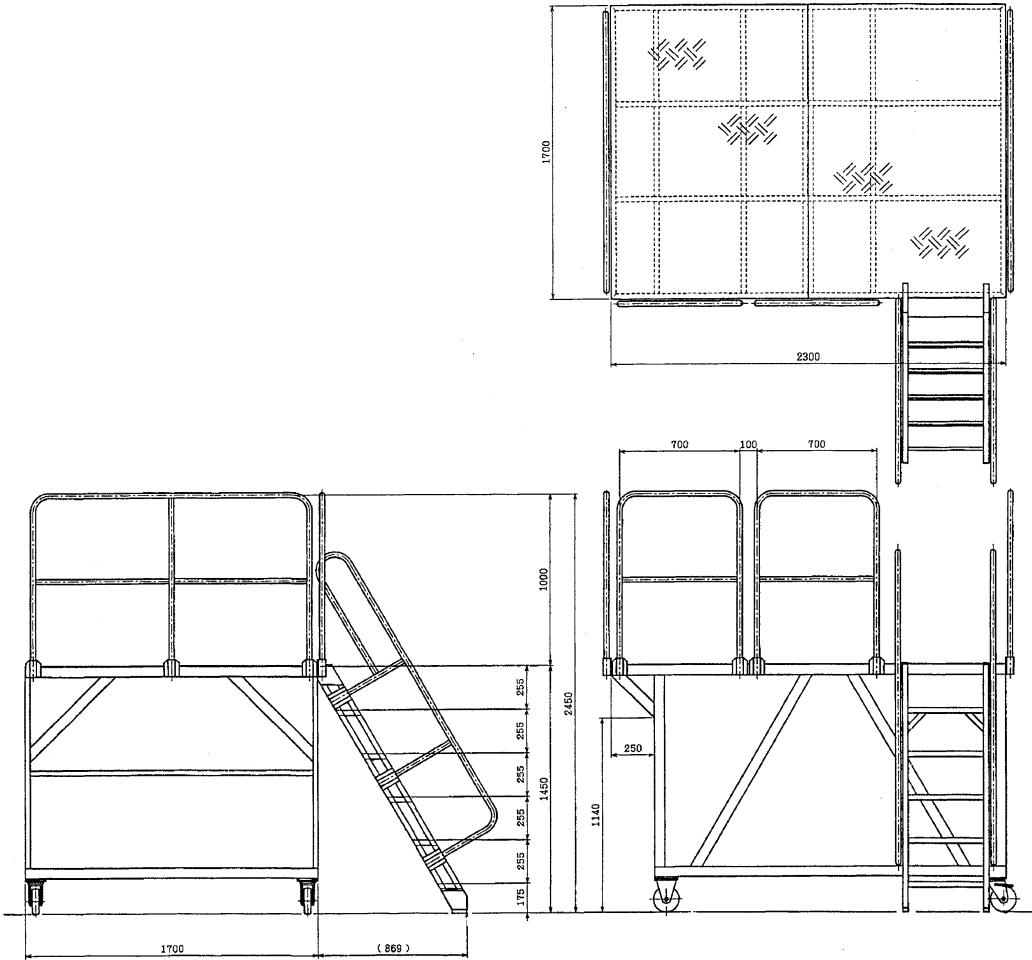


Figure 3-28 Movable Operation Bench

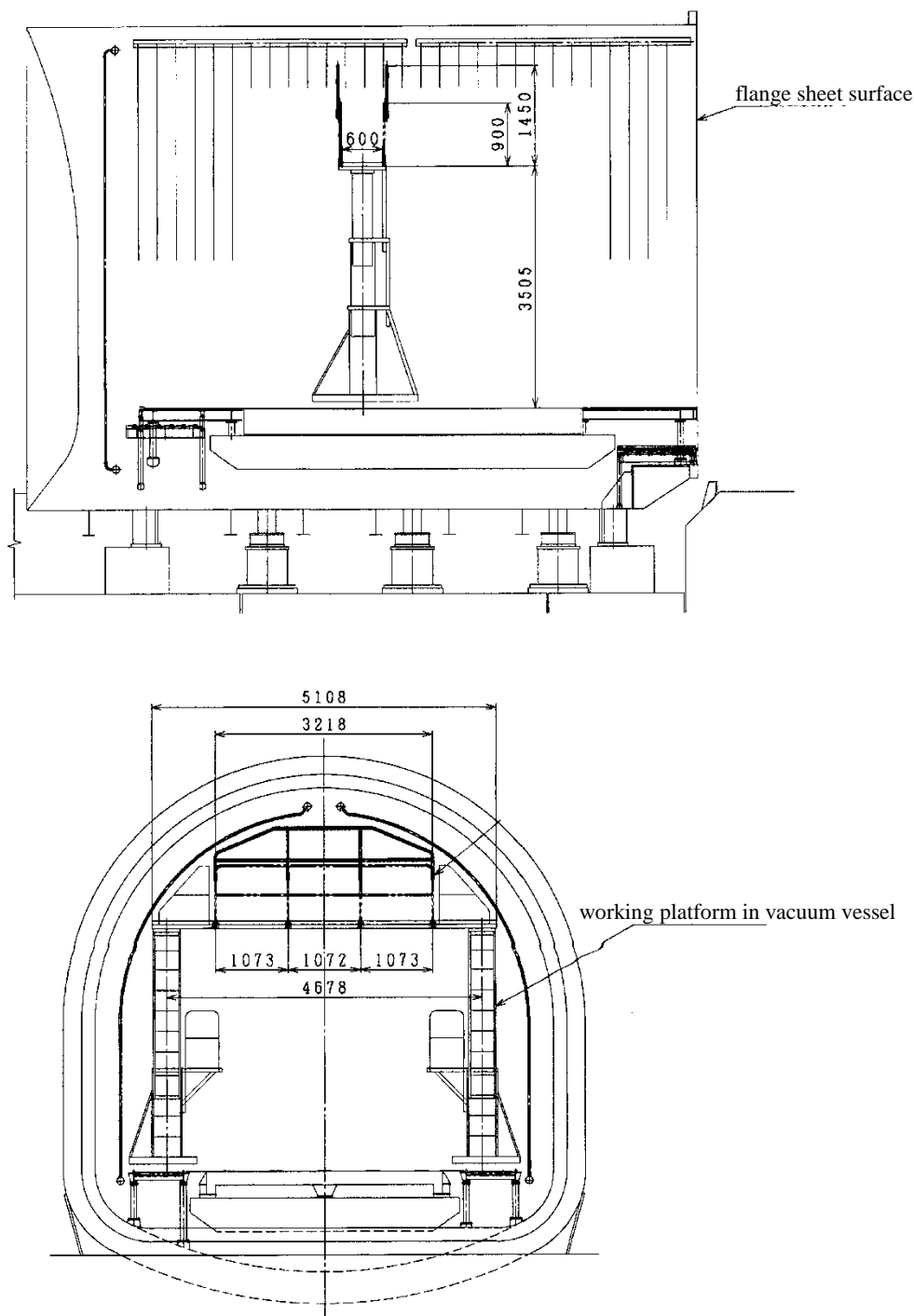


Figure 3-29 Working Platform

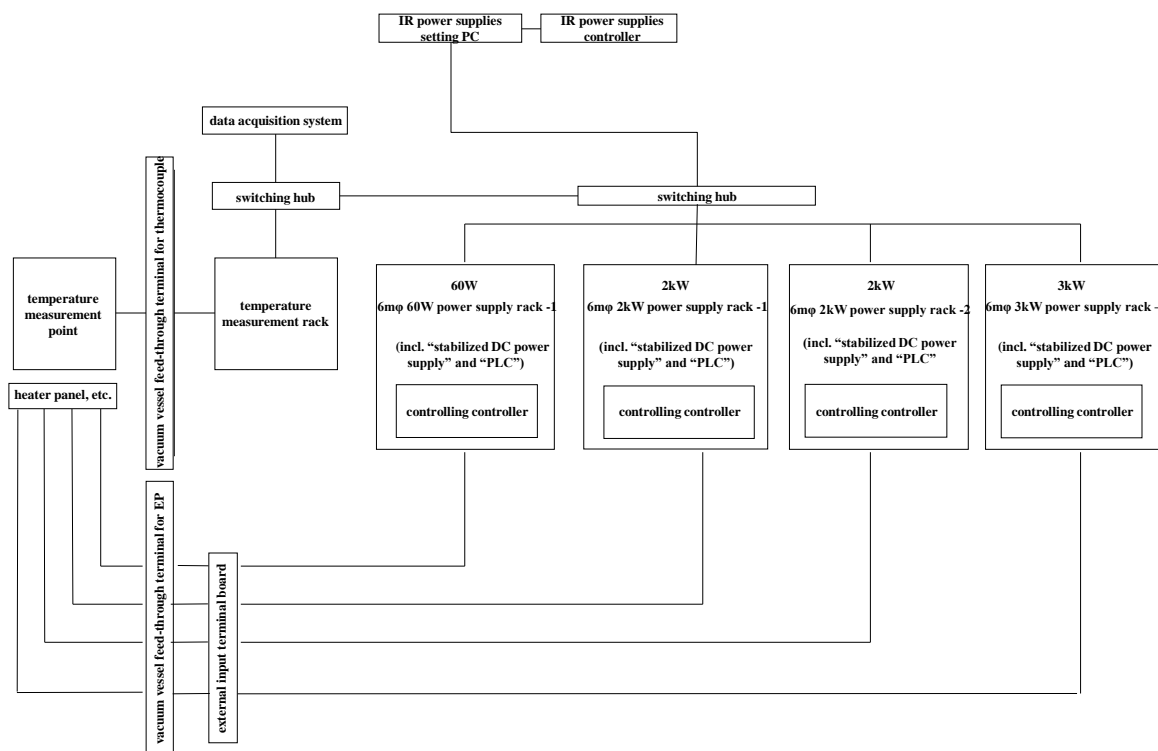
### 3.3.2. Power Supplies for Heat Sources

#### (1) Composition of components

The composition of primary components in the power supplies for heat sources and a system diagram of the holistic system are shown in Table 3-11 and Figure 3-33, respectively. Also, an inter-connection diagram of power supply racks is shown in Figure 3-34.

**Table 3-11 Composition of Primary Components in Power Supplies for Heat Sources**

name of component	model #, etc.	qty	note
(1) controller	HF-W7500 / model 30LX	1	
(2) setting PC	Endeavor Pro7500	1	
(3) power supplies for heat sources			qty of power supplies:
(a) 6m $\phi$ 60W power supply rack -1	by AES/ Matsusada Precision Inc.	1 set	25
(b) 6m $\phi$ 2 kW power supply rack -1	by AES/ Matsusada Precision Inc.	1 set	10
(c) 6m $\phi$ 2 kW power supply rack -2	by AES/ Matsusada Precision Inc.	1 set	10
(d) 6m $\phi$ 3 kW power supply rack -1	by AES/ Matsusada Precision Inc.	1 set	10



**Figure 3-33 System Diagram of Holistic System**



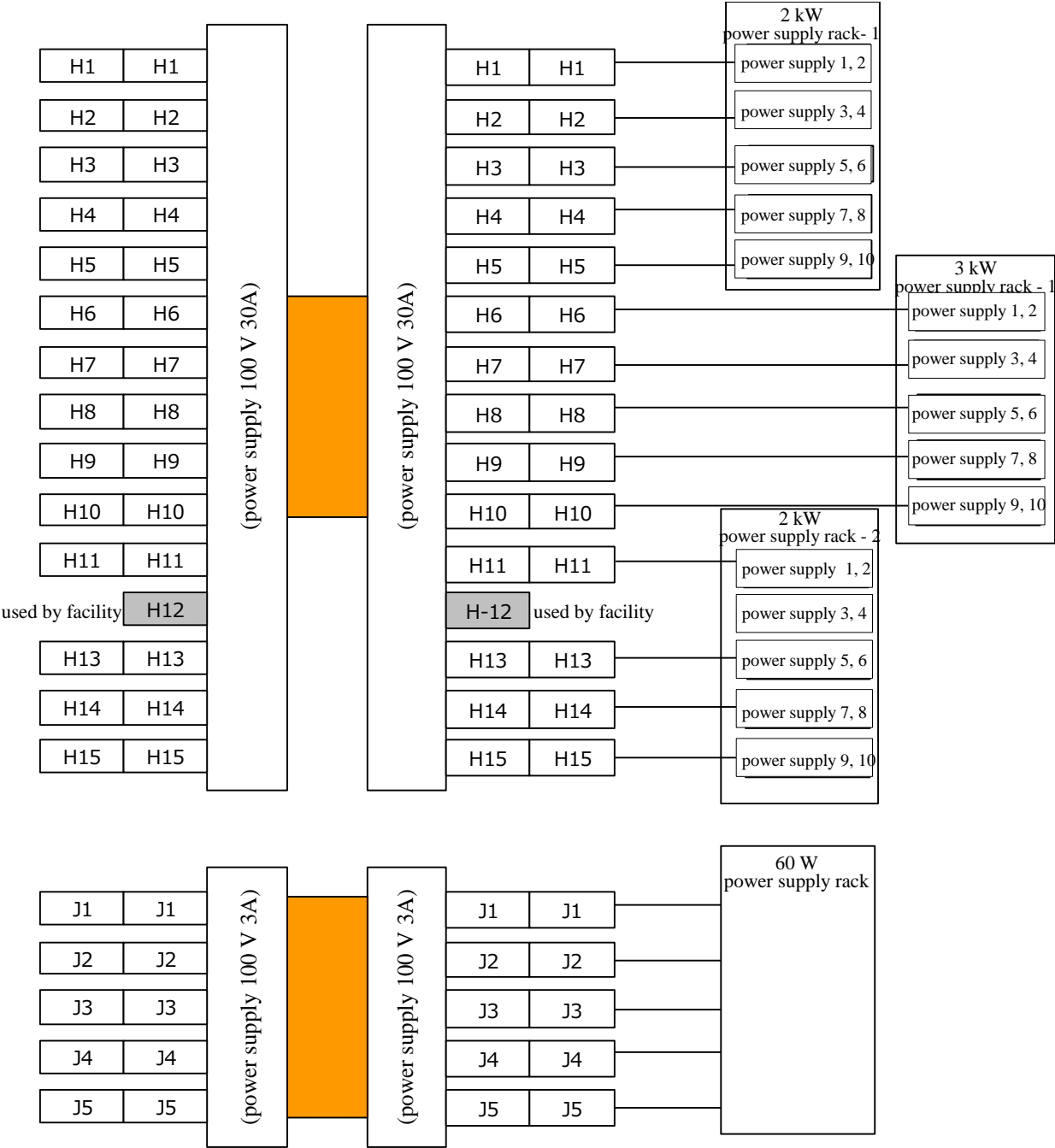


Figure 3-34 System Diagram of Power Supply Racks for IR Heaters

### 3.3.3. Control Mode

#### 3.3.3.1. Control System

- (1) Control system of this power supply rack

The control system of power supply racks is shown in the following Table 3-12.

**Table 3-12 Control System of Power Supply Rack**

control	temperature control in broad definition	PID control (=temperature control)	based on temperature at one point
			based on averaged temperature among multiple points
			based on temperature difference at one point
			based on averaged temperature difference among multiple points
		ON/OFF control	
	constant power control	with load resistance value input	
		without load resistance value input	
	manual voltage output control		
	local control		

- (2) Grouping of multiple power supplies

Power supplies can be grouped for simultaneous operation. The grouping is possible only for the power supplies on the same rack. The grouping of power supplies for simultaneous controlling can only be applied to PID control and ON/OFF control.

### 3.3.3.2. Temperature Control

PID control denotes the controlling of temperature by using the PID commands sent from a PLC. The control methods and descriptions of PID control are shown in Table 3-13 below:

**Table 3-13 Control Methods and Descriptions of PID Control (1/2)**

control	number of controlled channels	target point(s) of temperature control		brief description of controlling
based on temperature at one point	1 temperature channel	—		The temperature of 1 temperature channel is controlled to be as designated.
based on averaged temperature among multiple points	Max of 10 temperature channels	—		The average temperature of multiple temperature channels is controlled to be as designated.
based on temperature difference at one point	1 temperature channel	1 temperature channel		The temperature of 1 temperature channel is controlled to be at a constant difference from the temperature of a reference control temperature channel.
		1 power supply	control power supply based on temperature at one point	The temperature of 1 temperature channel is controlled to be at a constant difference from the temperature of a temperature channel of the reference control power supply.
			control power supply based on averaged temperature among multiple points	The temperature of 1 temperature channel is controlled to be at a constant difference from the average temperature of multiple temperature channels of the reference control power supply.
		power supply group	control based on temperature at one point	The temperature of 1 temperature channel is controlled to be at a constant difference from the temperature of a temperature channel designated by the reference control power supply group.
			control based on averaged temperature among multiple points	The temperature of 1 temperature channel is controlled to be at a constant difference from the average temperature of multiple temperature channels designated by the reference control power supply group.

**Table 3-13 Control Methods and Descriptions of PID Control (2/2)**

control	number of controlled channels	target point(s) of temperature control		brief description of controlling
based on averaged temperature difference among multiple points	Max of 10 temperature channels	1 temperature channel		The average temperature of multiple temperature channels is controlled to be at a constant difference from the temperature of a reference control temperature channel.
		1 power supply	control power supply based on temperature at one point	The average temperature of multiple temperature channels is controlled to be at a constant difference from the temperature of a temperature channel of the reference control power supply.
			control power supply based on averaged temperature among multiple points	The average temperature of multiple temperature channels is controlled to be at a constant difference from the average temperature of multiple temperature channels of the reference control power supply.
		power supply group	control based on temperature at one point	The average temperature of multiple temperature channels is controlled to be at a constant difference from the temperature of a temperature channel designated by the reference control power supply group.
			control based on averaged temperature among multiple points	The average temperature of multiple temperature channels is controlled to be at a constant difference from the average temperature of multiple temperature channels designated by the reference control power supply group.

**3.3.3.3. ON/OFF Control**

The definition of on/off control is that temperature is controlled with the voltage output of a power supply turned off when the upper temperature limit is exceeded, and turned on when the lower temperature limit is exceeded.

For this control method, the preset ON/OFF control voltage is applied as the output voltage (ON/OFF control voltage  $\leq$  voltage load tolerance.) On/off temperature control can only be achieved in controlling based on temperature at one point.

#### 3.3.3.4. Constant Power Control

The constant power control function is based on the control methods as follows. Controlling is executed every 10 seconds.

(1) With input of load resistance value

Constant power control (with load resistance value input) denotes current control which keeps the theoretical current calculated from the specified power and load resistance levels. The basic idea is that a heater generates the specified power when theoretical current is applied to the heater. (Here, the variation of heater load resistance is not taken into account.) Based on the theory, the control current value to generate the target EP at the heater is calculated. Then, the calculated current/voltage values are transmitted to the power supply via LAN.

The EP of measurement data is obtained by the following equation.

$$EP(P) = I^2 \times R \text{ [current} \times \text{current} \times \text{resistance]}$$

(2) Without input of load resistance value

For constant power control (without load resistance input), initial current is applied to a circuit to obtain its resistance, from which to derive the current level required to achieve the constant control on the target output power (output voltage  $\times$  output current) of a power supply, which is executed via feedback control. The circuit resistance is updated every 10 seconds for correction.

To be precise, the current levels at the forementioned process are varied in stages, during which the output voltage of a power supply is measured. Then the approximate circuit resistance is derived from the output voltage/current of the power supply, using which the output power from the power supply is controlled to achieve the target EP.

That is, a power supply is controlled the way its output EP, which is calculated from the output current/voltage of the power supply, achieves the preset target EP. The power supply is used in a constant current mode to ease the influence of the variation in load resistance. The output current/voltage from a power supply are obtained via LAN, to which then feedback controlling is applied.

#### 3.3.3.5. Manual Voltage Output Control

Via the manual voltage output control function, voltage arbitrarily set by users can be output. To be precise, a power supply can be controlled the way the voltage preset in the “setting PC” or the “controller” can be output.

### 3.3.3.6. Local Control

When local control is designated for a power supply from the setting screen, the corresponding power supply can be locally operated on its own (by turning its current/voltage output knob.)

The power supplies for local controlling designated by the setting screen can also measure voltage/current output, which is sent to PC and recorded thereat, as in other controlling methods.

Local controlling is also applicable to the 60W power supplies pre-installed in the 6mφ chamber, as one of the controlling types they can deal with.

Local controlling is possible even when the “setting PC” and the “controller” are not in operation (data cannot be recorded in that case.)

### 3.3.4. Limit Function

The limit function can be classified into the three control operations as follows according to the detected items.

#### (1) Alert

When the limit that does not require the immediate stop of controlling is chosen to be applied, controlling is sustained while displaying an alert and outputting a PC alarm. It is up to users then whether or not to change control conditions or to take other countermeasures.

#### (2) Survival mode

When all the target temperature levels to be controlled turn out to be abnormal, temperature controlling is judged as not continuable. When temperature control is stopped, an immediate temperature drop of a TS is avoided by maintaining the heater output only to the ratio [%] preset as the control output for the survival mode case to that at the point of abnormality detection. (The percentage of sustained output is determined based on the output at the point when abnormal temperature output takes place.) Then, an alert shows up on the display while PC/power supply rack alarms go off.

#### (3) Control abort

Control is stopped when it cannot be sustained due to the abnormality of hardware. Then, an alert shows up on the display, while PC/power supply rack alarms go off and the stop/abnormality lamp turns on.

Tables 3-14 (1/3)(2/3)(3/3) show the items to be detected by the limit function, immediate control reactions, and the control methods in which the corresponding failures are prone to take place. Alerts are output to the setting PC and power supply racks. Table 3-15 shows the actions of alert for individual detected phenomena.

**Table 3-14 Table of Limit Functions (1/3)**

	detected item	content	control reaction	PID control				ON/OFF control	constant power control	manual voltage output control
				based on temperature at one point	based on averaged temperature among multiple points	based on temperature difference at one point	based on averaged temperature difference among multiple points			
(1)	preset temperature limit	Control temperature exceeded the preset temperature upper limit.	alert	○				○		
		Control temperature exceeded the preset temperature lower limit.	alert	○				○		
(2)	average temperature limit	Average control temperature exceeded the average temperature upper limit.	alert		○					
		Average control temperature exceeded the average temperature lower limit.	alert		○					
(3)	temperature difference limit	Control temperature difference exceeded the preset upper limit.	alert			○				
		Control temperature difference exceeded the preset lower limit.	alert			○				
(4)	average temperature difference limit	Control temperature difference exceeded the preset upper limit.	alert				○			
		Control temperature difference exceeded the preset lower limit.	alert				○			
(5)	temperature overchange abnormality	Temperature change of over 10℃ in 10 secs was observed in control temperature.	alert	○	○	○	○	○		
		Temperature change of over 10℃ in 10 secs was observed for 30 secs in control temperature.	survival mode	○	○	○	○	○		

**Table 3-14 Table of Limit Functions (2/3)**

	detected item	content	control reaction	PID control				ON/OFF control	constant power control	manual voltage output control
				based on temperature at one point	based on averaged temperature among multiple points	based on temperature difference at one point	based on averaged temperature difference among multiple points			
(6)	temperature data abnormality	About all the target temperatures to be controlled; • Temperature data cannot be acquired for 1 minute. • Measurement failure due to wire breakage of thermocouple, for example, took place in temperature data.	survival mode	○	○	○	○	○		
(7)	preset EP upper limit	Control EP exceeded the preset EP upper limit.	alert						○	
(8)	output EP upper limit	EP load tolerance was exceeded, the excess being 1% or more to less than 5% of Max. power supply output EP.	alert	○	○	○	○	○	○	○
		EP load tolerance was exceeded, the excess being 5% or more of Max. power supply output EP.	control abort	○	○	○	○	○	○	○
(9)	output voltage upper limit	Voltage load tolerance was exceeded, the excess being 1% or more to less than 5% of Max. power supply output voltage.	alert	○	○	○	○	○	○	○
		Voltage load tolerance was exceeded, the excess being 5% or more of Max. power supply output voltage.	control abort	○	○	○	○	○	○	○
(10)	output current upper limit	Current load tolerance was exceeded, the excess being 1% or more to less than 5% of Max. power supply output current.	alert	○	○	○	○	○	○	○
		Current load tolerance was exceeded, the excess being 5% or more of Max. power supply output current.	control abort	○	○	○	○	○	○	○



Table 3-14 Table of Limit Functions (3/3)

	detected item	content	control reaction	PID control				ON/OFF control	constant power control	manual voltage output control
				based on temperature at one point	based on averaged temperature among multiple points	based on temperature difference at one point	based on averaged temperature difference among multiple points			
(11)	power supply abnormality	Abnormal data was received in STS command from power supply.	control abort	○	○	○	○	○	○	○
(12)	communication failure of power supply	Communication failure took place.	output maintained	○	○	○	○	○	○	○
(13)	heater wire breakage abnormality	When control input $\geq 2\%$ of Max. output current AND current level $< 0.4\%$ of Max. output current in current control (temperature/constant EP control), heater wire breakage abnormality is determined.	control abort	○	○	○	○	○	○	○
(14)	abnormal data from power supply	Measurement failure took place due to abnormality in data from power supply.	control abort	○	○	○	○	○	○	○
(15)	PLC abnormality	Abnormality took place during PID control.	survival mode	○	○	○	○			
		Abnormal response from PLC was received.	survival mode	○	○	○	○			
		Communication failure took place.	survival mode	○	○	○	○			
(16)	power failure detection	Power failure or dropping of breaker took place.	control abort	○	○	○	○	○	○	○
(17)	overcurrent detection	Overcurrent was supplied to power supply.	control abort	○	○	○	○	○	○	○

**Table 3-15 Contents of Alert for Each Detection Item (1/2)**

	detected item	content	control reaction	setting PC			power supply rack	
				setting screen	log message	alarm sound	abnormality lamp (red)	buzzer
(1)	preset temperature limit	Control temperature exceeded the preset temperature upper limit.	alert	light fault	alert	○		
		Control temperature exceeded the preset temperature lower limit.	alert	light fault	alert	○		
(2)	average temperature limit	Average control temperature exceeded the average temperature upper limit.	alert	light fault	alert	○		
		Average control temperature exceeded the average temperature lower limit.	alert	light fault	alert	○		
(3)	temperature difference limit	Control temperature difference exceeded the preset upper limit.	alert	light fault	alert	○		
		Control temperature difference exceeded the preset lower limit.	alert	light fault	alert	○		
(4)	average temperature difference limit	Control temperature difference exceeded the preset upper limit.	alert	light fault	alert	○		
		Control temperature difference exceeded the preset lower limit.	alert	light fault	alert	○		
(5)	temperature overchange abnormality	Temperature change of over 10℃ in 10 secs was observed in control temperature.	alert	light fault	alert	○		
		Temperature change of over 10℃ in 10 secs was observed for 30 secs in control temperature.	survival mode	heavy fault	abnormality	○		
(6)	temperature data abnormality	About all the target temperatures to be controlled; <ul style="list-style-type: none"> <li>• Temperature data cannot be acquired for 1 minute.</li> <li>• Measurement failure due to wire breakage of thermocouple, for example, took place in temperature data.</li> </ul>	survival mode	heavy fault	abnormality	○		
(7)	preset EP upper limit	Control EP exceeded the preset EP upper limit.	alert	light fault	alert	○		
(8)	output EP upper limit	EP load tolerance was exceeded, the excess being 1% or more to less than 5% of Max. power supply output EP.	alert	light fault	alert	○		
		EP load tolerance was exceeded, the excess being 5% or more of Max. power supply output EP.	control abort	heavy fault	abnormality	○	△	△

Table 3-15 Contents of Alert for Each Detection Item (2/2)

	detected item	content	control reaction	setting PC			power supply rack	
				setting screen	log message	alarm sound	abnormality lamp (red)	buzzer
(9)	output voltage upper limit	Voltage load tolerance was exceeded, the excess being 1% or more to less than 5% of Max. power supply output voltage.	alert	light fault	alert	○		
		Voltage load tolerance was exceeded, the excess being 5% or more of Max. power supply output voltage.	control abort	heavy fault	abnormality	○	△	△
(10)	output current upper limit	Current load tolerance was exceeded, the excess being 1% or more to less than 5% of Max. power supply output current.	alert	light fault	alert	○		
		Current load tolerance was exceeded, the excess being 5% or more of Max. power supply output current.	control abort	heavy fault	abnormality	○	△	△
(11)	power supply abnormality	Abnormal data was received in STS command from power supply.	control abort	heavy fault	abnormality	○	△	△
(12)	communication failure of power supply	Communication failure took place.	output maintained	heavy fault	abnormality	○	△	△
(13)	heater wire breakage abnormality	When control input $\geq$ 2% of Max. output current AND current level $<$ 0.4% of Max. output current in current control (temperature/constant EP control), heater wire breakage abnormality is determined.	control abort	heavy fault	abnormality	○	△	△
(14)	abnormal data from power supply	Measurement failure took place due to abnormality in data from power supply.	control abort	heavy fault	abnormality	○	△	△
(15)	PLC abnormality	Abnormality took place during PID control.	survival mode	heavy fault	abnormality	○		
		Abnormal response from PLC was received.	survival mode	heavy fault	abnormality	○		
		Communication failure took place.	survival mode	heavy fault	abnormality	○		

\* △ denotes that the abnormality lamps and buzzers are turned on only on the power supply racks that contain abnormality-detected power supplies.

### 3.3.5. Vibration Control System

Among the work concerning the vibration control system, the preparatory work and operation of a vibration analyzer are to be executed by users. For using a vibration analyzer, users are to install accelerometers and cables, and set the analyzer itself by themselves. The points to be taken into account and cautions for the preparation and operation of a vibration analyzer are shown below. Ask the operation company of the facility for more details.

(1) Accelerometers for different usage purposes

As Table 2-8 shows, there are three kinds of accelerometers prepared in this system for different usage purposes according to resolution, applied temperature range, etc. The installation sites where they are used are mostly assumed as below.

- (a) 393M33: inside vacuum vessel (shroud, supporting bench with cooling panel, vacuum vessel, optical window)
- (b) 393B12: inside vacuum vessel (optical bench, TS supporting bench)
- (c) 393B31: seismic slab

Those accelerometers are not restricted to the locations shown above; 393B31, for example, can be mounted on the TS supporting bench in the vacuum vessel, as long as thermal insulation measures were taken by protecting it with insulating materials, etc. (That way, it is applicable in vacuum.)

(2) Accelerometer I/F

(a) Cable connecting I/F

As you can see from Figure 2-11, the cable connection I/F inside and outside the vacuum vessel are different from each other. Inside the vacuum vessel, accelerometers are connected to the MIL connectors at the end of the low noise cables stored in the cutouts on the vacuum vessel body shroud. Outside the vessel, e. g., on the seismic slab, meanwhile, they are connected to the relay box in the lower pit of the vacuum vessel via twisted wire cables. The wiring from the relay box to the vibration analyzer is completed in advance. Accelerometers are designated to be assigned to the channels 1 ~ 15 for installation inside the vacuum vessel and to the channels 16 ~ 30 for installation outside the vessel. As for the former group of channels, the wiring between the inner-vessel MIL connectors and the relay box is completed in advance.

(b) I/F for installation

The general description of the I/F for installation is provided as follows.

In case there is not enough number of purpose-made plates mentioned below, users are to prepare them. Accelerometers can be fixed not only to the pre-designated places but anywhere using kapton tape, etc.

① Seismic slab

The seismic slab has screw holes for fixing an I/F on it for mounting accelerometers. That I/F is to be made for the specific purpose.

② Optical bench

Mount a purpose-made plate on the optical bench as the I/F, using the screw holes on it for mounting a TS supporting bench guide.

③ TS supporting bench

Mount a purpose-made plate on the TS supporting bench as the I/F using the hard ports on it.

④ Shroud

There are purpose-made mounting points near the man door on the body part.

⑤ Vacuum vessel

There are purpose-made mounting points near the manhole at the bottom of the vacuum vessel.

⑥ Optical window

There are purpose-made mounting points on three places at the bottom of the optical window.

(3) Cautions for executing analysis

Acceleration data can be obtained for three minutes at the sampling frequency of 800Hz due to the restriction of the hard disc capacity. Choose “monitor mode” (ask the operation company of the facility for details) when long-term monitoring is desired.

(4) Data transfer

The acceleration/displacement data acquired by the vibration analyzer and the FFT results obtained by post-processing those data are saved in the work station in binary format. There are three ways of transferring data as below (recording media is to be prepared by users.)

- (a) Copy binary data on magnetic tape, and bring it out.
- (b) Convert binary data to text data, copy it on a data storage device via LAN, and bring it out in MO.
- (c) Copy binary data on a data storage device via LAN in a binary mode, and bring it out in MO (data can be corrupted during transference unless it is kept in a binary mode.)

When using magnetic tape, choose one with a capacity of 525 MB.

### **3.3.6. Data Acquisition System**

#### **3.3.6.1. Registration of Measurement Conditions**

Input measurement conditions following the users’ manual for the system. (Information can be input in a form of a file.)

The format of the “measurement ID” to be made for measurement ID/mode settings is 8 alphanumeric letters. Do not use half-width spaces before and after a measurement ID.

#### **3.3.6.2. Data Distribution**

After a test, the recorded measurement data is to be CSV-converted and handed to a TS manufacturer.

### 3.3.6.3. Content of Data obtained by Data Acquisition System

The data obtainable by the data acquisition system are as follows.

- Thermocouple temperature
- Calorimeter output
- Temperature by resistance temperature detector (■ abbreviated as RTD hereafter)
- T-QCM output
- IR power supply current/voltage output
- Vacuum pressure

Users can monitor those data from the data displaying devices 1 ~ 4.

The correspondence between the channel numbers of the input signals for the data acquisition system and the plug signs on the inner-vessel permanent terminal board are shown in Figure 3-4 and Table 3-16. According to them, for example, the thermocouple lines for a TS (600 channels in total) which do not go through IR power supplies correspond to the plugs C1 ~ C41, D1 ~ D6, N1 ~ N2 on the inner-vessel permanent terminal board, which correspond to the channel numbers 1 ~ 600 in the data acquisition system.

**Table 3-16 Correspondence between Acquisition Data and Channel Numbers**

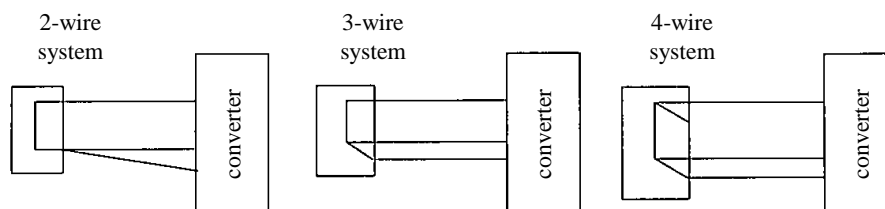
channel No.	plug sign	name of data
1 ~ 600	C1 ~ 41 D1 ~ 6 N1 ~ 2	TS temperature*
613 ~ 648	—	standard signals
601 ~ 612 649 ~ 672	—	spare
1001 ~ 1016	—	T-QCM
3001 ~ 3420	—	power supplies for heat sources

Refer to the correspondence table of channels in Appendix A for details.

\* Among the pairs of pins, the 12<sup>th</sup> pair of C14 and C28 is occupied for grounding, which leaves 11 pairs available.

### 3.3.6.4. Resistance Temperature Detector

The output resistance of the RTDs to be connected is to be between 0 ~ 3 kW. They are basically to be JAXA-certified products. The resistance levels of measurement data are converted into temperature only via the data processing system. That is, they are displayed as they are in the data gathering system. Refer to the following figure for how RTDs are connected.



Note) The converters all have a three-wire system.

**Figure 3-35 Connection of RTDs**

Also, a conversion sheet for resistance and temperature is to be prepared in the tabular format of EXCEL. The data acquisition system generates an approximate line by connecting the values designated in the sheet with linear lines. Up to 32 contact points can be specified.

There are default conversion sheets for the ten kinds of RTDs as shown below.

- (1) Thermistor (cf. NASDA-QTS-23648A)
  - THS51CNA501, 102
  - THS51CNB222, 302
  - THS51CNC502
  - THS51CND103
  - THS51CNE153, 303
- (2) Platinum temperature sensor (cf. NASDA-QTS-1043A)
  - N1043501-90-300, N1043501-91-600

### 3.3.6.5. Wire Breakage Detection Function and How to Use it

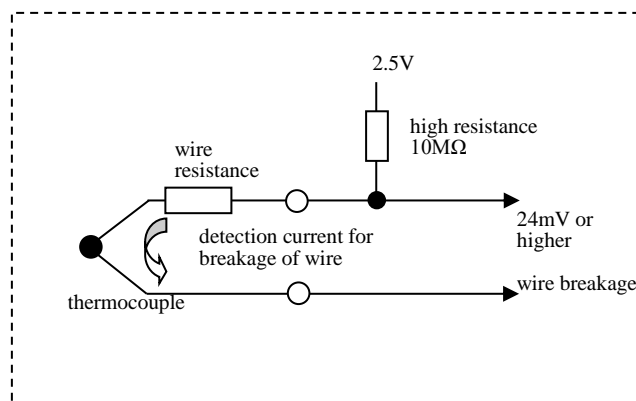
- (1) Wire breakage detection function

A detection circuit for wire breakage is installed for thermocouple-adopted temperature measurement to detect a broken wire in a thermocouple circuit by deflecting signals to the maximum limit, so that temperature can be controlled to the safety side. The detection circuit for wire breakage is of a voltage impression type as shown in Figure 3-36. When a thermocouple circuit has no defects, the detection current for wire breakage flows into a thermocouple.

- (2) Wire breakage detection function in 6mφ Radiometer Space Chamber

The wire breakage detection function in this facility has a high resistance of 10 MΩ and voltage of 2.5V loaded on its input circuit as shown in Figure 3-36. That is, detection current of about 0.25 μA is flowing to the thermocouple side.

When this detection current for wire breakage is interrupted, the wire breakage of a thermocouple is detected.



**Figure 3-36 Wire Breakage Detection Circuit**

(3) How to use it

As can be seen from (2) above, “ $0.25\ \mu\text{A} \times$  the voltage for the wiring resistance of a thermocouple” is added to the temperature measured by a thermocouple (electromotive force), because current of  $0.25\ \mu\text{A}$  is flowing to the thermocouple side. That is how wiring resistance increases with a longer wire of a thermocouple, which pushes up measurement errors derived from the detection current for breakage of wire. In case of 6mφ radiometer space chamber, the thermocouple wiring resistance to the facility side is  $20\ \Omega$ , which denotes exceeded measurement accuracy of the logger (within  $\pm 1^\circ\text{C}$ ) when the thermocouple wiring resistance to the TS side goes over  $80\ \Omega$ .

Therefore, it is recommended to follow the instructions in Table 3-17 when using the wire breakage detection function.



**Table 3-17 Recommended Usage Instructions for Wire Breakage Detection Function (1/2)**

thermocouple wiring resistance for the TS side	80Ω or less	over 80Ω	
		temperature monitor channel	temperature control channel
ON/OFF of wire breakage detection function	It can be either turned on or off.	It is recommended to be turned off.	It is to be turned on.
measurement accuracy	-200°C ~ -130°C: Ask the facility staff because measurement errors differ depending on temperature (nonlinear.) -130°C ~ : within ±1°C	-200°C ~ -130°C: Ask the facility staff because measurement errors differ depending on temperature (nonlinear.) -130°C ~ : within ±1°C	The following accuracy can be assured if system calibration is executed in advance using the wiring resistance of a thermocouple. -200°C ~ -130°C: Ask the facility staff because measurement errors differ depending on temperature (nonlinear.) -130°C ~ : within ±1°C
screen display for wire breakage	When wire breakage detection function is on : The data display area shows “breaking of wire.” When wire breakage detection function is off : The graph display of temperature becomes unstable.	In the data display area and the graph display area; • The graph display of temperature becomes unstable. • Abnormal values are displayed.	The data display area shows “breaking of wire.”

**Table 3-17 Recommended Usage Instructions for Wire Breakage Detection Function (2/2)**

thermocouple wiring resistance for the TS side	80Ω or less	over 80Ω	
		temperature monitor channel	temperature control channel
how to use the function (including restrictions, cautions, etc.)	With no wire breakage, normal temperature measurement is possible regardless of the wiring resistance of a thermocouple.	<ul style="list-style-type: none"> <li>• With no wire breakage, normal temperature measurement is possible regardless of the wiring resistance of a thermocouple.</li> <li>• When unstable temperatures or abnormal values are indicated, it is possible to check the existence of wire breakage by temporarily turning on the wire breakage detection function.</li> </ul>	<ul style="list-style-type: none"> <li>• When wire breakage takes place, the heat source power supply maintains the preset values (e. g., 50% output, etc.)</li> <li>• When system calibration is required to be executed by the facility staff prior to the installation of a TS into the chamber, that is subject to additional charge to cover calibration on about 30 channels a day in the chamber. Re-execution of system calibration will be necessary after the test to restore the facility to the pre-test state (which costs the same amount of charge as above.)</li> </ul> <p>Users are to prepare a list of channels to be calibrated and thermocouple wires with the equivalent resistance as of those used for the test in advance.</p>

### 3.3.6.6. Cautions

The data input device, the data gathering device, and the data processing device have their power supplied from the uninterruptible power supply. When power failure takes place, take measures, e. g., normal termination operation, etc., within the operation time (10 minutes) of the uninterruptible power supply system.

### 3.3.7. Utility Facilities

#### 3.3.7.1. Clean Booth I/F

##### (1) General operation procedure

The outline flow of executing an optical performance confirmation test on a TS in the clean booth while mounted on the moving dolly is shown in Figure 3-37. It is to be noted that in the procedure of carrying the moving dolly into the vacuum vessel, when its ducts have to be removed, the clean booth cannot maintain the cleanliness of ISO5[ISO14644] (class M3.5, equivalent of class 100 [FED-STD-209E].)

##### (2) I/F inside clean booth

The effective test area (volume) in the clean booth is 3,500 mm (width) × 5,000 mm (depth) × 2,110 mm (height, with a clearance of 100 mm from the thermohydrometer.) (cf. Figure 3-38.)

##### (3) Required time for achieving ISO5 [ISO14644] (class M3.5, equivalent of class 100 [FED-STD-209E])

It takes about thirty minutes to establish an ISO5 [ISO14644] (class M3.5, equivalent of class 100 [FED-STD-209E]) environment in the clean booth with no personnel inside.

##### (4) Max. capacity in the room

The clean booth can hold up to three people.

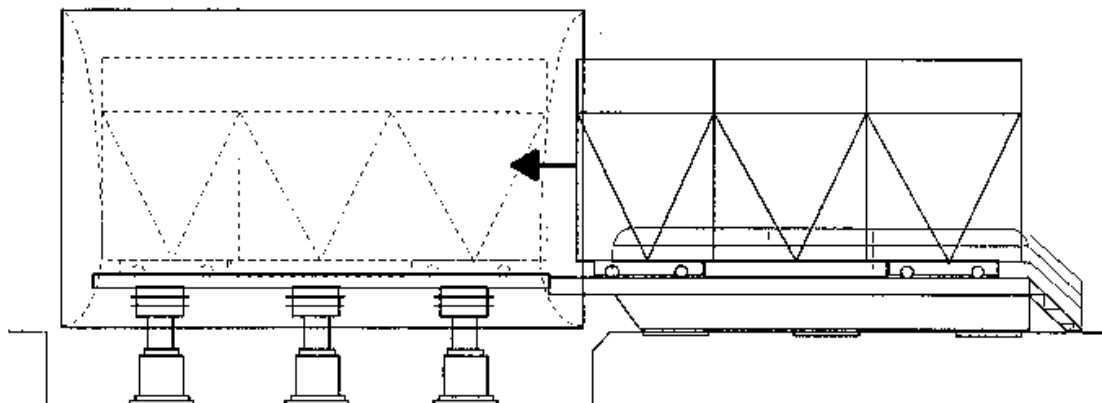
##### (5) Monitoring of temperature/humidity

The temperature and humidity data inside the clean booth can be monitored and checked during the operation of the clean booth from its operation console via three points for each of temperature and humidity. Among the three points, the temperature and humidity of the one in the center are recorded and saved in the data acquisition system.

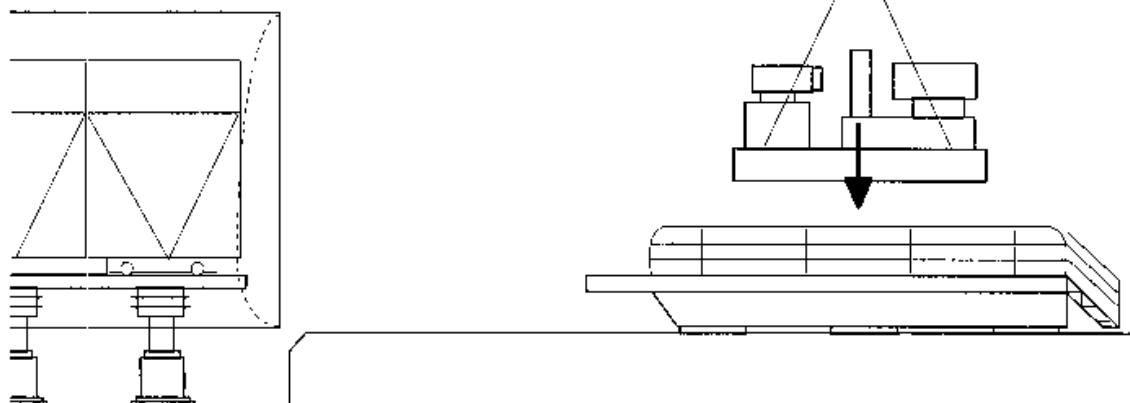
##### (6) Configuration of related equipment

The usage of the clean booth requires air-conditioning ducts to be configured, and therefore limits the usable range for setting test-related equipment next to the chamber as shown in Figure 3-39.

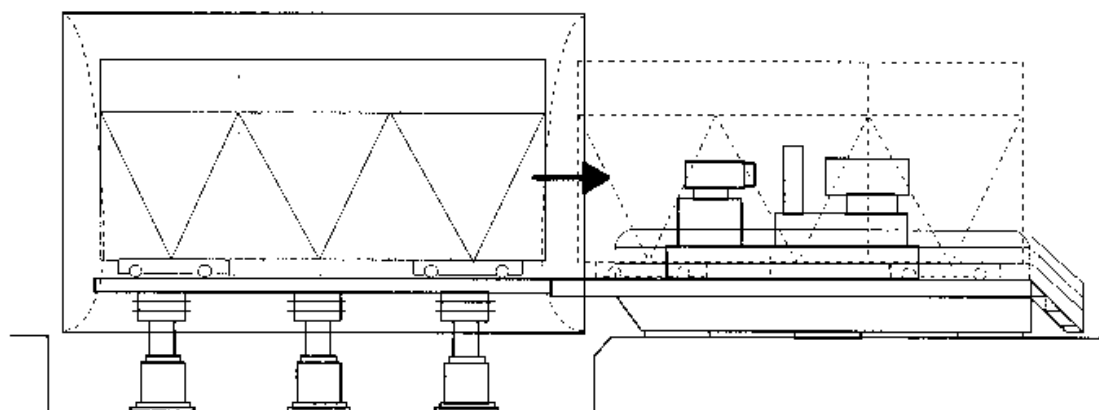
1. After connecting the TS installation bench to the vacuum vessel, move the clean booth into the vacuum vessel.



2. After disconnecting the TS installation bench from the vacuum vessel, mount a TS on the installation bench using a crane.



3. After connecting the TS installation bench to the vacuum vessel again, move the clean booth onto the installation bench.



**Figure 3-37 Outline Flow of Clean Booth Operation**

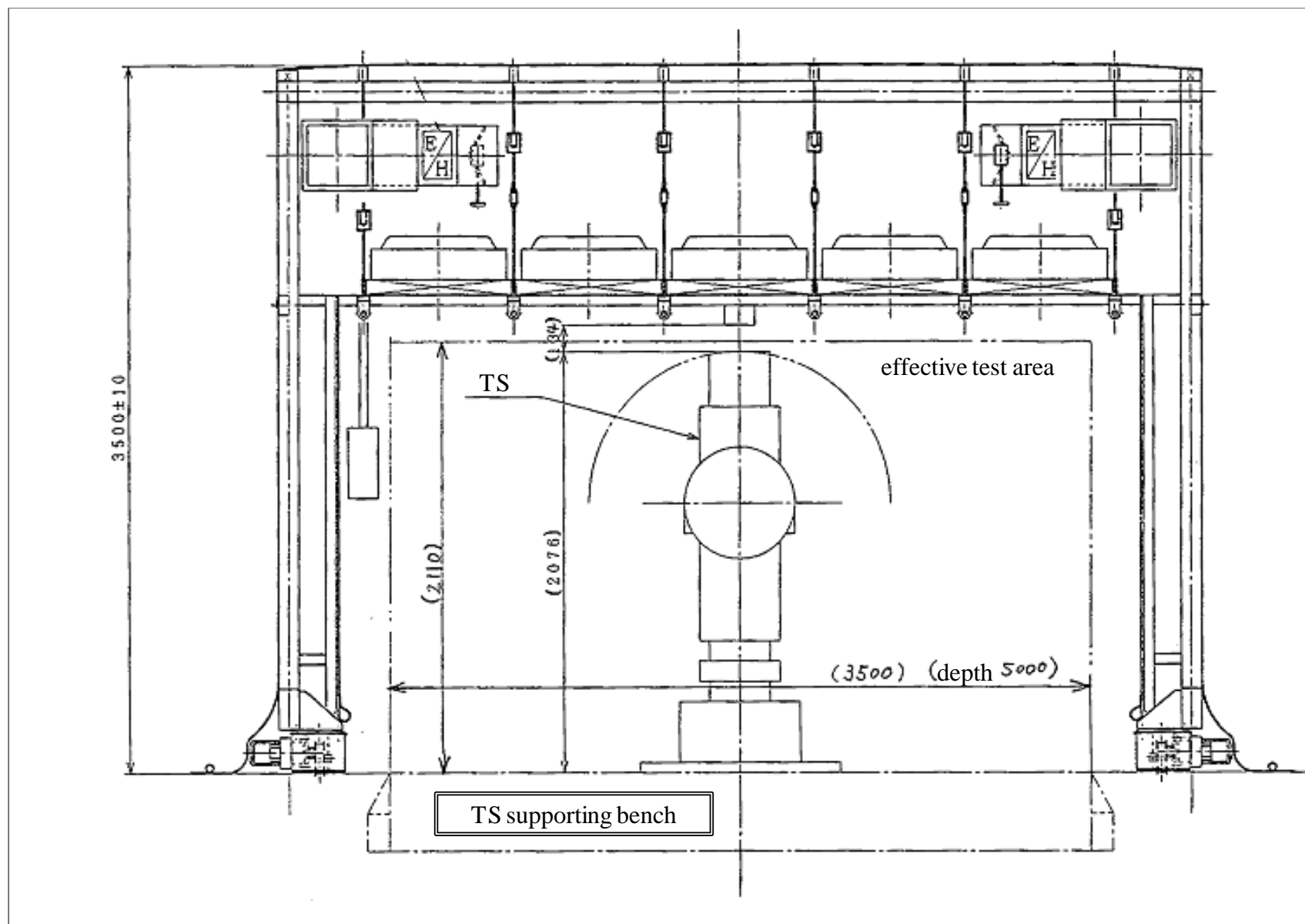


Figure 3-38 Height inside Clean Booth

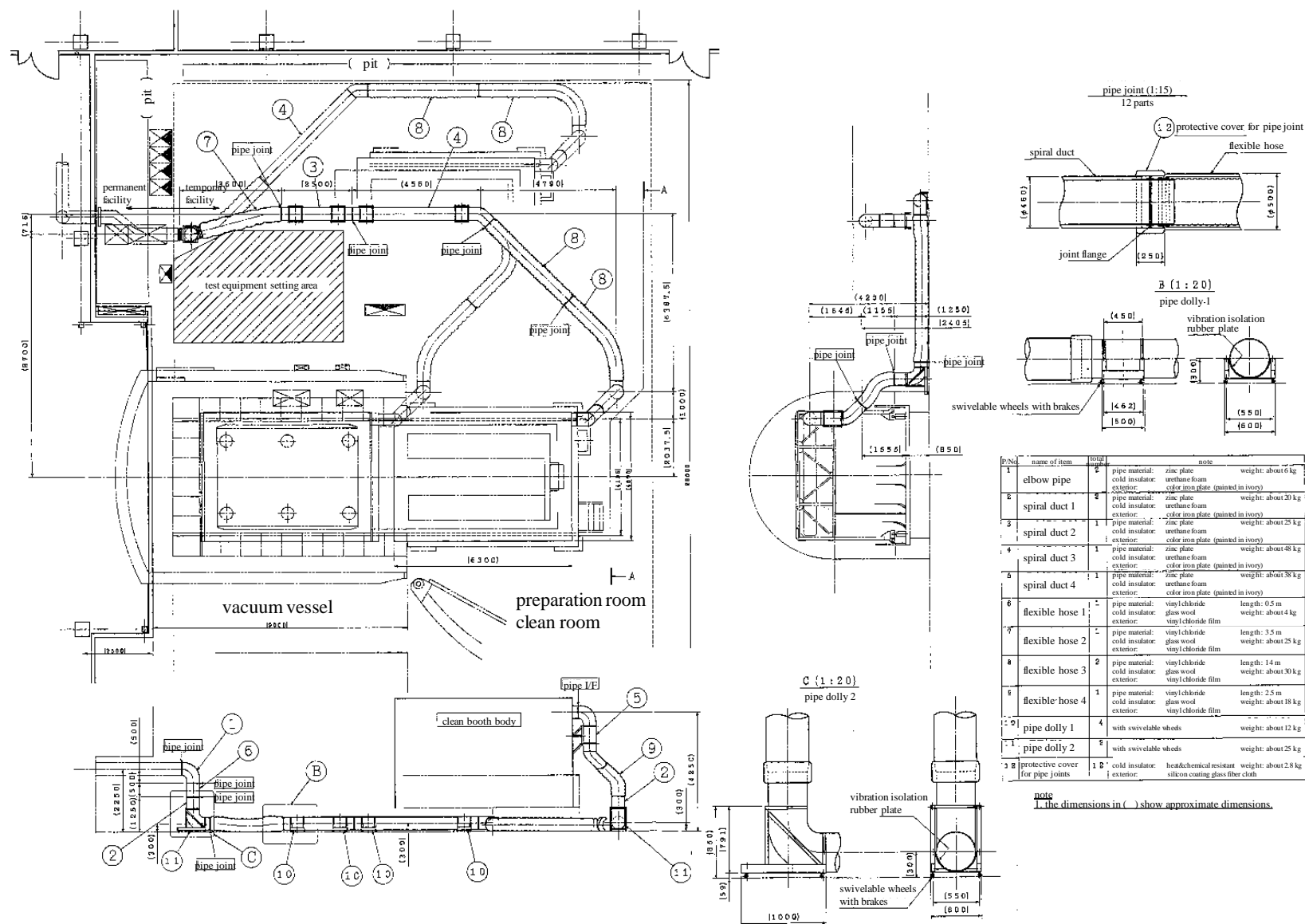


Figure 3-39 Configuration of Clean Booth Ducts

### 3.4. Facility Belongings

This facility is equipped with the following connectors, etc., necessary for obtaining data during a test, which can be rented out for users. The procedures for renting and returning the items are shown under the table.

**Table 3-18 List of Facility Belongings**

item	usage purpose	model #	owned qty
connector (plug)	for signals, EP, IR power supplies, and RTDs	MS3106B18-1S	—
		MS3106B22-23S	—
		MS3106B32-17S	—
	for thermocouples	AFD56-16-26SN	—
		JA3106B24-J28SC	—
socket contact*	for thermocouples	0603-34-2039	—
		105372	—
		NM-104-845#1	—
		NM-104-845#2	—
calorimeter	for radiation intensity measurement	ST4356A	30
T-QCM	for contamination monitoring	MK-10 sensor MODEL1900 processor MODEL1800 temperature controller	4 sets

\* Socket contacts (for thermocouples) are crimp-type, and are therefore not reusable. Users are to prepare them by themselves. In case they cannot be procured on time for the schedule, those equipped in the facility are also available. In that case, make sure to return equivalent items later.

Note) Users are also to prepare plugs by themselves as much as possible. In case they cannot be procured on time for the schedule, those equipped in the facility are also available. In that case, users are to pull out the pins of thermocouple plugs, or clean solder off other equipment before returning them.

#### [Procedures for Renting and Returning Items]

- (1) When renting items, users are to fill in the acknowledgement form of rent (prepared by the operation company of the facility) with the names, quantity, etc., of necessary items.
- (2) The items are to be returned as soon as the tenancy is over. Expendables (e. g., socket contacts, etc.) are to be replaced by the same number of the same new items.
- (3) The items with solder applied (e. g., connectors, etc.), if any, are to be returned after wiping off the solder clearly, or to be refilled with the same number of the same new items.
- (4) The operation company of the facility will explain anything not yet clear to users concerning the procedures for renting and returning items.

### 3.5. Building I/F

#### (1) Preparation room

This room, where the chamber is located, is used as a working area for users to carry out preparatory work and tests.

##### (a) Gradient of floor and load capacity

The floor of the preparation room has a gradient of 3/1000 or less because the TS installation device moves on it. The floor therefore has a specified load capacity, which is 9.8 kPa for widely-spread load and 7.85 MPa (= compressive strength of floor coating material. The compressive strength of concrete (for temporary load) is 23.8 MPa) for concentrated load (e. g., casters of a bench, etc.) The floor requires prior curing even for an item weighing less than the specified load capacity if it has any possibility of damaging the floor.

##### (b) Hand-pallet truck

A hand-pallet truck can be used for moving heavy items in the preparation room. There are large-size and small-size hand-pallet trucks. The former is the same as the TS installation dolly (cf. section 2.2.2), with the same dimensions and capacity. The basic descriptions of the smaller hand-pallet truck are shown below.

**Table 3-19 Basic Descriptions of Hand-pallet Truck**

	hand-pallet truck (small)
dimensions	1,230W × 1,600L × 193H
capacity	2,400 kg

When moving a TS, etc., using the larger hand-pallet truck, it is convenient to use the satellite mounting bench (large) (cf. Figure 3-40.) Its mass and the maximum load mass are 2,100 kg and 4,000 kg, respectively.

##### (c) Temperature/humidity monitoring

The temperature and humidity in the preparation room can be displayed on a portable monitor.

##### (d) Particles (cleanliness)

Particles are being counted by the dust counter located in the preparation room.

##### (e) Max. capacity in the room

The preparation room can hold up to 15 people.

#### (2) Measurement and control room

Users carry in check-out devices, etc., into this room, for performing data analysis, etc.



## (3) Distribution boards for users

The installation sites and usage purposes of the distribution boards and plug socket boards necessary for performing a test are shown in Table 3-20. Each distribution board has a plug socket board at the lower part of itself. In addition to that, LS-1B and 1C each has a surface plug socket board (A.) Refer to Figure 3-41 for their locations. The WBD diagram of distribution boards is shown in Figure 3-42. The specifications of the plug socket board at the lower part of a distribution board and the surface plug socket board (A) (configuration of sockets) are shown in Figure 3-43.

Since the distribution boards are also connected to the emergency power supply system, they can all gain power from the private power generator in the power building in case the commercial power supply is interrupted. It takes about 10 minutes before the private power generator finally gets to supply power, which then starts supplying power to the distribution boards in the order of priority. Likewise, power failure takes place for about 10 minutes at the time of power restoration by the commercial power supply.

**Table 3-20 List of Distribution Boards for Users**

distribution board #	installation site	usage purpose
LS-1B	preparation room	for sockets and devices
LS-1C	preparation room	for sockets and devices
LS-1E	fore-room	for sockets and devices
LS-1I	measurement and control room	for sockets and devices

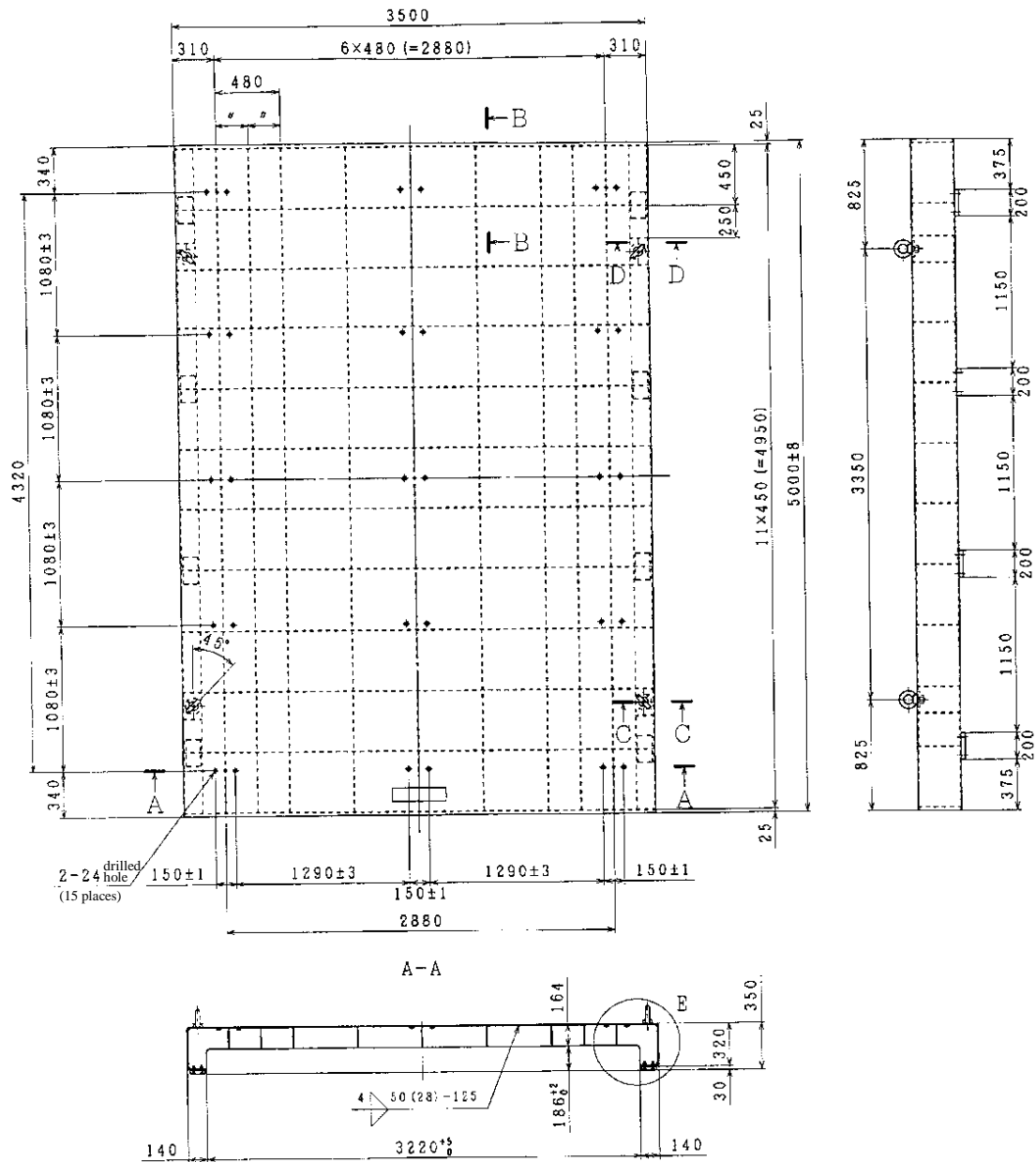
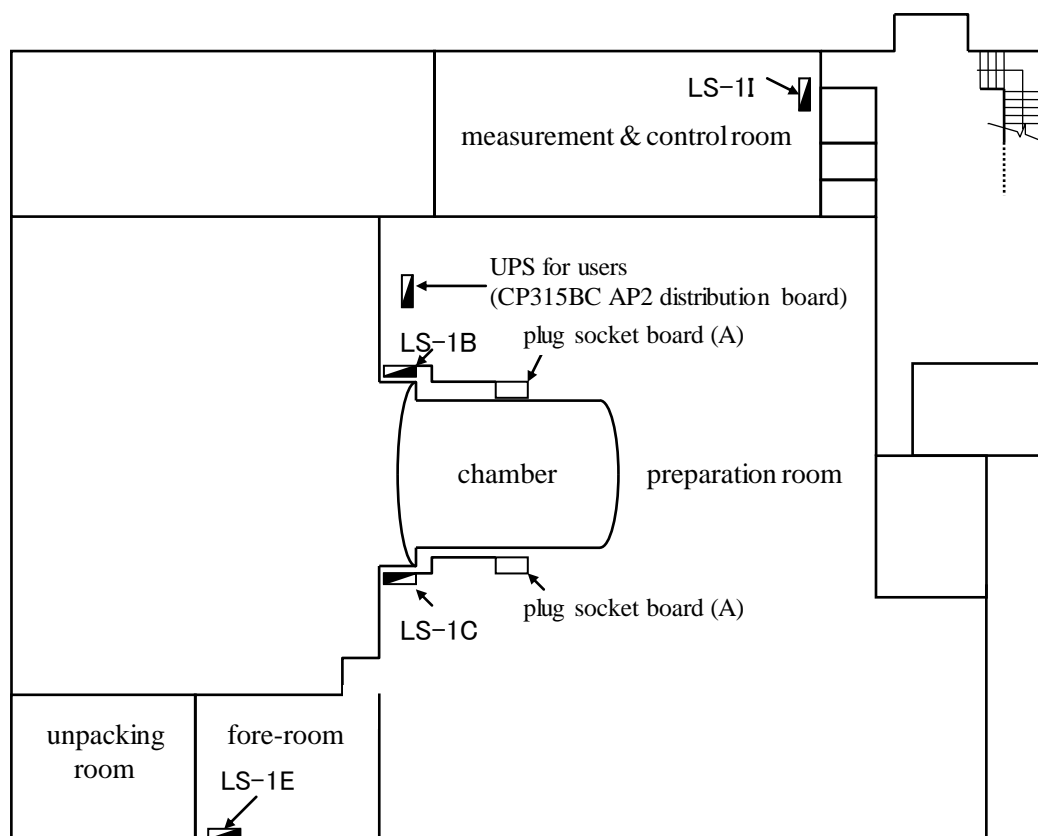
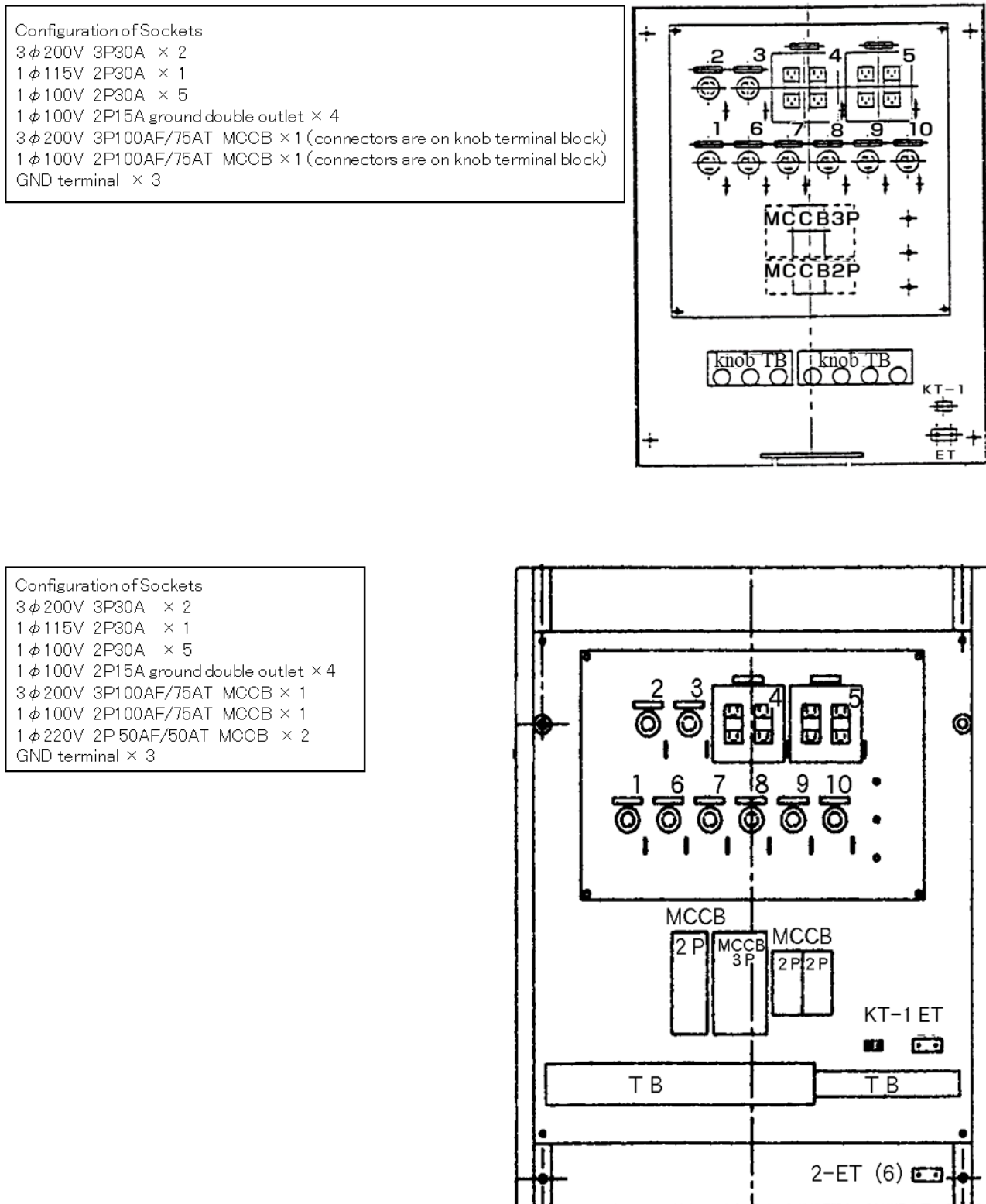


Figure 3-40 Mounting Bench (Large)



**Figure 3-41 Configuration of Distribution Boards/Plug Socket Boards**





**Figure 3-43 Specifications of Socket at Lower Part of Distribution Board and Plug Socket Board (A)**

## (4) Cranes

There are cranes between the unpacking room and the fore-room, and in the preparation room, which can be used for carrying in a TS, etc. When using them, they are to be operated only by qualified people, who are always to fill in the specified record form with the track record of use. There is a rail switch mechanism between the unpacking room and the fore-room crane, which allows the transportation of items with the crane between the two rooms with the shutter open. The specifications of the cranes are shown in Table 3-21. Each crane is oil-drip proofed, but a TS is to be protected by a cover, etc., for precaution's sake. Refer to Figure 3-45 for the movable range of each crane. The cranes require about ten seconds to be ready for operation after the “on” button on the pendant switch is pressed due to the installed inverter, while there is a little time lag before completely stopping after the “stop” button is pressed (same with the case of their activation.)

The hook is to be wound up to the limit after using the crane.

**Table 3-21 Specification of Cranes**

installation site	unpacking room ~ fore-room	preparation room
type	monorail hoist type 4.8t	doublerail hoist type 4.8t
rated load	4.8t	4.8t
lifting height	11.0m (below hook: 10.71m)	13.6m (below hook: 13.54m)
hoist speed (Min/max)	0.4/4.0 (m/min)	0.4/4.0 (m/min)
traverse speed (Min/max)	1.25/12.5 (m/min)	1.25/12.5 (m/min)
travel speed (Min/max)	2/20 (m/min)	2/20 (m/min)
operation method	press button on the floor	press button on the floor

Note 1) The speed can be changed by pressing the buttons for low and high speeds.

Note 2) The low speed at the first step is changable. The speed range, however, is within 1/10 of the top speed.

## (5) Unpacking room

The shutter facing the outside has a slight opening, through which rain, etc., can enter the room at the occasion of typhoon, etc. Therefore, no jigs or measurement instruments are to be placed near the shutter.

## (6) UPS for users

There is a UPS available to users in the preparation room. Contact the facility operation company in advance if it is planned to be used.

## (a) Location

Refer to Figure 3-41.

## (b) Specifications

- ① Max. total output capacity: 15.0 kVA
- ② Backup duration: 10 min or longer
- ③ Output rating/wiring number

**Table 3-22 Specification of UPS**

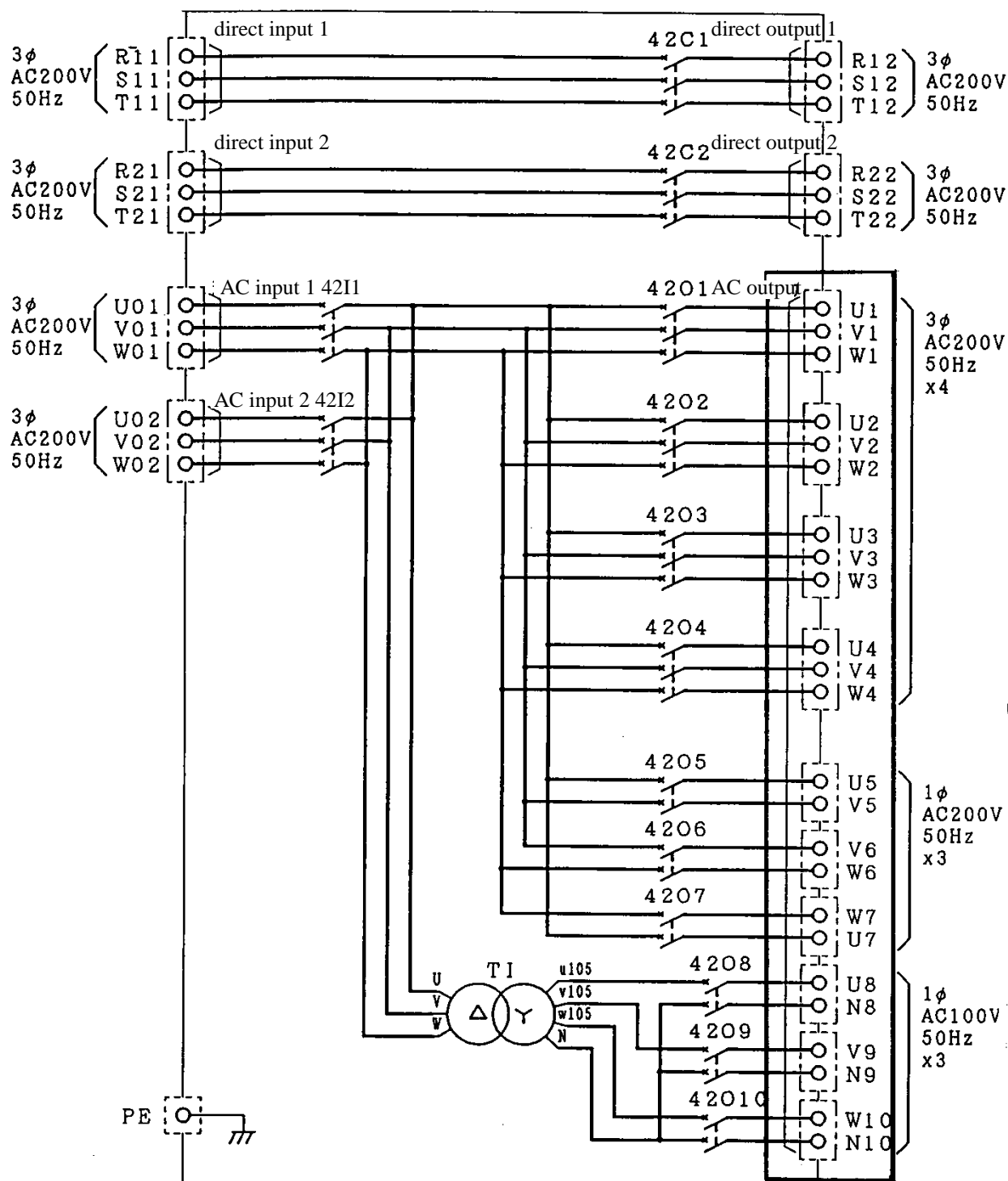
output rating		wiring # on branch power board
AC200V three-phase three-wire 50Hz	total: 4 circuits	U1, V1, W1
		U2, V2, W2
		U3, V3, W3
		U4, V4, W4
AC200V single-phase two-wire 50Hz	total: 3 circuits	U5, V5
		V6, W6
		W7, U7
AC100V single-phase two-wire 50Hz	total: 3 circuits	U8, N8
		V9, N9
		W10, N10

\* Wiring is to be performed after checking the wiring numbers shown on the branch power board at site.

(c) Others

A circuit diagram of the branch power board is shown in Figure 3-44.

The total load from the equipment mounted by users is to be 75A or less.



The terminals in the bold frame are available to users.

Figure 3-44 Circuit Diagram of Branch Power Board for Users



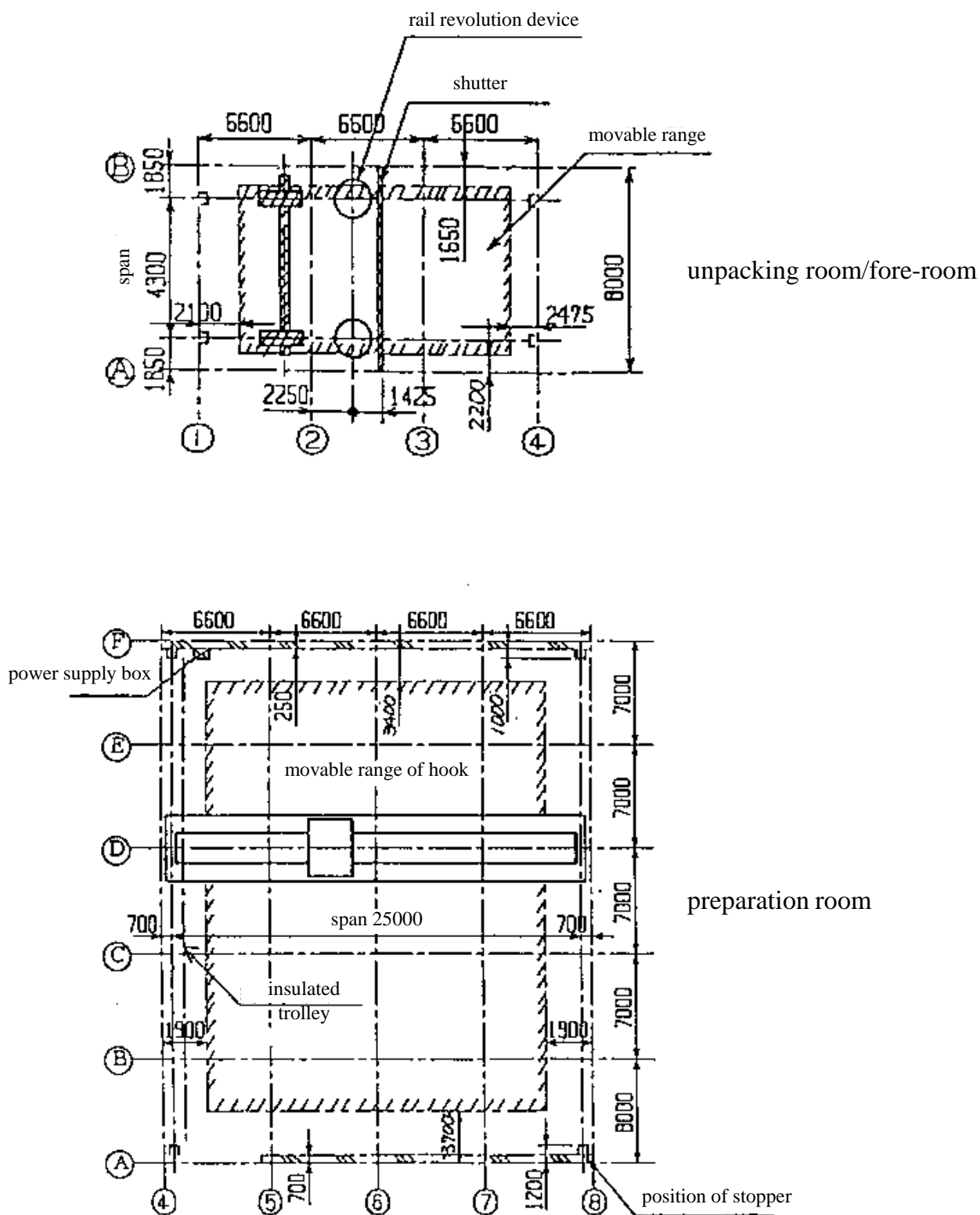


Figure 3-45 Movable Range of Crane in Each Room

(7) Contamination control

- (a) The requirements for optical sensors are becoming more and more demanding compared to general TSs. That is why this facility executes more strict contamination control than other facilities in Tsukuba Space Center. Precisely, the following measures are being taken.
  - ① Particulate contamination is controlled abiding by ISO7 [ISO14644] (class M5.5, equivalent of class 10,000 [FED-STD-209E].)
  - ② Molecular contamination is prevented by refraining from using oil as the lubricant for the sliding parts of equipment used in the preparation room as much as possible; otherwise, the oil-applied parts are tightly sealed.
- (b) When testing an optical sensor that calls for especially demanding cleanliness requirements, the clean booth will help establishing the ISO5 [ISO14644] (class M3.5, class 100 [FED-STD-209E]) environment.
- (c) The preparation room and the clean booth are designed to retain cleanliness for their Max. capacities of fifteen and three people, respectively. The number of people exceeding the capacities may fail to satisfy the cleanliness. Never enter or leave the preparation room without clearly indicating the entering/leaving state on the management board at the entry/exit.
- (d) NVR plates for detecting non-volatile residue are set in the chamber all through a test to check for contamination on a TS and the facilities. Refer to Figure 3-46 for the installation sites of NVR plates. It takes about a week to complete the analysis on the amount of contamination, and users may be required to clean inside the chamber or perform a verification test (including analysis) at users' expense when the analysis results suggest the existence of contamination on the facilities (viz. the amount of NVR on work floor: 1.5 mg/0.1m<sup>2</sup> or more\*). It takes about two weeks to clean inside the chamber and complete a verification test.

\* Policy for contamination measurement in thermal vacuum tests (GCT-2011023)

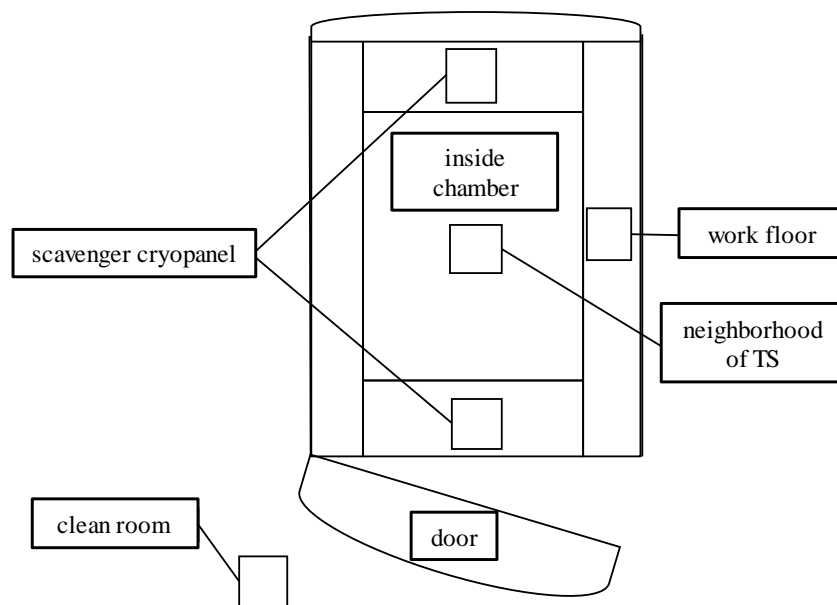


Figure 3-46 Diagram of Installation Sites for NVR Plates

(e) General cautions in the clean room

The rules shown below are especially crucial for users to follow when using the clean room.

① Clean garment

Users are to wear one of the following clean garments depending on the cleanliness requirements of a TS.

ISO5 [ISO14644] (class M3.5, equivalent of class 100 [FED-STD-209E]): overall, hood, mask, boots

ISO7 [ISO14644] (class M5.5, equivalent of class 10,000 [FED-STD-209E]): overall, hood, boots (or shoes, shoes cover.)

ISO8 [ISO14644] (class M6.5, equivalent of class 100,000 [FED-STD-209E]): overall (the kind same as those used in other clean rooms is acceptable), cap, short boots.

When coping with contamination-sensitive surfaces, wear a pair of gloves in addition to the items above.

For a test in a clean booth, a clean garment that meets class 100 requirements is to be prepared. For reference, some examples of clean garments (model numbers) used by the facility are shown below.

Overall: FB102C

Hood: FB405C

Boots: FE652C

Mask: FZ554C

Gloves: Cleanfast1000

manufactured by Toyo Lintfree Co.

\* The clean garments used by facility-side personnels are the kinds to satisfy the cleanliness standards of both ISO5 and ISO7 [ISO14644.]

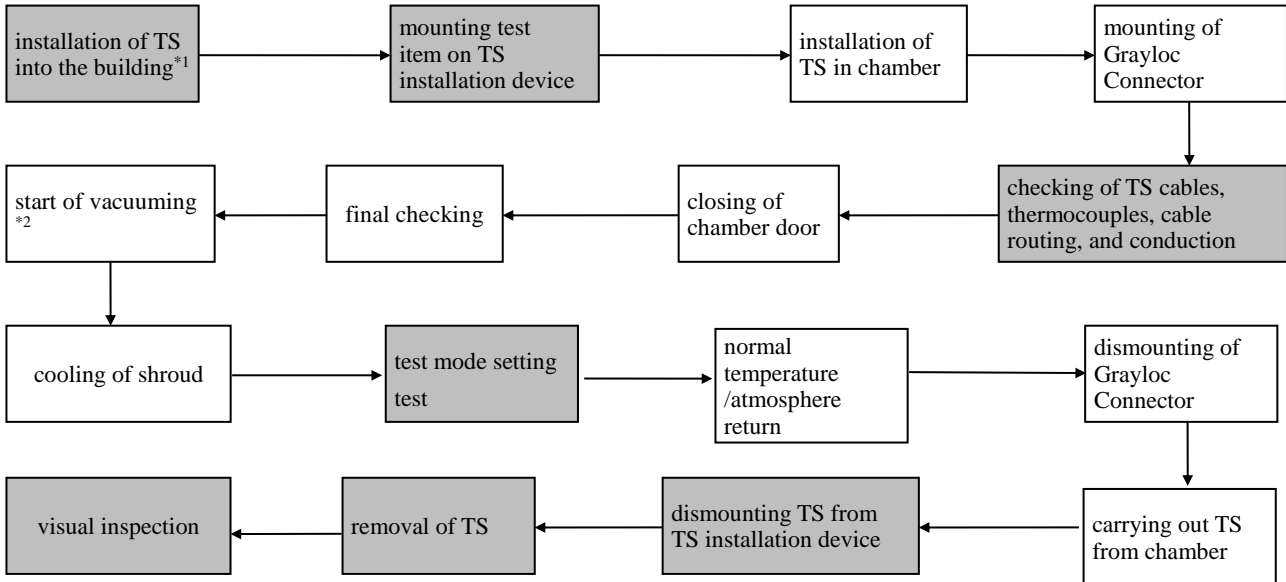
② Stationary articles

Refrain from bringing in paper into the preparation room to the extent possible. If not avoidable, choose dust-free paper. As a writing tool, use a ballpoint pen.

## 4. Execution of Tests

### 4.1. Test-related Work Procedure

Each work in the course of a test is executed based on the test implementation plan sheet presented by the TS side. The following Figure 4-1 shows a general flow of test-related work. (The hatched boxes show the work to be done by the TS side.)



\*1 A TS is to be left in the fore-room for about 1 hour to wait for the recovery of cleanliness, before being carried into the preparation room.

\*2 A test schedule is to be arranged the way low vacuuming starts at 13:00.

**Figure 4-1 Test-related Work Flow**

## 4.2. Test Procedure

### 4.2.1. General Description of Test

In this facility, tests are classified in two ways according to their purposes and methods. Each classification is described below. The selectable test methods are determined by test purposes. Refer to Table 4-1 for more details.

(1) Classification according to purposes

In this facility, environmental tests, e. g., (a) radiometer optical property tests, (b) IR radiation thermal balance/thermal vacuum tests, etc., can be performed. The general description of each environmental test is provided below. The environmental conditions of each test are described in Table 4-2.

(a) Radiometer optical property test

It is a test for checking the optical properties, etc., of a TS in the high vacuum and cryogenic temperature simulating outer space and in the atmospheric pressure and normal temperature.

(b) IR radiation thermal balance/thermal vacuum test

A thermal balance test confirms the thermal design, etc., of a TS in the high vacuum and cryogenic temperature that simulate outer space, while a thermal vacuum test confirms the environmental resistance of equipment mounted on a TS to the thermal environment in space, that is, high and low temperatures and the back-and-forth transition between them. IR lamps or heaters are used as the heat sources.

(2) Classification according to methods

The following three modes can be chosen as a testing method.

(a) Mode 1

In this mode, shrouds are started to be cooled after the chamber is vacuumed with a cryosorption pump to the level passed the discharge-hazardous range. That way a TS can be protected from excessive cooling. Thermal vacuum/balance tests are basically performed in this mode.

Note) There is a case in which the reached level is found to be in the discharge-hazardous range when a cryosorption pump is stopped after the shroud temperature is raised during atmosphere return, depending on the amount of outgas from a TS.

(b) Mode 2

In this mode, the chamber is started to be vacuumed with a cryosorption pump after the shroud is cooled down, for the purpose of performing thermal vacuum/balance tests. This mode enables the quick establishment of test conditions when there is no fear of damage on a TS caused by excessive cooling.

(c) Mode 3

This mode denotes a vacuum test in normal temperature. That is, only a vacuum state is established without cooling the shroud.

The correspondence between test purposes and test methods is shown below.

**Table 4-1 Test Methods Corresponding to Test Purposes**

test purpose	test method
radiometer optical property test	modes 1, 2, 3
IR radiation thermal vacuum/balance test	modes 1, 2

**Table 4-2 Summary of Kinds of Tests and Environmental Conditions**

kinds of tests environment	radiometer optical property test	IR radiation thermal balance/thermal vacuum test
(1) chamber pressure	$1.33 \times 10^{-4}$ Pa or less or atmospheric pressure	$1.33 \times 10^{-4}$ Pa or less
(2) IR intensity	20 kW (max)	20 kW (max)
(3) shroud temperature	100K or lower or 300K (normal temperature)	100K or lower

4.2.2. Standard Chamber Vacuum Curve, etc.

Figure 4-2 “Standard Chamber Vacuum Curve, etc.” shows a standard chamber vacuum curve in mode 1 (with no TS placed inside), a standard operation procedure, and a shroud temperature curve.

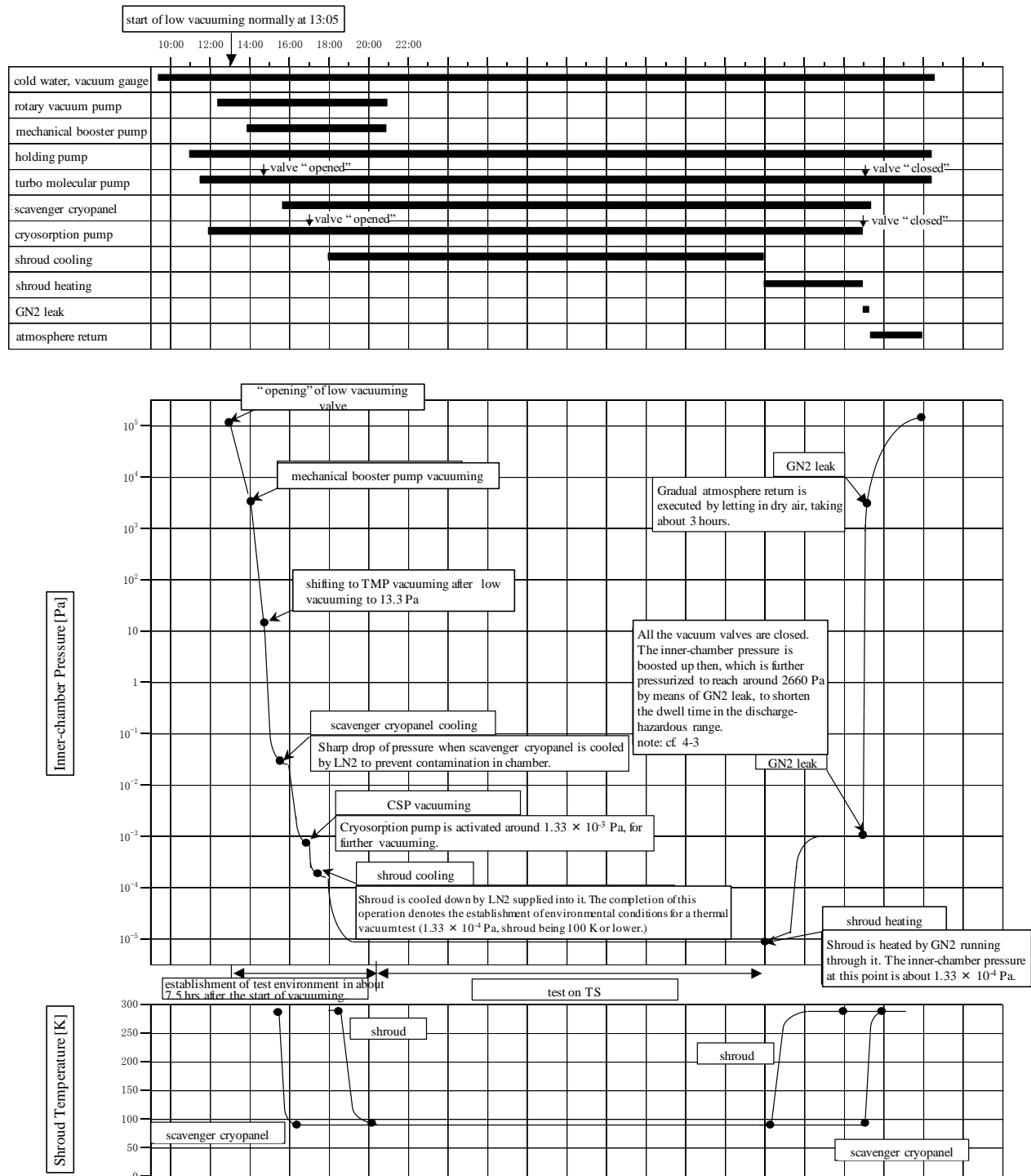


Figure 4-2 Vacuum Curve in Standard Chamber, etc.

### 4.3. Power Failure Protective Measures

The general flow of measures against momentary power interruption or power failure is shown in Figure 4-3.

#### (1) Momentary power interruption

- (a) All the devices but the instrument air compressor in this facility are equipped with two-second momentary power interruption measures, which enables continued operation of vacuum pumps, etc., during power interruption of two seconds or shorter.
- (b) Even though the instrument air compressor is aborted at the momentary power interruption of shorter than two seconds, it has no impact on test environments owing to the automatic backup by GN<sub>2</sub>.

#### (2) Power failure

- (a) In the power failure of two seconds or longer, all the mechanical vacuuming pumps, etc., are aborted, except for the cooler for shrouds and scavenger cryopanel. Then, it is to be determined whether to keep cooling the shrouds to avoid rapid pressure raise or stop cooling them by introducing GN<sub>2</sub>, based on the power failure duration and the state of excessive cooling protection measures being taken for a TS. (Generally, continuous cooling of shrouds is chosen while waiting for power recovery.)
- (b) When power failure lasts for two seconds or longer, the inner-chamber pressure rises up to the discharge-hazardous range ( $1.3 \times 10^{-3}$ Pa) in about ten minutes. Therefore, discharge prevention measures, e. g., shifting a TS into a launch mode, etc., are to be taken as soon as power failure takes place.
- (c) A 15 kVA UPS is prepared in the preparation room for users. It is recommended that the heater systems (e. g., power supply for IR heaters) wished to be heated during power failure or the checkout devices, etc., wished to be controlled and monitored during power failure be connected to the UPS in advance. Refer to section 3.5 for how to connect the UPS for users.

The power supply for IR heaters and checkout devices not connected to the UPS for users will be turned off during power failure.

- (d) After about 10 minutes of power failure, the emergency power generator in the power building of Tsukuba Space Center starts supplying EP. Its pre-activation stand-by time and EP capacity vary depending on the state of its application by other facilities and equipment. Figure 4-4 shows the pressure transition inside the chamber during an assumed power failure of 20 minutes.
- (e) The control device, data processing device, a remote setting PC for the power supply for IR heaters, communication system, and oximeter are connected to a UPS (uninterruptible power supply) which can supply power for 10 minutes or longer.
- (f) In case power failure is not recovered for 10 minutes or longer, the saved data is to be stored in the external medium to make provision for hard disc failure due to the forced termination of the data acquisition system (measurement can be continued.)
- (g) The power supply from the emergency power generator in the power building of Tsukuba Space Center is finite. Therefore, unnecessary lights or devices are to be turned off while the emergency power generator is supplying EP, for the sake of saving EP to the extent possible.



- (h) Once the emergency power generator in the power building of Tsukuba Space Center starts to supply EP, high vacuum operation ( $1 \times 10^{-4}$ Pa or less) can be restarted with the help of cryosorption pumps (CSP) and turbo molecular pumps (TMP.)
- (3) Power restoration
  - (a) A momentary power interruption takes place at the moment of power restoration when power supply shifts from the emergency power generator in the power building of Tsukuba Space Center to the regular power supply.
  - (b) High vacuum operation can be recovered in about thirty minutes after power restoration unless GN<sub>2</sub> or dry air was introduced into the chamber during power failure.

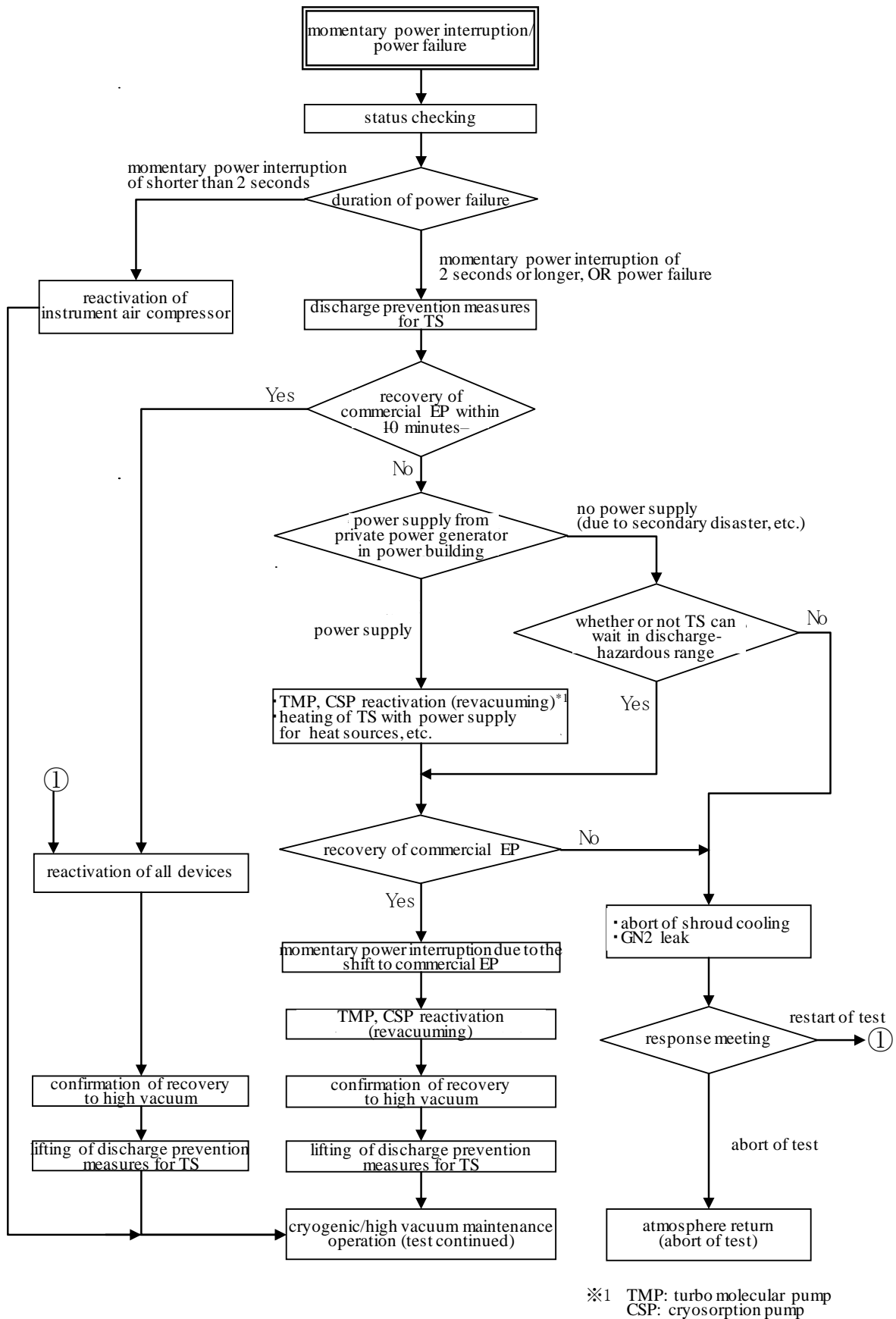
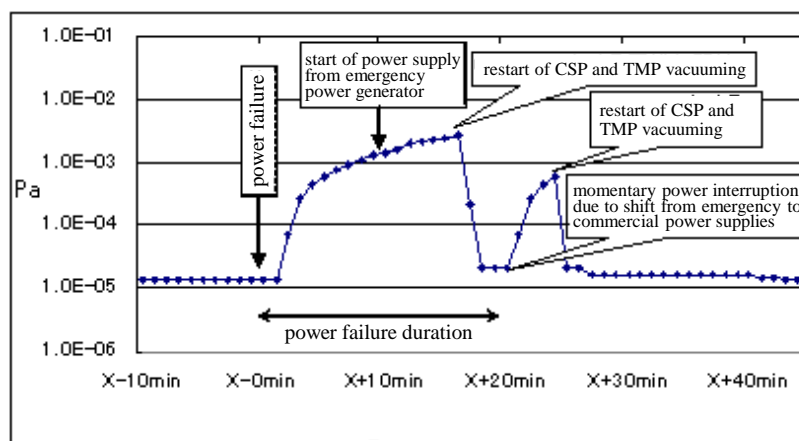


Figure 4-3 Standard Flow in Momentary Power Interruption and Power Failure



**Figure 4-4 Inner-Chamber Pressure Transition during 20-minute Power Failure**

#### 4.4. Other Remarks

(1) Matters to be confirmed for test

The environment in the space chamber is the same as outer space in that it cannot be accessed promptly even when abnormalities are found on a TS. Bearing that in mind, the following matters are to be checked.

(a) Matters concerning chamber contamination

- ① Whether or not anything with high steam pressure or susceptibility to evaporation from heating is used in the chamber.
- ② Whether or not commercial products that are not made for the usage in space are being used. (Are there commercially available glues or adhesive tapes being used?)
- ③ Is the applied material less likely to generate outgas?
- ④ Whether or not a TS, jigs, etc., that are coated with paint have been put through enough baking.

(b) Matters concerning vacuum

- ① Whether or not there is gas leakage from gas-sealed equipment.
- ② Whether or not there is any chance that MLI might block vent holes (See if MLI does not cover the vent holes of tanks, etc.)
- ③ Whether or not MLI has vent holes, or one end of it is not fixed.
- ④ Whether or not there is a problem when inner or outer pressure is loaded.
- ⑤ Whether or not the vacuum seals on vacuum seal connectors have been closely inspected.
- ⑥ Whether or not leakage has been thoroughly inspected in case the vacuum vessel has any feed-through equipment (waveguide, tube, etc.)

(c) Harmful effects of low temperature

- ① Whether or not the material has low temperature brittleness that can cause a problem.
- ② Whether or not polymer material (rubber, etc.) is used in the parts that become cold.
- ③ Whether or not there is any item whose temperature won't go up readily during normal temperature atmosphere return. If there is any, it is to be checked if it is equipped with any mechanism to raise its temperature.
- ④ Whether or not a fluid is freeze-proven, if it is planned to be used.

(d) Matters concerning vacuum discharge

- ① Electric discharge is generally said to take place in the pressure range around  $1.33 \times 10^{-3} \sim 1.33 \times 10^4 \text{Pa}$ , where loading of high voltage may damage a TS due to electric discharge (cf. JERG-2-130-HB005 Handbook of Thermal Vacuum Test, section 3.7.1.)
- ② It is required that the electric-discharge-hazardous pressure range be determined by the TS side and reported to the facility-side personnel in advance.
- ③ It is to be confirmed that loading of voltage is avoided in the electric-discharge-hazardous pressure range, or discharge prevention measures are taken in case that is not possible.
- (e) Considerations for high pressure gas safety law
  - ① The facility-side pipes in the vacuum vessel of this facility are not subject to the High Pressure Gas Safety Law. When users prepare  $\text{LN}_2/\text{GN}_2$  panels, make sure they are designed not to be the regulated objects of the law.
- (f) The I/F to the facility is to be checked not only by a drawing, but also by visual observation on it.
  - ① I/F to TS supporting bench
  - ② I/F to inner-chamber protruding objects (sensors, work floor, tubes, etc.)
- (2) Important matters for using this facility
 

Here, especially important matters concerning the equipment of this facility are provided for the case of using it. For more detail, refer to the users' manual of each equipment.

  - (a) General matters
    - ① Users are to mount a TS on a TS supporting bench and control the IR heat source power supply (when used) by themselves, following the users' manual. (The TS supporting bench is brought in and out of the chamber by the facility-side personnel.)
    - ② Especially the domestic products of Aeroglaze Z306 (black), which is used for painting satellites, tend to generate a big amount of outgas, and therefore is to be refrained from being used inside the chamber to prevent contamination. When it is used nevertheless, sufficient baking is required in advance. In case of using paint whose outgas components are unknown, outgas analysis is to be performed on it, followed by the same procedure as above if it is found to generate excessive amount of outgas.
    - ③ The air introduced into the chamber during atmosphere return passes through a drier, which generates absorption heat from the absorbent filled inside. That absorption heat together with the compression heat generated from the introduced air sometimes raises the temperature of air introduced into the chamber (the level of the temperature rise depends on the outdoor temperature and humidity, reaching highest in summer.) Users are to pay attention to this point when performing a test on a temperature-sensitive TS, taking necessary measures for it.

(b) Chamber system

- ① When feed-through flanges such as a waveguide or a connector are used on the chamber nozzle for users, they are to be subject to the prior checking on leakage from their vacuum-sealed parts.
- ② The hard ports being made of SUS304, users are to watch out for “seizure” if they prepare screws that are SUS products whose surfaces are not coated. In case an SUS screw is thrust into the helisert of the hard port, enough caution is required to do it by hand at first, for example.
- ③ Emergency stop switch

This facility has emergency stop switches, which abort all the facilities when emergency stop is needed (ex. a person is locked into the chamber.) Users are to check the actual switch with their own eyes before using the facility.

- Emergency stop switch inside chamber

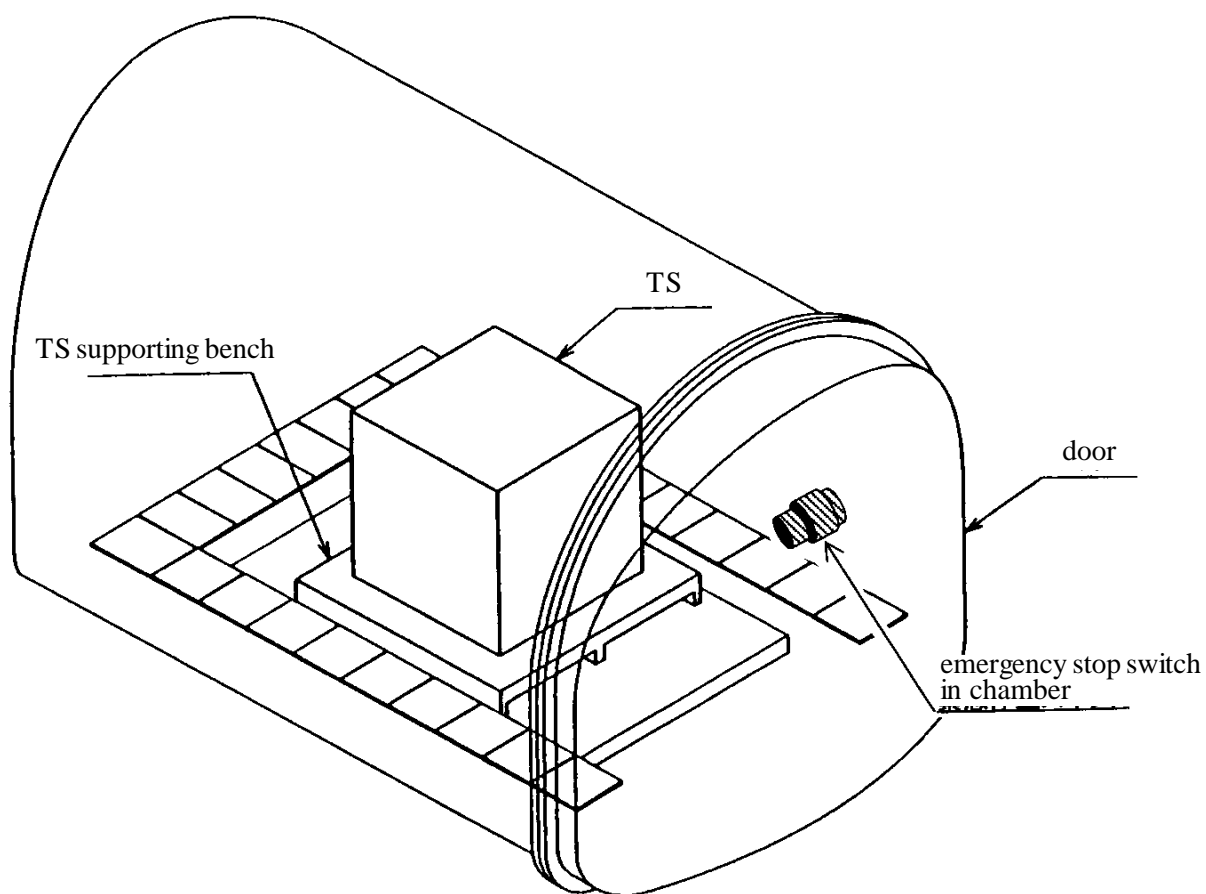
The “switch” consists of the receptacle and plug of an MS connector; the contact point is disconnected when the plug is pulled out, which activates the interlock to abort the facility. In case someone was locked into the chamber, he or she has to pull out the switch. The location of the switch is shown in Figure 4-5.

- Emergency stop switch inside control room

It is a button-type switch, which aborts all the facilities when its protection pin is pulled out and the button is pressed. The location of the switch is shown in Figures 4-6 and 4-7.

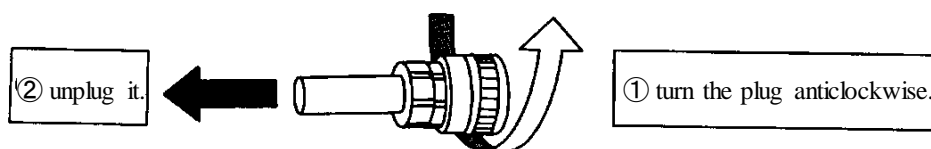
- Emergency stop switch in preparation room

It is a button-type switch, which aborts all the facilities when its protection pin is pulled out and the button is pressed. The location of the switch is shown in Figures 4-6 and 4-8.

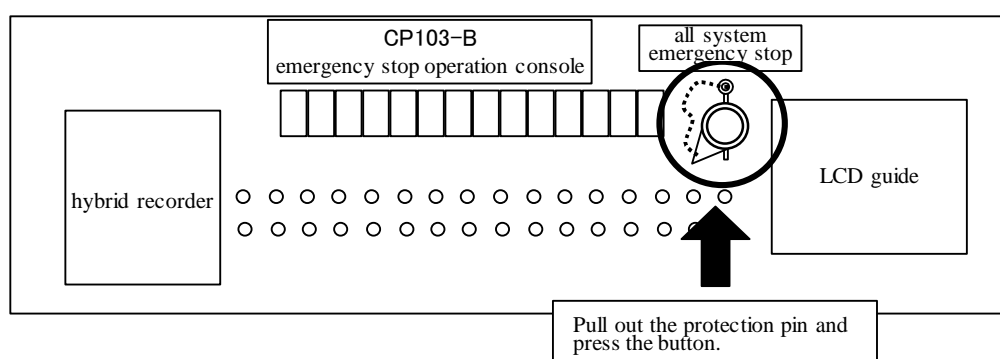
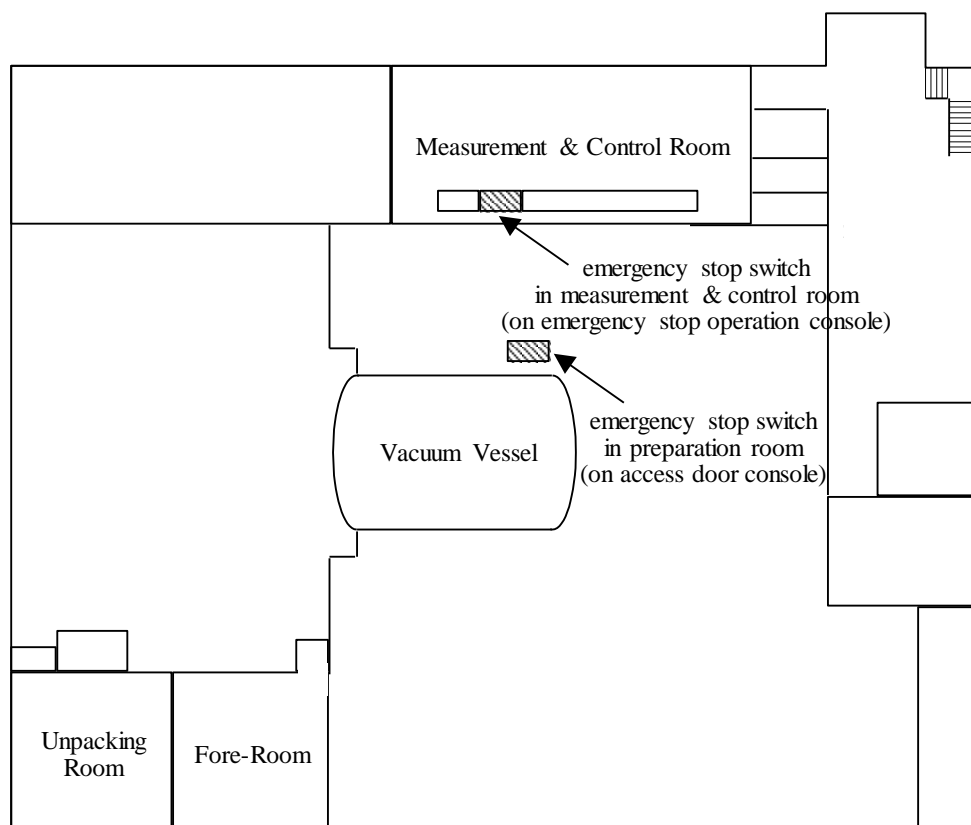


how to operate

Grab the plug by its root, turn it anticlockwise to the limit, and unplug it.



**Figure 4-5 Emergency Stop Switch inside Chamber**



**Figure 4-6 Locations of Emergency Stop Switches in Preparation Room and Measurement & Control Room**

**Figure 4-7 Location of Emergency Stop Switch on Emergency Stop Console Panel in Measurement & Control Room**

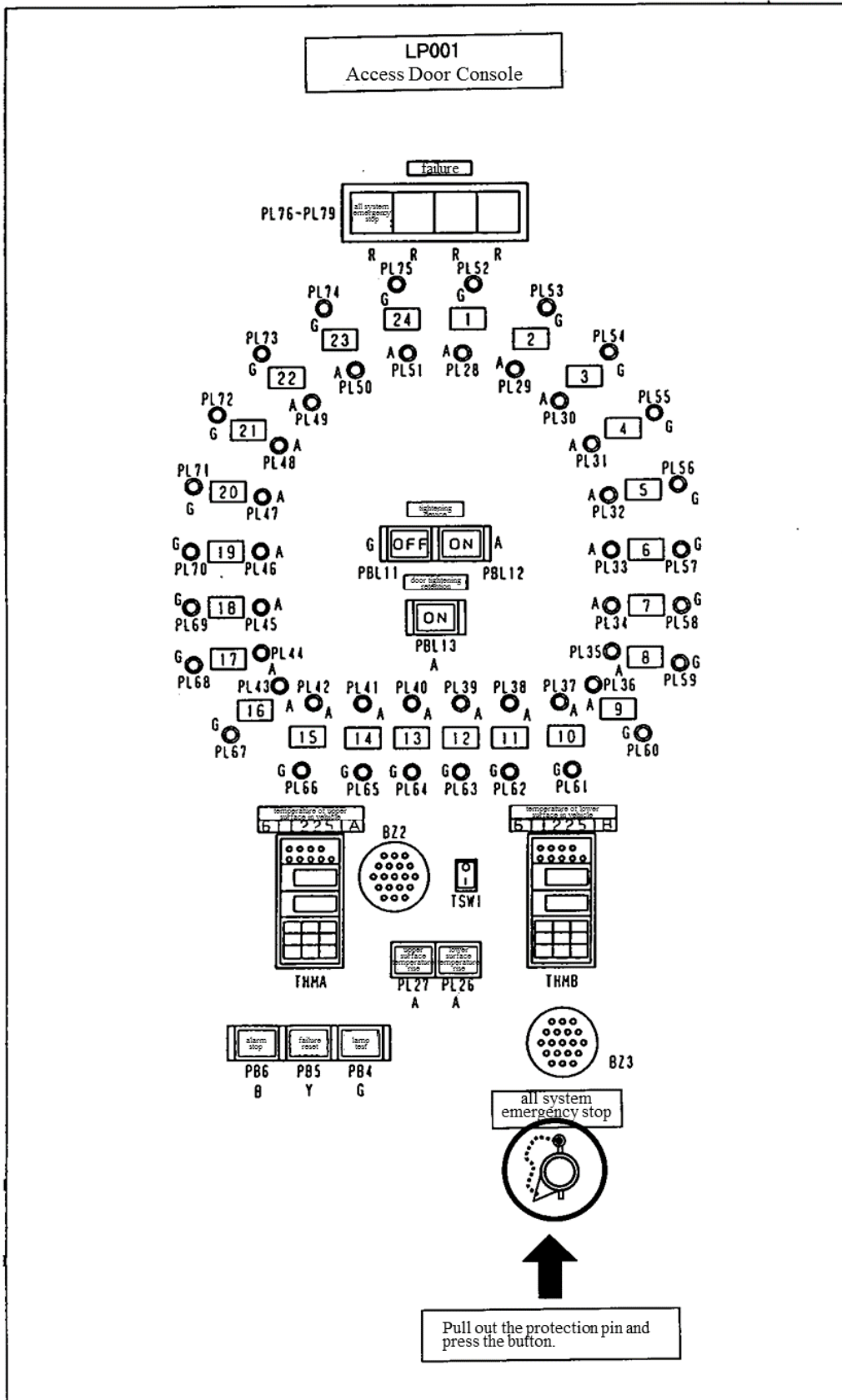


Figure 4-8 Position of Emergency Stop Switch on Preparation Room Access Door Console Panel



#### **4.5. Documents to be Submitted at K/O Meeting**

The following documents are to be submitted to the personnel in charge of the facility at the K/O meeting.

- Test implementation plan
- Requirements for the facility (cf. Table 4-3)
- List of nonmetallic articles brought into chamber (cf. Table 4-4)

**Table 4-3 Requirements for Facility**

&gt;&gt;&gt;&gt;These requirements are to be submitted at K/O meeting to the personnel in charge of operating the facility.&lt;&lt;&lt;&lt;

6mφ Radiometer Space Chamber

name of test			documentation date : Year    Month    Day
facility users' name			note
test conditions, etc.	inner-chamber pressure	Pa or less	
	discharge-hazardous range	Pa ~ Pa	
	shroud temperature	K or lower	
	environment of clean room (preparation room)	temperature :	23 ± 3°C
		humidity :	30 ~ 60%
		cleanliness :	ISO7 [ISO14644] (class M5.5, equivalent of class 10,000 [FED-STD-209E])
test method, used equipment, etc.	test mode	mode :	
	type of test specimen supporting bench	w/ cooling panel    •    w/o cooling panel	
	power supplies for heat sources	6mφ 60W power supply rack -1 :	
		6mφ 2,kW power supply rack -1 :	
		6mφ 2,kW power supply rack -2 :	
		6mφ 3 kW power supply rack -1 :	
	LN <sub>2</sub> (GN <sub>2</sub> ) for test specimen	not use    /    use	
	UPS for test specimen	not use    /    use	
	vibration analyzer	not use    /    use	
	accelerometer	not use    /    use	
		393M33 :	
		393M12 :	
		393M31 :	
	clean booth	not use    /    use	
	TQCM	not use    /    use _____ (qty)	

**Table 4-4 List of Nonmetallic Articles Brought into Space Chamber**

&gt;&gt;&gt;This list is to be submitted at K/O meeting to the personnel in charge of operating the facility.&lt;&lt;&lt;

name of test:		test period:		~		
component	material	application purpose	used amount	TML	CVCM	track record of use
1. test specimen						
2. jig						

Note 1) It is the basic rule that a test specimen and all the jigs are put through baking in another facility before performing a test on them, unless they are true with the cases as below.

- A thermal vacuum test has been already performed on the test specimen and jigs, and the nonexistence of outgas from them is apparent.
- When baking can be proved unnecessary from this list. In that case, never fail to write in the TML and CVCM of the materials.

Note 2) The materials are to accompany their trade names and model numbers.

Note 3) When the used amount of materials is not clear, write in the maximum amount. For silicone grease, for example, 50 g × 2 would be written. When the amount is just a little, write so.

Note 4) If baking is not necessary, provide the basis for that. ex) The amount is just a little, being in the specified levels of both TML and CVCM.

## **Appendix A   Correspondence Table of Channels between Terminal Boards inside Vessel and Data Loggers**

**Table A-1 Correspondence Table of Channels between Terminal Boards inside Vessel and Data Loggers**

(1/5)

ch serial#	connectors on inner-vessel terminal boards side						ch serial#	connectors on inner-vessel terminal boards side					
	#	connector	CH	PIN	material	connector model#		#	connector	CH	PIN	material	connector model#
1	1	C1	1	A	copper	AFD56-16-26SN	37	4	C4	1	A	copper	AFD56-16-26SN
2			2	B	constantan		38			2	B	constantan	
3			3	D	copper		39			3	D	copper	
4			4	C	constantan		40			4	C	constantan	
5			5	F	copper		41			5	F	copper	
6			6	E	constantan		42			6	E	constantan	
7			7	H	copper		43			7	H	copper	
8			8	G	constantan		44			8	G	constantan	
9			9	c	copper		45			9	c	copper	
10			10	J	constantan		46			10	J	constantan	
11			11	K	copper		47			11	K	copper	
12			12	R	constantan		48			12	R	constantan	
13	2	C2	1	M	copper	AFD56-16-26SN	49	5	C5	1	M	copper	AFD56-16-26SN
14			2	L	constantan		50			2	L	constantan	
15			3	N	copper		51			3	N	copper	
16			4	P	constantan		52			4	P	constantan	
17			5	S	copper		53			5	S	copper	
18			6	T	constantan		54			6	T	constantan	
19			7	U	copper		55			7	U	copper	
20			8	V	constantan		56			8	V	constantan	
21			9	W	copper		57			9	W	copper	
22			10	X	constantan		58			10	X	constantan	
23			11	Z	copper		59			11	Z	copper	
24			12	Y	constantan		60			12	Y	constantan	
25	3	C3	1	A	copper	AFD56-16-26SN	61	6	C6	1	A	copper	AFD56-16-26SN
26			2	B	constantan		62			2	B	constantan	
27			3	D	copper		63			3	D	copper	
28			4	C	constantan		64			4	C	constantan	
29			5	F	copper		65			5	F	copper	
30			6	E	constantan		66			6	E	constantan	
31			7	H	copper		67			7	H	copper	
32			8	G	constantan		68			8	G	constantan	
33			9	c	copper		69			9	c	copper	
34			10	J	constantan		70			10	J	constantan	
35			11	K	copper		71			11	K	copper	
36			12	R	constantan		72			12	R	constantan	

**Table A-1 Correspondence Table of Channels between Terminal Boards inside Vessel and Data Loggers**

(2/5)

connectors on inner-vessel terminal boards side							connectors on inner-vessel terminal boards side								
ch serial#	#	connector	CH	PIN	material	connector model#	ch serial#	#	connector	CH	PIN	material	connector model#		
73	7	C7	1	A	copper	AFD56-16-26SN	109	10	C10	1	A	copper	AFD56-16-26SN		
					B		constantan							B	constantan
74			2	D	copper		110			2	D	copper			
				C	constantan						C	constantan			
75			3	F	copper		111			3	F	copper			
				E	constantan						E	constantan			
76			4	H	copper		112			4	H	copper			
				G	constantan						G	constantan			
77			5	c	copper		113			5	c	copper			
				J	constantan						J	constantan			
78			6	K	copper		114			6	K	copper			
				R	constantan						R	constantan			
79	7	M	copper	115	7	M	copper								
		L	constantan			L	constantan								
80	8	N	copper	116	8	N	copper								
		P	constantan			P	constantan								
81	9	S	copper	117	9	S	copper								
		T	constantan			T	constantan								
82	10	U	copper	118	10	U	copper								
		V	constantan			V	constantan								
83	11	W	copper	119	11	W	copper								
		X	constantan			X	constantan								
84	12	Z	copper	120	12	Z	copper								
		Y	constantan			Y	constantan								
85	8	C8	1	A	copper	AFD56-16-26SN	121	11	C11	1	A	copper	AFD56-16-26SN		
				B	constantan						B	constantan			
86			2	D	copper		122			2	D	copper			
				C	constantan						C	constantan			
87			3	F	copper		123			3	F	copper			
				E	constantan						E	constantan			
88			4	H	copper		124			4	H	copper			
				G	constantan						G	constantan			
89			5	c	copper		125			5	c	copper			
				J	constantan						J	constantan			
90			6	K	copper		126			6	K	copper			
				R	constantan						R	constantan			
91	7	M	copper	127	7	M	copper								
		L	constantan			L	constantan								
92	8	N	copper	128	8	N	copper								
		P	constantan			P	constantan								
93	9	S	copper	129	9	S	copper								
		T	constantan			T	constantan								
94	10	U	copper	130	10	U	copper								
		V	constantan			V	constantan								
95	11	W	copper	131	11	W	copper								
		X	constantan			X	constantan								
96	12	Z	copper	132	12	Z	copper								
		Y	constantan			Y	constantan								
97	9	C9	1	A	copper	AFD56-16-26SN	133	12	C12	1	A	copper	AFD56-16-26SN		
				B	constantan						B	constantan			
98			2	D	copper		134			2	D	copper			
				C	constantan						C	constantan			
99			3	F	copper		135			3	F	copper			
				E	constantan						E	constantan			
100			4	H	copper		136			4	H	copper			
				G	constantan						G	constantan			
101			5	c	copper		137			5	c	copper			
				J	constantan						J	constantan			
102			6	K	copper		138			6	K	copper			
				R	constantan						R	constantan			
103	7	M	copper	139	7	M	copper								
		L	constantan			L	constantan								
104	8	N	copper	140	8	N	copper								
		P	constantan			P	constantan								
105	9	S	copper	141	9	S	copper								
		T	constantan			T	constantan								
106	10	U	copper	142	10	U	copper								
		V	constantan			V	constantan								
107	11	W	copper	143	11	W	copper								
		X	constantan			X	constantan								
108	12	Z	copper	144	12	Z	copper								
		Y	constantan			Y	constantan								

**Table A-1 Correspondence Table of Channels between Terminal Boards inside Vessel and Data Loggers**

(3/5)

ch serial#	connectors on inner-vessel terminal boards side						ch serial#	connectors on inner-vessel terminal boards side					
	#	connector	CH	PIN	material	connector model#		#	connector	CH	PIN	material	connector model#
145	13	C13	1	A	copper	AFD56-16-26SN	181	16	C16	1	A	copper	AFD56-16-26SN
146				B	constantan		182				B	constantan	
147			2	D	copper		183			2	D	copper	
148				C	constantan		184				C	constantan	
149			3	F	copper		185			3	F	copper	
150				E	constantan		186				E	constantan	
151			4	H	copper		187			4	H	copper	
152				G	constantan		188				G	constantan	
153			5	c	copper		189			5	c	copper	
154				J	constantan		190				J	constantan	
155			6	K	copper		191			6	K	copper	
156				R	constantan		192				R	constantan	
157			7	M	copper		193			7	M	copper	
158				L	constantan		194				L	constantan	
159			8	N	copper		195			8	N	copper	
160				P	constantan		196				P	constantan	
161			9	S	copper		197			9	S	copper	
162				T	constantan		198				T	constantan	
163			10	U	copper		199			10	U	copper	
164				V	constantan		200				V	constantan	
165			11	W	copper		201			11	W	copper	
166				X	constantan		202				X	constantan	
167			12	Z	copper		203			12	Z	copper	
168				Y	constantan		204				Y	constantan	
169	14	C14	1	A	copper	AFD56-16-26SN	205	17	C17	1	A	copper	AFD56-16-26SN
170				B	constantan		206				B	constantan	
171			2	D	copper		207			2	D	copper	
172				C	constantan		208				C	constantan	
173			3	F	copper		209			3	F	copper	
174				E	constantan		210				E	constantan	
175			4	H	copper		211			4	H	copper	
176				G	constantan		212				G	constantan	
177			5	c	copper		213			5	c	copper	
178				J	constantan		214				J	constantan	
179			6	K	copper		215			6	K	copper	
180				R	constantan		216				R	constantan	
			7	M	copper					7	M	copper	
				L	constantan						L	constantan	
			8	N	copper					8	N	copper	
				P	constantan						P	constantan	
			9	S	copper					9	S	copper	
				T	constantan						T	constantan	
			10	U	copper					10	U	copper	
				V	constantan						V	constantan	
			11	W	copper					11	W	copper	
				X	constantan						X	constantan	
			12	Z	copper					12	Z	copper	
				Y	constantan						Y	constantan	

**Table A-1 Correspondence Table of Channels between Terminal Boards inside Vessel and Data Loggers****(4/5)**

ch serial#	connectors on inner-vessel terminal boards side						ch serial#	connectors on inner-vessel terminal boards side					
	#	connector	CH	PIN	material	connector model#		#	connector	CH	PIN	material	connector model#
217	19	C19	1	A	copper	AFD56-16-26SN	253	22	C22	1	A	copper	AFD56-16-26SN
				B	constantan						B	constantan	
218			2	D	copper		254			2	D	copper	
				C	constantan						C	constantan	
219			3	F	copper		255			3	F	copper	
				E	constantan						E	constantan	
220			4	H	copper		256			4	H	copper	
				G	constantan						G	constantan	
221			5	c	copper		257			5	c	copper	
				J	constantan						J	constantan	
222			6	K	copper		258			6	K	copper	
				R	constantan						R	constantan	
223			7	M	copper		259			7	M	copper	
				L	constantan						L	constantan	
224			8	N	copper		260			8	N	copper	
				P	constantan						P	constantan	
225			9	S	copper		261			9	S	copper	
				T	constantan						T	constantan	
226			10	U	copper		262			10	U	copper	
				V	constantan						V	constantan	
227			11	W	copper		263			11	W	copper	
				X	constantan						X	constantan	
228			12	Z	copper		264			12	Z	copper	
				Y	constantan						Y	constantan	
229	20	C20	1	A	copper	AFD56-16-26SN	265	23	C23	1	A	copper	AFD56-16-26SN
				B	constantan						B	constantan	
230			2	D	copper		266			2	D	copper	
				C	constantan						C	constantan	
231			3	F	copper		267			3	F	copper	
				E	constantan						E	constantan	
232			4	H	copper		268			4	H	copper	
				G	constantan						G	constantan	
233			5	c	copper		269			5	c	copper	
				J	constantan						J	constantan	
234			6	K	copper		270			6	K	copper	
				R	constantan						R	constantan	
235			7	M	copper		271			7	M	copper	
				L	constantan						L	constantan	
236			8	N	copper		272			8	N	copper	
				P	constantan						P	constantan	
237			9	S	copper		273			9	S	copper	
				T	constantan						T	constantan	
238			10	U	copper		274			10	U	copper	
				V	constantan						V	constantan	
239			11	W	copper		275			11	W	copper	
				X	constantan						X	constantan	
240			12	Z	copper		276			12	Z	copper	
				Y	constantan						Y	constantan	
241	21	C21	1	A	copper	AFD56-16-26SN	277	24	C24	1	A	copper	AFD56-16-26SN
				B	constantan						B	constantan	
242			2	D	copper		278			2	D	copper	
				C	constantan						C	constantan	
243			3	F	copper		279			3	F	copper	
				E	constantan						E	constantan	
244			4	H	copper		280			4	H	copper	
				G	constantan						G	constantan	
245			5	c	copper		281			5	c	copper	
				J	constantan						J	constantan	
246			6	K	copper		282			6	K	copper	
				R	constantan						R	constantan	
247			7	M	copper		283			7	M	copper	
				L	constantan						L	constantan	
248			8	N	copper		284			8	N	copper	
				P	constantan						P	constantan	
249			9	S	copper		285			9	S	copper	
				T	constantan						T	constantan	
250			10	U	copper		286			10	U	copper	
				V	constantan						V	constantan	
251			11	W	copper		287			11	W	copper	
				X	constantan						X	constantan	
252			12	Z	copper		288			12	Z	copper	
				Y	constantan						Y	constantan	



**Table A-1 Correspondence Table of Channels between Terminal Boards inside Vessel and Data Loggers**

(5/5)

ch serial#	connectors on inner-vessel terminal boards side						ch serial#	connectors on inner-vessel terminal boards side					
	#	connector	CH	PIN	material	connector model#		#	connector	CH	PIN	material	connector model#
289	25	C25	1	A	copper	AFD56-16-26SN	325	28	C28	1	A	copper	AFD56-16-26SN
				B	constantan						B	constantan	
290			2	D	copper		326			2	D	copper	
				C	constantan						C	constantan	
291			3	F	copper		327			3	F	copper	
				E	constantan						E	constantan	
292			4	H	copper		328			4	H	copper	
				G	constantan						G	constantan	
293			5	c	copper		329			5	c	copper	
				J	constantan						J	constantan	
294			6	K	copper		330			6	K	copper	
				R	constantan						R	constantan	
295			7	M	copper		331			7	M	copper	
				L	constantan						L	constantan	
296			8	N	copper		332			8	N	copper	
				P	constantan						P	constantan	
297			9	S	copper		333			9	S	copper	
				T	constantan						T	constantan	
298			10	U	copper		334			10	U	copper	
				V	constantan						V	constantan	
299			11	W	copper		335			11	W	copper	
				X	constantan						X	constantan	
300			12	Z	copper		336			12	Z	copper	
				Y	constantan						Y	constantan	
301	26	C26	1	A	copper	AFD56-16-26SN					A	copper	
				B	constantan						B	constantan	
302			2	D	copper						D	copper	
				C	constantan						C	constantan	
303			3	F	copper						F	copper	
				E	constantan						E	constantan	
304			4	H	copper						H	copper	
				G	constantan						G	constantan	
305			5	c	copper						c	copper	
				J	constantan						J	constantan	
306			6	K	copper						K	copper	
				R	constantan						R	constantan	
307			7	M	copper						M	copper	
				L	constantan						L	constantan	
308			8	N	copper						N	copper	
				P	constantan						P	constantan	
309			9	S	copper						S	copper	
				T	constantan						T	constantan	
310			10	U	copper						U	copper	
				V	constantan						V	constantan	
311			11	W	copper						W	copper	
				X	constantan						X	constantan	
312			12	Z	copper						Z	copper	
				Y	constantan						Y	constantan	
313	27	C27	1	A	copper	AFD56-16-26SN					A	copper	
				B	constantan						B	constantan	
314			2	D	copper						D	copper	
				C	constantan						C	constantan	
315			3	F	copper						F	copper	
				E	constantan						E	constantan	
316			4	H	copper						H	copper	
				G	constantan						G	constantan	
317			5	c	copper						c	copper	
				J	constantan						J	constantan	
318			6	K	copper						K	copper	
				R	constantan						R	constantan	
319			7	M	copper						M	copper	
				L	constantan						L	constantan	
320			8	N	copper						N	copper	
				P	constantan						P	constantan	
321			9	S	copper						S	copper	
				T	constantan						T	constantan	
322			10	U	copper						U	copper	
				V	constantan						V	constantan	
323			11	W	copper						W	copper	
				X	constantan						X	constantan	
324			12	Z	copper						Z	copper	
				Y	constantan						Y	constantan	